

Large-Area Epitaxial Growth of Transition Metal Dichalcogenides

Published as part of Chemical Reviews *virtual special issue* "Two-Dimensional Layered Transition Metal Dichalcogenides".

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Cite This: <https://doi.org/10.1021/acs.chemrev.3c00851>



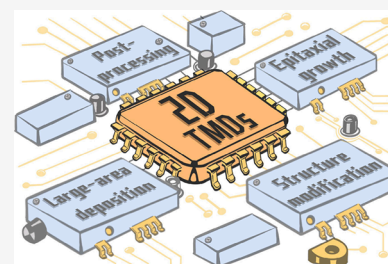
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ABSTRACT: Over the past decade, research on atomically thin two-dimensional (2D) transition metal dichalcogenides (TMDs) has expanded rapidly due to their unique properties such as high carrier mobility, significant excitonic effects, and strong spin–orbit couplings. Considerable attention from both scientific and industrial communities has fully fueled the exploration of TMDs toward practical applications. Proposed scenarios, such as ultrascaled transistors, on-chip photonics, flexible optoelectronics, and efficient electrocatalysis, critically depend on the scalable production of large-area TMD films. Correspondingly, substantial efforts have been devoted to refining the synthesizing methodology of 2D TMDs, which brought the field to a stage that necessitates a comprehensive summary. In this Review, we give a systematic overview of the basic designs and significant advancements in large-area epitaxial growth of TMDs. We first sketch out their fundamental structures and diverse properties. Subsequent discussion encompasses the state-of-the-art wafer-scale production designs, single-crystal epitaxial strategies, and techniques for structure modification and postprocessing. Additionally, we highlight the future directions for application-driven material fabrication and persistent challenges, aiming to inspire ongoing exploration along a revolution in the modern semiconductor industry.



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Received: November 19, 2023

Revised: July 14, 2024

Accepted: July 18, 2024

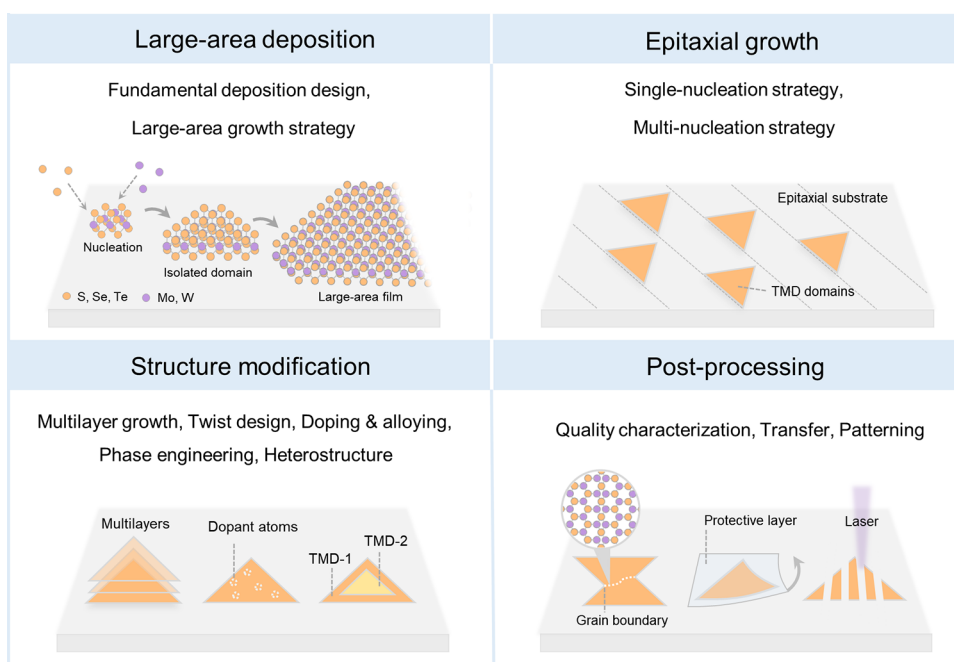


Figure 1. Overview of the four key aspects for large-area epitaxial growth of TMDs.

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1. INTRODUCTION

Two-dimensional (2D) transition metal dichalcogenides (TMDs) are a class of materials with the formula of MX_2 , where M denotes transition metal elements such as Mo, W or Nb, and X represents chalcogen elements such as S, Se or Te. Most TMDs are assembled as layered crystals via van der Waals (vdW) interactions, making them easily isolated into ultrathin layers, even down to a single layer with a thickness of only ~ 0.7 nm. The different coordination environments of transition metal atoms lead to various structural phases such as trigonal prismatic and octahedral species. And this composition diversity and polymorphic nature of TMDs further provide a rich 2D material library for novel physics exploration.^{1,2} For instance, fascinating properties including

short-channel effect immunity in semiconducting 2H-MoS₂, topologically nontrivial phase in 1T'-WTe₂ and moiré exciton in MoSe₂/WSe₂ heterobilayers, have been gradually unveiled in laboratories in the past decade.^{3–5} These progress have fully burned up the passion for pushing atomic TMD layers toward a promising future in electronics, optoelectronics, and spintronics.^{6–9}

The evolution of 2D TMD devices is intrinsically necessitated on the advancements in material fabrication techniques. The preparation of extremely thin MoS₂ samples can be traced back to the 1960s, initially employing a stripping technique using adhesive tape to exfoliate MoS₂ down to near-monolayer levels.^{10,11} Over subsequent decades, driven by the development of transmission electron imaging techniques and the growing demand to utilize TMDs in applications such as energy storage^{12,13} and solid lubricants,^{14–16} the investigation of TMDs has progressively shifted from 3D bulks toward lower dimensions. Around 2004, a pivotal moment in this journey occurred, inspired by the success in isolating monolayer graphene.¹⁷ TMD monolayers of MoS₂ and NbSe₂ are consecutively obtained from their bulk counterparts.¹⁸ This breakthrough not only represents a significant leap into the 2D era for TMDs, but also set the stage for a multitude of innovations in nanotechnology and material sciences.

Complementary to top-down mechanical exfoliation, bottom-up synthesis strategies were also employed to improve the accessibility of TMD materials around 2012. Techniques such as chemical vapor deposition (CVD), physical vapor deposition (PVD), metal–organic CVD (MOCVD), and molecular beam epitaxy (MBE) have been utilized and modified to meet the demand of large-area TMD films.^{19–24} Technical aspects including crystallinity, uniformity, scalability, and integration compatibility have been steadily improved over the past decade.^{25–30} To date, the film size of uniform monolayer MoS₂ polycrystals has already reached wafer scale up to 300 mm.^{31,32} Besides that, high single crystallinity is another main pursuit to further improve the device performance and device-to-device consistency. By aligning multiple

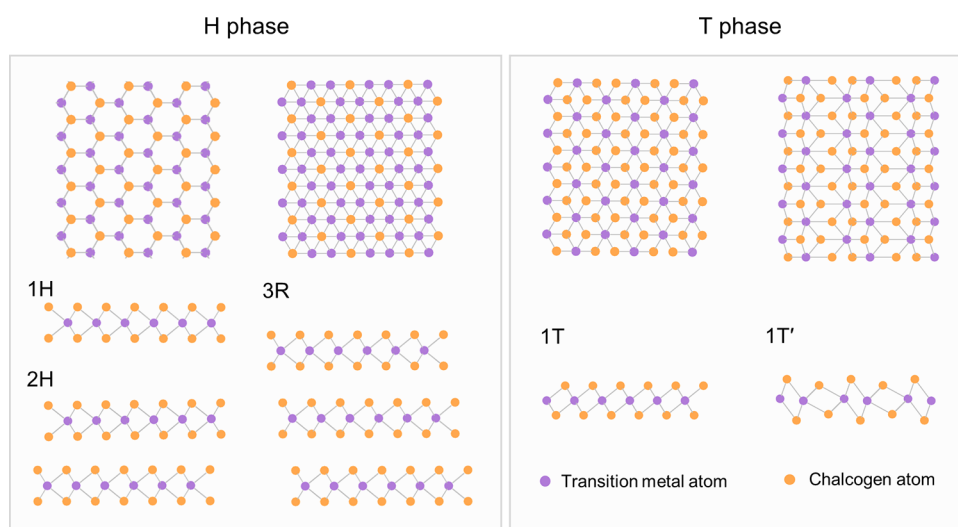


Figure 2. Schematics of the polymorphic structures for the TMDs.

TMD islands unidirectionally and stitching them into a large film, wafer-scale single crystals have become accessible in recent years.^{33–39} The inherent epitaxial behavior of TMDs through substrate engineering is the theme of these routes, which has been systematically studied and driven forward wafer-scale chips with comparable performance to exfoliated crystal flakes.^{36,40}

In addition to the pristine monolayers, a variety of structure modifications offer extra degree of freedom to tailor the functionalities of TMDs. Comprehensive techniques of external doping, stable alloying, and phase engineering are extensively supplemented for specific use including *p*-/*n*-type modulation, bandgap tuning, and semiconductor-metal transition.^{41–44} Besides, there is plenty of room above the 2D basal plane, encouraging designs in homo- and heterointegration regarding layer numbers and twist angles. Moreover, corresponding wafer-scale transfer and patterning techniques are of great importance in bridging the synthesis of as-grown films to hybrid integration and device fabrication.⁴⁵

This Review meticulously outlines the progress in the field of large-area TMDs over the past decade, encapsulating both fundamental designs and practical advancements. Here, we propose and primarily focus on four key aspects, i.e., large-area deposition, epitaxial growth, structure modification, and postprocessing (Figure 1). It begins with a brief introduction to the TMDs family, focusing on their crystal structures, elemental compositions and fascinating properties. Section 3 delves into the bottom-up synthesis designs for large-area TMD films. Advancements in epitaxial mechanisms and techniques aimed at producing single crystals are then discussed in Section 4. Sections 5 and 6 cover the strategies for structure modification and postprocessing, respectively. The Review reaches a crescendo in Section 7, highlighting some of the most promising scenarios and applications of 2D TMDs, effectively demonstrating their versatility and potential. The Review concludes in Section 8 with future perspectives and ongoing challenges, thereby encouraging in-depth exploration and technological innovation in large-area TMDs.

2. STRUCTURES, COMPOSITIONS AND PROPERTIES OF TMDs

As early as 1923, Linus Pauling investigated the crystalline structure of molybdenite (mineral MoS₂) by X-ray crystallography.⁴⁶ This layered crystal is held together by vdW forces, rendering it easily cleaved into nanometer-thick layers, even down to a monolayer, through techniques such as adhesive tape stripping or intercalation-assisted exfoliation.^{47,48} The early stages of TMD research greatly benefited from these fabrication techniques, along with X-ray diffraction and nascent electron microscopy, which were instrumental in delineating the lattice arrangement and precise thickness of TMD layers. The exploration of TMDs at an atomic scale gained significant momentum with the advent of advanced imaging technologies such as scanning tunneling microscopy (STM), atomic force microscopy (AFM), and scanning transmission electron microscopy (STEM). A major breakthrough in the field was marked by the mechanical exfoliation of single-layer graphene by Geim et al. in 2004, paving the way for subsequent achievements in the fabrication and electrical measurements of monolayer TMDs, including MoS₂ and NbS₂.¹⁸ In 2011, a series of pioneering studies concentrated for MoS₂. Heinz et al., Wang et al., and Kis et al., discovered the strong photoluminescence (PL) in monolayer MoS₂, as well as the impressive performance of MoS₂ transistors.^{49–51} These findings fully fueled the exploration of the unique properties of 2D TMDs and sparked a rapid expansion in the field. This chapter is dedicated to providing a sketch of TMDs, including their crystal structure, chemical composition, physical properties, and potential applications. The aim of this section is to provide a comprehensive overview, that elucidates the fundamental physical concepts linking the basic structure and properties of TMDs, tailored especially for new audiences in this field.

2.1. Crystal Structures

For a typical monolayer TMD, two chalcogen atom layers and one metal layer are packaged together to form a sandwich structure, with a thickness of ~ 6 – 7 Å. The exposed chalcogen-terminated surfaces are free of dangling bonds, which can prevent the absorption of external molecules, and thus lead to the ambient stability of TMDs. Considering the metal coordination in the fundamental building blocks (Figure 2),



Figure 3. Periodic table of known experimentally synthesized layered TMD materials (groups IV,^{64–77} V,^{78–99} VI,^{2,100–102} VII,^{59,60,103,104} and VIII^{105–125}), summarizing their existing structural phases (H: trigonal prismatic, T: octahedral, T': distorted octahedral, T_d: orthorhombic), typical band gaps (values at the bottom left corner of each grid, M: metallic), and observed electronic phases (superconducting, topological, and CDW).

monolayer TMDs can be broadly categorized into two configurations: trigonal prismatic (D_{3h}) and octahedral (D_{3d}), denoted as H and T phase, respectively. The octahedral coordination may evolve further variations, such as distorted octahedral T' and orthorhombic T_d structures. The phase structure evolution of TMDs is determined by thermodynamic preferences, which are primarily attributed to the *d*-electron count of the transition metal atom according to the crystal field theory.⁴⁴ Furthermore, taking monolayers as a fundamental building block, the stacking sequence of different monolayers gives rise to additional phase (or polytype) structures. These phases are described by a combination of digit and letter (such as 1T, 2H, and 3R), in which the digit (1, 2, and 3) indicates the number of stacking layers in a unit cell, and the letter (T, H, and R) denotes the trigonal, hexagonal and rhombohedral, respectively. For example, an inversion symmetric 2H phase (space group: $P6_3/mmc$) is constructed by stacking H-phase TMD monolayers in an “AA'AA'AA'...” sequence (A' layers are 180° rotated from A layers). While it comes to the broken inversion symmetric 3R phase (space group: $R3m$) by aligning H-phase monolayers in an “ABCABC...” manner (here A, B, and C layers are orientated parallel to each other).¹

The polymorphic nature of TMD materials enriches their electronic structures and physical properties. For example, the thermodynamic stable 2H-MoS₂ possesses a considerable bandgap of ~2 eV, rendering it an ideal semiconductor for high-performance electronic devices. In contrast, the high-symmetry 1T-MoS₂ phase exhibits metallic properties, with the capability to transition into the 1T' phase through lattice distortion. Notably, the 1T' variant exhibits a spin–orbit coupling induced bandgap, which is pursued as the 2D topological insulator candidate.⁴ The 3R phase of TMDs, known for its broken inversion symmetry, shows promising applications in nonlinear optics and valleytronics.⁵² Given these diverse phase-determined properties, numerous post-processing and synthetic strategies have been proposed to

stabilize and purify some specific metastable phases. Transitions between these phases are also accessible by applying external chemical, thermal, or mechanical conditions. This versatility forms the basis for the intriguing field of phase engineering in TMD fabrication, which will be further discussed in Section 5.3.

2.2. Elemental Compositions

The TMD materials denoted by the general formula of MX₂ consist of a diverse category, where the M and X represent the transition metal and chalcogen atoms with the oxidation states of +4 and –2, respectively. From the aspect of elements, the metal atom M includes elements from group IVB to VIII, and the X is a chalcogen atom including S, Se, and Te. Compounds from groups IVB to VIIB typically crystalline in the layered structure, facilitating the synthesis of thin layers down to monolayers. Conversely, the compounds in group VIII dominantly are nonlayered in nature since they are more thermodynamically stable. A comprehensive first-principles study has predicted that up to 171 types of transition-metal oxides and dichalcogenides are calculated to be stable in monolayer.⁵³ Experimentally, over 40 types of these binary TMD materials have been successfully synthesized as monolayers or few-layer structures.

The TMD scope of the periodic table is shown in Figure 3. In general, the bandgap of TMDs decreases from sulfides, selenide, and even to a semimetal in tellurides. The *d*-electron counts of the coordinate metal atoms correlate with the material's electronic structure, phase structure, and the emergence of unique properties:

- The group IV (d^0 : Ti, Zr, and Hf) TMDs are 1T phase favorable, and the Ti species are extensively investigated in the charge density wave (CDW) phenomenon, such as the TiSe₂ with a high transition temperature of around 200 K.⁵⁴ The Zr and Hf species are predicted as high-performance semiconductors with possible high

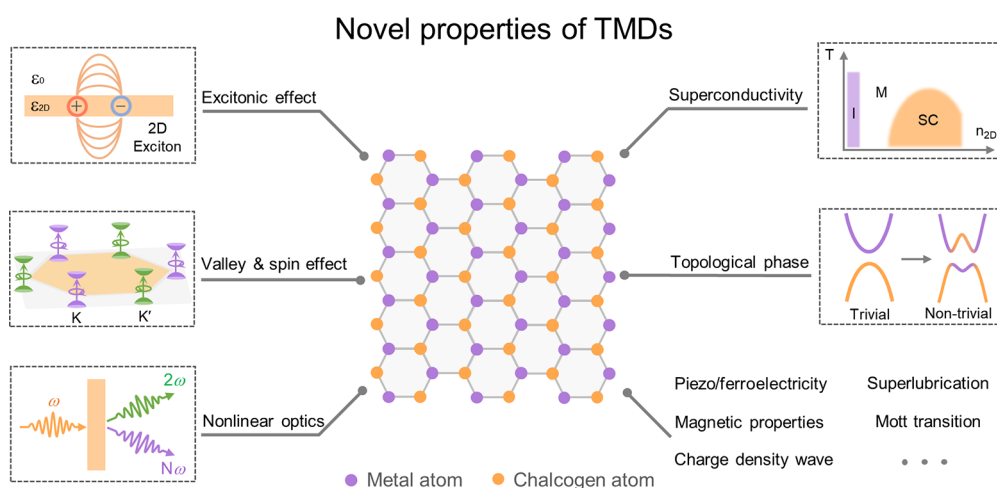


Figure 4. Schematic illustration of the novel properties of TMDs.

mobility (e.g., $\sim 3500 \text{ cm}^2\text{V}^{-1}\text{s}^{-1}$ for HfSe_2) and could form a native high- k layer by mild oxidation.^{55,56}

- (b) The group V (d^1 : V, Nb, and Ta) TMDs are metallic in nature. The V-dichalcogenides have attracted much interest in room-temperature ferromagnetism.⁵⁷ The Nb and Ta species are the most studied TMD materials exhibiting superconductivity and CDW order at low temperatures.
- (c) The group VI (d^2 : Cr, Mo, and W) TMDs are polymorphic with the existence of multiple H, T, T' phases, depending on the preparing conditions. The Cr-dichalcogenides exhibit novel thickness-dependent magnetic properties with promising applications in magneto-electronics.⁵⁸ The H-phase Mo and W species with sizable bandgap and excellent synthesizing convenience are considered as the most promising 2D semiconductors, and their 1T' species (e.g., WTe_2 and MoTe_2) bring importance in exploring novel topological states.
- (d) The group VII (d^3 : Mn and Re) TMDs have attracted fewer investigations than the group VI. The Mn-dichalcogenides prefer nonlayered structures, and the layered species such as 1T-MnSe₂ demonstrated behavior in ferromagnetism at room temperature.⁵⁹ The Re species possess the strongly distorted T phase and serve as anisotropic semiconductors with potential applications in electronics and optoelectronics.⁶⁰
- (e) The group VIII (Fe, Co, Ni, Pd, and Pt) TMDs are mostly crystalline in nonlayered forms. Fe, Co, and Ni themselves are metallic elements with magnetic properties, and their dichalcogenides also have rich magnetic properties. For example, Fe-dichalcogenides exhibit a variety of magnetic behaviors, including ferromagnetism, ferrimagnetism, and antiferromagnetism. The Pd- and Pt-dichalcogenides show promise in applications such as polarized photodetectors and high-performance catalysts.⁶¹

The chemical richness and polymorphic structures suggest the TMD material family is a rich 2D material library for new physics exploration and on-demand concept device design.^{62,63} Further composition engineering such as alloying, doping, and heterointegration can provide a huge number of combinations. To date, steady progress in the large-area fabrication of these

materials fully fuels the field toward promising applications exceeding or complementary to existing technologies.

2.3. Novel Properties

2D TMDs exhibit distinct and extraordinary properties due to the reduced dimensionality.^{126,127} The exceptional electronic structures, broken inversion symmetry, and enhanced Coulomb interaction within 2D TMDs give rise to numerous novel properties, including remarkable excitonic behaviors, giant optical nonlinearity, strong spin-orbit coupling effects, nontrivial topological physics, superconductivity, piezo-/ferroelectricity, and the formation of CDW, etc (Figure 4). In the following sections, we will proceed with a detailed introduction of these novel properties of TMDs, respectively.

2.3.1. Excitonic Effects. One of the remarkable features inherent to 2D TMDs is the pronounced influence of excitons, which govern their optical properties and phenomena.^{127,128} Excitons are bound states formed by the attractive Coulomb force between a negatively charged electron and a positively charged hole.^{129,130} Typically, excitons originate from the optical excitation in semiconductors, promising the efficient recombination and emission of light.^{131,132} However, exciton binding energies are typically very weak ($\sim 10 \text{ meV}$) in conventional bulk materials, which exhibit negligible excitonic behavior.^{133,134} In contrast, 2D TMDs possess tightly bound excitons with large exciton binding energies on the order of hundreds of meV, due to enhanced Coulomb interaction resulting from their reduced dimensionality.^{135,136} Thus, diverse excitonic effects can be observed, such as enhanced photoluminescence emission, complex exciton fine structure and significant environmental sensitivity.^{127,137–140}

Tightly bound excitons significantly influence the optical properties of monolayer TMDs. Thinning TMDs to monolayer limit not only facilitates the formation of tightly bound excitons, due to the quantum confinement and weakened dielectric screening effects, but also transitions them into direct bandgap semiconductors.^{126,141,142} Consequently, a wealth of optical characteristics attributed to the strong excitonic effects have been observed in monolayer TMDs.^{50,51,143,144} For example, monolayer TMDs can absorb light exceeding 15% at the resonance energy of exciton. Considering the atomic-scale thickness, they exhibit obviously stronger light-matter interaction than their bulk counterparts and the conventional semiconductors, such as GaAs and Si.¹⁴⁵ In addition, the

direct-bandgap characteristic leads to the emergence of robust PL in monolayer TMDs, where it is largely absent in the few-layer TMDs with indirect-bandgap.^{50,51} Moreover, PL behaviors of monolayer TMDs exhibit the remarkable excitonic emission, including narrow spectra lines, wavelength-dependent emission efficiency, and temperature-dependent emission features.^{146,147}

The weakened dielectric screening in 2D TMDs has also introduced exciting opportunities for modulating the excitonic behaviors using various external fields, such as electric fields, strain, and light.^{148–154} Additionally, their weak interlayer vdW interactions facilitate the formation of new excitons by fabricating TMD homostructures or heterostructures through interlayer stacking.^{155,156} This versatility provides a new degree of freedom to controlling the excitonic effects, enabling the exploration of unique exciton physics and applications.^{157–161} Presently, the excitonic effects associated with high tunability and controllability have positioned 2D TMDs as promising candidates for advanced photonic and optoelectronic devices.^{162–166}

2.3.2. Nonlinear Optics. Nonlinear optics is the cornerstone of coherent light generation and manipulation.^{167,168} The emergence of 2D TMDs hold immense promise in this realm that becomes a highly sought-after area of research.^{169–174} Direct-bandgap monolayer TMDs stand out in the nonlinear regimes, due to their large nonlinear susceptibility with the lack of inversion symmetry.^{175–177} This feature facilitates the manifestation of various fascinating nonlinear optical phenomena,^{146,178–182} such as even-order harmonic generations, exciton-resonance nonlinear enhancement, and valley-dependent nonlinear selection rules. In addition, the quantum confinement and atomically thin nature of 2D TMDs enable strong broadband nonlinear optical responses and phase-matching-free condition.^{52,183}

Second harmonic generation (SHG), a well-studied nonlinear optical phenomenon, plays a crucial role in characterizing 2D TMDs. During this process, two incident photons with the same frequency ω create a single photon at the frequency 2ω in noncentrosymmetric materials. For 2H phase TMDs belonging to D_{6h} symmetry group, second-order nonlinear optical effects are forbidden (permitted) in their even layers (odd layers), due to the interlayer stacking with opposite dipole orientation.^{169,170} As the thickness is reduced to monolayer, it changes to D_{3h} symmetry group and breaks the inversion symmetry.¹⁷⁸ Nowadays, various SHG characterization techniques have been explored to fully understand the fundamental physics and properties of TMDs. For example, the layer number in 2H phase TMDs can be determined by the SHG response, which is only observed at odd layers and vanishes at even layers.^{178,184,185} The excitonic effects of TMDs can also be characterized through wavelength-dependent SHG responses, where the SHG intensity reveals a significant enhancement at both bright and dark exciton states.^{146,186–188} Moreover, polarization-dependent SHG techniques have been developed to determine the lattice orientation, interlayer stacking angle, strain direction grain boundary, etc.^{172,189–191}

In recent years, significant research has focused on the nonlinear optical behavior and properties of monolayer TMDs. Their large nonlinear susceptibility, combined with the capacity for seamless integration without lattice mismatch, makes them promising candidates for miniaturized and on-chip nonlinear photonics.^{173,192–194} Nevertheless, the absolute energy conversion efficiency in monolayer TMDs is too

weak for practical applications, due to the atomic thickness. To overcome these challenges, various strategies have been proposed to enhance the nonlinear optical response of 2D TMDs, such as excitons, electric field, element doping as well as hybridizing them with fibers, waveguides, quantum dots, and metamaterials.^{146,150,195–201} Currently, a promising strategy is to increase the effective light propagation length in 2D materials, notably with multilayer rhombohedral TMDs with naturally broken inversion symmetry.^{202,203} These intrinsic noncentrosymmetric thick 2D crystals allow simultaneously enhanced nonlinear efficiency and outpower, which has been exploited for the applications of compact nonlinear waveguide, ultrathin frequency-doubling crystal, and ultrathin quantum light source.^{204–206} These advancements would open up exciting possibilities for 2D TMDs for developing compact and efficient nonlinear photonic devices.

2.3.3. Valley Properties. 2D TMDs with hexagonal lattices have two degenerate and inequivalent valleys located at K and K' points of the Brillouin zone.^{207,208} The valleys are largely separated in momentum space, where the electron intervalley scattering can be suppressed with a long lifetime in materials without obvious atomic-scale defects. As a result, the valley has been regarded as an internal degree of freedom (DOF) of an electron in addition to the spin and charge, where valley DOF has been used for information encoding and processing applications known as valleytronics.²⁰⁸ The concept of valleytronics, which has been predicted for some time, now has been demonstrated in conventional bulk materials.^{209–214} However, achieving precise control of the valley state has proven challenging due to the lack of strong coupling between an external field and valley index. The emergence of 2D TMDs have garnered significant attention in this field and offers new opportunities for exploring and controlling valley polarization, due to their capacity for manipulating of valley DOF using various fields.^{215–217}

For 2D materials with the absence of inversion symmetry, they possess two nonzero physical quantities, Berry curvatures and orbital magnetic moments, which have the potential to control the valley DOF and distinguish between the two valleys.^{218–221} By breaking the inversion symmetry of monolayer graphene, the emerging nonzero physical quantities have led to the observation of valley contrasting Hall transport.²¹⁸ In contrast, monolayer TMDs possess intrinsic inversion asymmetry, making them exceptionally suitable materials for exploring valley-dependent physics and phenomena.^{221–225} For example, the strong spin–orbit coupling originated from the d orbitals of the heavy metal atom in TMDs enables the observation of spin-valley locked physics.^{226,227} In addition, the exciton valley polarization can be easily tuned using external fields, including electrical and magnetism fields.^{228–235} Furthermore, 2D TMD heterostructures have exhibited a much longer exciton valley lifetime than that of monolayer TMDs, which makes these interlayer excitons highly promising for valley-dependent applications.^{236–245} These unique valley-dependent physics and phenomena in 2D TMDs and their heterostructures open up new opportunities to realize future spintronic and valleytronic devices.^{246–248}

2.3.4. Superconductivity. The bulk Nb-dichalcogenides, previously studied as conventional low-temperature superconductors, could retain their intrinsic superconductivity even when exfoliated down to monolayer thickness.²⁴⁹ The reduced dimensionality of 2D TMD superconductors generally lead to

a decrease in transition temperature (T_c).²⁵⁰ For instance, the T_c drops from ~ 7 K for bulk NbSe₂ down to less than 3 K in its monolayer counterpart.²⁵¹ The advancement of the bottom-up synthesis methodology has significantly enhanced material accessibility for both fundamental research and promising applications of superconducting 2D TMDs.^{252–254} In addition to intrinsic 2D superconductivity, chemical doping or electrostatic doping can bring the superconductivity in TMDs. For example, doping with alkali metals, such as Cs_{0.3}MoS₂ can lead to a T_c around 6 K.²⁵⁵ A qualitative and clean strategy involves field effect gating semiconducting TMDs by ionic liquids, which form an electrical double layer (EDL) and provide an ultradense sheet of carriers ($>10^{14}$ cm⁻²) to modulate the superconducting behaviors. In 2012, Ye et al. achieved continuous gate tuning of the few-layered MoS₂, demonstrating the remarkable doping range appeared the superconducting dome in phase diagram.²⁵⁶ This gate-induced superconductivity has been demonstrated a common behavior in series TMDs such as MoSe₂, MoTe₂ and CVD-growth WS₂.^{257,258} Furthermore, these 2D TMD superconductors are identified as unconventional Ising superconductors with ultralarge in-plane critical field far beyond the Pauli paramagnetic limit.^{251,259,260}

2.3.5. Charge Density Wave. When the temperature falls below a critical threshold, the stability of the Fermi surface in a system will be disrupted, leading to the redistribution of charge density and the formation of a periodic lattice space modulation known as a CDW.²⁶¹ This intriguing phenomenon is a collective excitation pattern involving phonons commonly observed in specific TMDs, including NbSe₂, TaSe₂, TaS₂, and TiSe₂.^{54,262–268} According to the relationship between the wavelength and original lattice constant, the resulting periodic charge density wave can be categorized into two types: commensurate (CCDW, ratio is rational) and incommensurate (ICCDW, ratio is irrational) CDW. For 2D materials, owing to their intricate lattice and electronic structures, the origin of this temperature-dependent phase transition is still widely discussed, including Fermi surface nesting, electron–phonon coupling interaction, electron correlation interaction, etc. In short, as the temperature decreases, the electron ordering and lattice structure change, accompanied by the emergence of an energy gap at the Fermi surface, resulting in periodic lattice distortion and the opening of an energy gap. For instance, VSe₂ has near-linear Fermi surfaces in its band structure, facilitating perfect Fermi surface nesting and aligning with Peierls' theory.²⁶⁹ However, experiments show that the formation of CDW in NbSe₂ is mainly due to strong electron–phonon coupling, rather than Peierls' theory.²⁷⁰ The CDW state in TMDs can be modulated to a certain extent by temperature, stress, and local electric field, offering potential applications in nanodevices. For instance, leveraging the metal–insulator transition in 1T-TaS₂ at low temperatures enables the creation of FETs²⁷¹ with high switching ratios and nonvolatile memory.²⁷² Additionally, 1T-TaS₂ thin layers can rapidly and controllably transition between NCCDW and ICCDW states at room temperature, facilitating applications in electronic devices like voltage oscillators.²⁷³ In some materials, CDWs have been found to be multiband,²⁶³ offering exciting prospects for CDW-regulated quantum computing in the future.

2.3.6. Magnetic Properties. Ferromagnetism is defined by the alignment of magnetic moments (spins) within certain materials, resulting in a consistent and enduring magnet-

ization.²⁷⁴ In 3D systems, the realization of ferromagnetism requires the Curie temperature to significantly exceed room temperature. However, 2D materials face a distinctive challenge. In 1966, N. D. Mermin and H. Wagner demonstrated that the isotropic Heisenberg model with finite-range interactions at nonzero temperature cannot exhibit ferromagnetic or antiferromagnetic properties in 2D systems.²⁷⁵ To overcome this constraint, the introduction of magnetic anisotropy becomes pivotal for 2D materials, enabling them to exhibit magnetism at specific temperatures. Magnetic anisotropy describes the relationship between magnetism and the relative orientation of the applied magnetic field concerning the lattice and stands as a fundamental requirement for the observation of ferromagnetism in 2D materials.^{276,277} In 2017, researchers made a groundbreaking discovery of intrinsic long-range ferromagnetism in few-layer Cr₂Ge₂Te₆ and monolayer CrI₃. Both 2D materials rely on magnetic anisotropy to suppress thermal fluctuations inherent in 2D crystals.^{278,279} Subsequently, Deng et al. discovered intrinsic ferromagnetism in 2D Fe₃GeTe₂ materials, which could further exhibit room-temperature ferromagnetism through doping.²⁸⁰ The revelation of long-range magnetic ordering in these 2D crystals holds profound significance in understanding spin dynamics at the 2D level. Moreover, these findings possess the potential to unlock a multitude of applications, spanning from individual quantum devices to high-capacity data storage solutions.

Most 2D TMDs are inherently nonmagnetic, but local magnetic moments can be typically induced through the process of doping or adsorption of magnetic atoms.^{281–284} In practice, these locally generated magnetic moments often suffer from the limited stability and controllability, making the establishment of the long-range magnetic order a huge challenge. Similarly, room-temperature ferromagnetism was also observed in 2D MnSe_x layers grown on vdW substrates like GaSe and SnSe₂.⁵⁹ In recent years, ferromagnetic and antiferromagnetic properties have been unveiled in other 2D TMDs, specifically transition metal compounds such as Mn, Fe, and Cr, in combination with chalcogenide elements like S, Se, and Te.^{285–294} In addition, Li et al. have reported the epitaxial growth of CrSe₂ nanosheets on WSe₂, revealing thickness-dependent ferromagnetism.⁵⁸ Theoretical investigations suggest that the magnetic ordering of CrSe₂ was significantly influenced by charge transfer from the WSe₂ substrate and interlayer coupling within CrSe₂. These groundbreaking discoveries are driving advancements in the fields of magnetoelectronics and spintronics.

2.3.7. Piezoelectricity and Ferroelectricity. 2D TMDs with inversion asymmetry serve as a kind of fascinating piezoelectric materials.²⁹⁵ Piezoelectricity results from strain-induced electric polarization or electric-induced stain, allowing the efficient and reversible energy conversion between mechanical force and electricity.^{296,297} The crucial indicator for multifunctional piezoelectric applications is the piezoelectric coefficient that characterizes the intercoupling efficiency between mechanical and electric energy.^{297,298} Noncentrosymmetric 2D TMDs are of great interest in piezoelectricity due to their reduced dimensionality and large piezoelectric coefficient.^{295,299,300} Monolayer MoS₂ was the first experimentally observed piezoelectricity in the family of 2D TMDs, which largely promoted the study of piezoelectricity in 2D materials.^{301–303} Recently, various 2D TMDs, including monolayer or odd-layer 2H phase TMDs, 3R phase

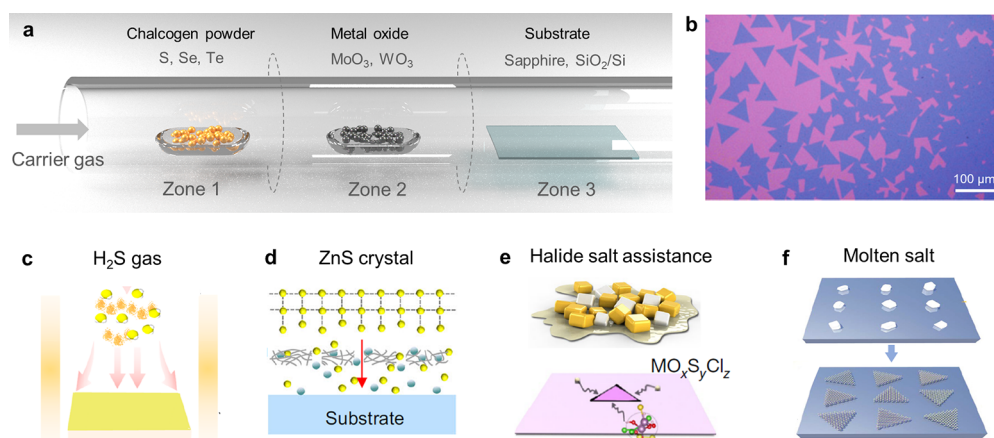


Figure 5. Feeding strategies of chalcogen and metal precursors for the vapor deposition of TMDs. (a) Schematic illustration of a typical configuration for the CVD growth of TMDs. (b) Optical image of the as-grown triangular monolayer MoS₂ islands. Reprinted with permission from ref 357. Copyright 2013 Springer Nature. (c) Vertical supply of gaseous H₂S precursors for TMDs growth. Reprinted with permission from ref 362. Copyright 2020 American Chemical Society. (d) High-melting-point ZnS crystals supply S monomers for MoS₂ growth. Reprinted with permission from ref 366. Copyright 2022 Springer Nature. (e) Molten-salt-assisted CVD method for universal producing of TMD materials. Reprinted with permission from ref 368. Copyright 2018 Springer Nature. (f) Molten Na₂MoO₄ salt facilitates the patterned VLS growth of MoS₂ monolayers. Reprinted with permission from ref 379. Copyright 2019 Royal Society of Chemistry.

TMDs, and their heterostructures, have been demonstrated with strong piezoelectric effects.^{304–306} In combination with the excellent piezoelectricity performance, 2D TMDs, and their heterostructures provide an ideal platform for novel piezoelectric applications in nanoelectromechanical systems and flexible electronic devices.^{307–309}

Beyond the intrinsic piezoelectricity, ferroelectricity in 2D TMDs is also impressive with robust polarization down to atomic thicknesses.^{307,310} Unlike conventional ferroelectrics, 2D TMDs, and other vdW ferroelectrics are robust against depolarization fields.³¹¹ This is attributed to the efficient screening of the bound charges and lower polarization values of vdW systems. The ferroelectricity in the family of 2D TMDs is first demonstrated in topological semimetal few-layer WTe₂, where their spontaneous out-of-plane electric polarization could be switched using gate electrodes. However, ferroelectrics in native 2D TMDs are rare because they are centrosymmetric without spontaneous polarization for their bulk crystals.^{312–314} Recently, 2D TMDs with stacking-engineered assemblies opened up a completely new field in 2D ferroelectrics.³¹⁵ When vdW materials are stacked to break the inversion symmetry, the interfacial charge transfer will lead to a reversal of the out-of-plane spontaneous polarization, enabling the sliding ferroelectricity.^{316–318} This concept was experimentally demonstrated in artificially stacked 2D TMDs, where electrically switchable stacking configurations and ferroelectric domain wall evolution were investigated.^{319,320} Meanwhile, the layer-dependent sliding ferroelectricity was also been demonstrated in the as-grown 3R MoS₂.³²¹ The studies on the field-effect transistors fabricated using 3R MoS₂ with different thicknesses revealed the critical roles layer in sliding ferroelectricity. The ferroelectricity in 2D TMDs offers new possibilities for creating 2D ferroelectrics and provides a new platform for investigating multiferroic phenomena.^{311,314,322}

2.3.8. Topological Properties. The topological nature of materials has been a topic of interest since the discovery of the integral quantum Hall effect in 1980.^{323,324} Topological materials, based on their band structures, are primarily categorized into two types: topological insulators (charac-

terized by insulating inside the bulk while becoming conductive on the edge) and topological semimetals (characterized by the existence of pairs of Weyl points and Fermi arcs on the surface).^{325,326} Recently, 1T' phase TMDs have attracted great attention due to their nontrivial topological properties. Initial theoretical studies suggested that these materials exhibited significant band inversion around the Γ point, indicating their potential for achieving the quantum spin Hall effect.⁴ This was later confirmed experimentally in monolayer 1T'-WTe₂, the first 2D material identified as a topological insulator, where the existence of edge states was demonstrated through Hall effect measurement and angle-resolved photoemission spectroscopy (ARPES).^{327–329} Meanwhile, several kinds of multilayer 2D TMDs, including 1T'-WTe₂ and 1T'-MoTe₂, have been proved as topological semimetals,^{330,331} where various Berry curvature effects are revealed, such as nonlinear Hall effect and circular photogalvanic effect.^{332,333} These findings make 2D TMDs a new platform for exploring novel topological physics and quantum geometrical physics.

Recently, fancy topological states have also been unveiled in bilayer TMDs with a small twist angle, where a moiré superlattice and strong correlated electronic states are formed. In the moiré superlattice, electrons tend to fill in one specific valley rather than distributing equally between different valleys. This behavior leads to the formation of an orbital magnetic moment and breaks time-reversal symmetry, thereby facilitating the exploration of a novel type of topological insulator known as the “orbital Chern insulator”.³³⁴ For instance, in the MoTe₂/WSe₂ superlattice, the quantum anomalous Hall effect was observed clearly, which confirmed the formation of an orbital Chern insulator.³³⁵ Furthermore, in twisted MoTe₂, fractional quantum anomalous Hall effect was observed through different experimental methods, signifying the presence of fractional Chern insulator in 2D TMD superlattices.^{336–339} This groundbreaking discovery is considered a significant step toward the exploring of anyons.

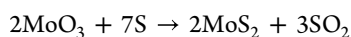
3. VAPOR DEPOSITION OF LARGE-AREA TMD FILMS

The fascinating properties of TMDs have primarily been demonstrated involving micrometer-sized flakes obtained through top-down exfoliation from natural minerals or synthetic bulk crystals. However, this lab-scale approach is limited by its low yield and small sample size, which restricts the scalability and broader application of 2D TMDs. Therefore, the bottom-up growth of large-area TMDs emerges as a promising avenue, utilizing various thin-film fabrication techniques such as sputtering,³⁴⁰ MBE,^{341–343} pulsed laser deposition (PLD),^{344–346} atomic layer deposition (ALD),^{346–354} and vapor deposition methods (including CVD, PVD, and MOCVD). Considering factors such as scalability, crystallinity, uniformity, and fabrication cost, vapor deposition methods stand out as the most promising route toward large-area electronic 2D TMDs. In this section, we delve into a representative solid source CVD method, as shown in Figure 5a, offering a comprehensive entry point for a broad audience to grasp the fundamental concepts and understanding of TMD vapor deposition processes.³⁵⁵ Section 3.1 guides readers through the fundamental designs in vapor deposition of TMDs, covering precursor feeding, surface nucleation, and growth promotion. Subsequently, in Section 3.2, we explore design strategies aimed at producing inch-sized TMD films—a challenging but crucial aspect facilitating the seamless transition of TMDs from laboratory research to practical applications.

3.1. Fundamental Designs in Vapor Deposition of TMDs

The vapor deposition process of large-area TMD materials can be broadly divided into three stages: (i) solid precursors vaporize at high temperatures (or using gaseous precursors) and create steady intermediate mass flows for reactions; (ii) these active intermediates agglomerate into clusters at the high-surface-energy positions on the target substrate, serving as nuclei for TMD growth; (iii) the continued precursor feeding promotes the nuclei to grow into domains, eventually coalescing to form a large-area film. Successfully preparing a piece of TMD film necessitates carefully dealing with numerous parameters, including temperature, pressure, gas flow, substrates, precursors, and growth promoters.³⁵⁶ Here we will introduce the fundamental designs in TMD vapor deposition, which are gradually forming a systematic methodology to advance the experimental production of large-area TMD films.

3.1.1. Precursor Feeding. The selection of appropriate precursors is the initial step in designing a vapor deposition reaction. More challenging than the synthesis of monoelemental 2D materials such as graphene, the vapor deposition of TMDs requires the efficient feeding of both chalcogen and metal precursors. A typical powder-based vapor deposition (or solid source CVD) of TMDs is illustrated in Figure 5a, where the multiheating-zone equipment is designed to simultaneously and independently evaporate the chalcogen and metal precursors. The generated mass flows at high temperatures are carried by inert gas and finally deposited onto the target substrate as monolayer TMD islands (Figure 5b).³⁵⁷ For instance, in the case of MoS₂ vapor deposition using MoO₃ and sulfur powder as precursors, this solid phase chemical reaction can be described as



The chalcogen source of sulfur melts at around 120 °C and creates an acceptable vapor pressure of ~10 Pa.³⁵⁸ In contrast, the vapor pressure is only ~10⁻² Pa for MoO₃ at 900 °C (note that MoO₃ is used as the metal source instead of pure Mo to increase the pressure of evaporated Mo precursor). This significant difference between chalcogen and transition metal precursors further complicates the synthesis process of MoS₂. Consequently, two critical aspects should be addressed for the precise synthesis of TMDs: (i) creating an active and steady mass flow to guarantee effective nucleation and uniform deposition, and (ii) tuning the concentration of as-fed chalcogen and metal precursors over a large range to modulate the TMD growth manner.

During the CVD growth process, upstream chalcogen powders or pellets can instantaneously generate sufficient gaseous sulfur molecules (mainly S₈ or smaller pyrolytic molecules) once the temperature is elevated. Therefore, the primary challenge for chalcogen precursors lies in improving their controllability to achieve a reliable and continuous feedstock flow. Wu et al. addressed this issue by premelting powder-form S precursors and subsequently resolidifying them into pellets to stabilize the sulfur concentrations during growth.^{359,360} This approach notably suppressed defect densities (particularly chalcogen vacancies) to an ultralow level in both interior and edge regions of the TMD domains. In addition to the commonly used elemental chalcogen sources, diluted gaseous chalcogen hydride^{361,362} (H₂S, H₂Se) and ethyl²⁶ ((C₂H₅)₂S, (C₂H₅)₂Se) are also widely utilized in CVD (Figure 5c) particularly MOCVD for synthesizing large-area TMD film due to their excellent diffusivity. The concentrations of these sources can be precisely modulated by controlling the partial pressure of reactants. Feng et al. bubbled liquid thiol (C₁₂H₂₅SH) into the CVD chamber, facilitating in situ healing of chalcogen defect and improving the crystalline quality.³⁶³

Furthermore, thermally stable chalcogen compounds offer an alternative avenue to match well with the vaporization of metal sources. Chalcogen salts like Na₂SO₄, Na₂SeO₃, and Na₂TeO₃, which melt around 700 °C, can effectively participate in synthesis while reducing the formation energies of TMDs.^{364,365} Zuo et al. reported that high-melting-point metal sulfide crystals (ZnS, ZnSe, and ZnTe, Figure 5d) can release active chalcogen monomers by thermally breaking the dangling bonds on the bulk surface, significantly facilitating the robust growth of wafer-scale TMDs with excellent optical and electrical characteristics.³⁶⁶ The slowly released chalcogen monomer is more active than dimers, making it more feasible to diffuse on the 2D surface and quickly heal the chalcogen vacancy, which accounts for the high crystallinity.

Distinguishing from the behavior of the chalcogen source, metal precursors often exhibit low volatility, and are difficult to support a sufficient mass flow. The commonly used metal oxides (such as MoO₃, WO₃ pellets, or mildly oxidized metal foil) undergo decomposition at significantly lower temperatures compared to pure metal precursors.³⁶⁷ To further enable a robust and mild-condition synthesis, the halide salts (NaCl, KI) are frequently introduced to assist with the reaction. These molten salts react with metal oxides and form highly volatile metal oxychlorides, meanwhile yielding the active molten Na_xMoO_y to further promote the reaction (Figure 5e). Benefiting from the assistance of halide salt, Zhou et al. have successfully synthesized up to 32 types of binary TMDs, notably expanding the library of 2D materials attainable via vapor phase deposition.³⁶⁸ To access a controllable metal

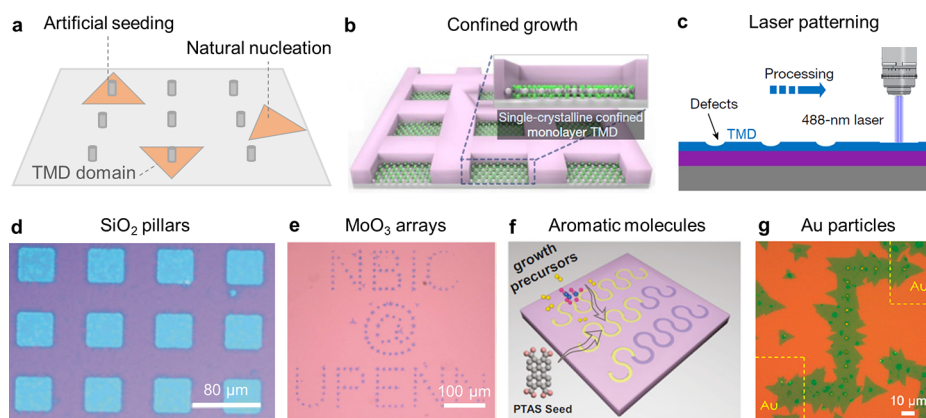


Figure 6. Surface nucleation control strategies for the vapor deposition of TMDs. (a) Schematic illustration of the natural and artificial seeding behaviors of TMDs. (b) Confined growth of single-crystalline TMDs by nucleating at selective areas via patterning SiO₂ masks. Reprinted with permission from ref 398. Copyright 2023 Springer Nature. (c) Laser-patterning of WSe₂ layers to create defect arrays for the selective growth of 2D VSe₂ crystals. Reprinted with permission from ref 399. Copyright 2020 Springer Nature. (d) Nucleation of MoS₂ facilitated by the patterned rectangular pillars on SiO₂/Si. Reprinted with permission from ref 395. Copyright 2013 Springer Nature. (e) Optical image of isolated MoS₂ flakes grown at specific locations by a patterned Mo source. Reprinted with permission from ref 404. Copyright 2015 Springer Nature. (f) Direct growth of MoS₂ nanostructures via seed-promoted growth and substrate engineering. Reprinted with permission from ref 409. Copyright 2019 National Academy of Sciences. (g) Optical image of Au-seeded growth of MoS₂ monolayers used as the transistor channel. Reprinted with permission from ref 410. Copyright 2018 American Chemical Society.

source feeding, a physical buffer layer can be placed between the precursor and substrate to stabilize the mass flow.^{369–371} Another strategy is the dissolution of metal precursors in the target substrates such as Au and molten glass, and the source uniformly diffuses to the surface during high-temperature growth.^{372–376}

To avoid complications arising from the sensitive precursor vaporizing process, Zhang et al. developed a flux-assisted growth strategy where precursors/cosolvents were eutectic and 2D growth within the confinement of mica.³⁷⁷ This innovative approach led to the successful synthesis of 48 ternary or quaternary compounds and 23 nonlayered structures. Moreover, molten salts such as Na₂MoO₄³⁷⁸ and Na₂WO₄ can be directly utilized as metal precursors for TMDs growth via a vapor–liquid–solid (VLS) mechanism³⁷⁹ (Figure 5f). Gaseous metal carbonyls (Mo(CO)₆)³⁸⁰ and volatile carbon-free halide compounds (e.g., MoCl₅,³⁸¹ MoOCl₄,³⁸² and WF₆)³⁸³ are also suitable metal precursors to address the challenges in diffusivity while providing a controllable mass flow. However, it is essential to fully consider the toxicity and corrosivity aspects of these feedstock species.

The precursors both contain chalcogen and metal elementals, such as MoS₂ and WS₂ powders are commonly used in CVT and PVD experiments.^{20,384–387} These thermally stable sources necessitate a considerably higher evaporation temperature, often requiring the addition of transport agents such as halide salt to address this problem. Moreover, these precursors enable the precisely controlled reverse flow strategies, contributing to the efficient fabrication of high-quality TMDs and their heterostructures.^{388,389} Additionally, thermally decomposing salts such as Na₂MoS₄, K₂MoS₄, K₂WS₄, and (NH₄)₂MoS₄^{390–393} can straightforwardly synthesize TMDs at a lower temperature and enable mass production, which will be further discussed in Section 3.2.1.

By now, a comprehensive precursor library and corresponding growth strategies have been developed to satisfy tailored TMDs synthesis requirements. Both chalcogen and metal precursors could be appropriately selected to strike a balance between crucial parameters like reactant concentration, diffusion

uniformity, and operation convenience. This selection forms the foundation for designing subsequent kinetic and thermodynamic processes, encompassing surface nucleation, lateral growth, and more. Meanwhile, the quality of as-grown TMDs closely related to the purity, activity, and uniformity of precursors, constituting a key topic that should be further explored.

3.1.2. Surface Nucleation. Once the vaporized precursors diffuse to the deposition region, they are frequently absorbed onto the target substrate and aggregated into nuclei, acting as the “seeds” for the initial growth stage. Nucleation is well-known to occur naturally or artificially at sites with high surface energy, such as steps, kinks, defects, scratches, and nanoparticles on substrates (Figure 6a). This process is of great importance in controlling the uniformity, crystallinity, and grain size of the resulting TMD films. Besides, the controlled nucleation at selective locations leads to designed single-crystal TMD patterns without involving lithography and etching process, which facilitates the high-throughput device fabrications. In this section, we primarily focus on the basic concept and the control of the nucleation process during TMD deposition.

The edge formation energies of TMD materials are much lower than other 2D counterparts such as graphene and hBN, with even growth no catalysts. As a result, the random-orientated, small-sized, high-density, and discontinuous samples further complicated the surface nucleation engineering. During the vapor deposition of TMDs, the nucleation behaviors are sensitively related to metal source concentration and the diffusivity of Mo atoms on the edge site of MoS₂ being extremely slower than S atoms (~10⁸ times the difference in diffusion coefficients calculated at 1000 K).³⁹⁴ Thus, growth parameters that affect the absorption, diffusion, and desorption of metal feedstocks can collectively influence the nucleation density of TMDs. For instance, to avoid the influence of Mo atoms diffusion caused by dust particles, Van der Zande et al. emphasized the importance of ultraclean substrates and fresh precursors, yielding low-density nucleation and large-area crystal growth.³⁵⁷ As shown in Figure 6d, Najmaei et al.

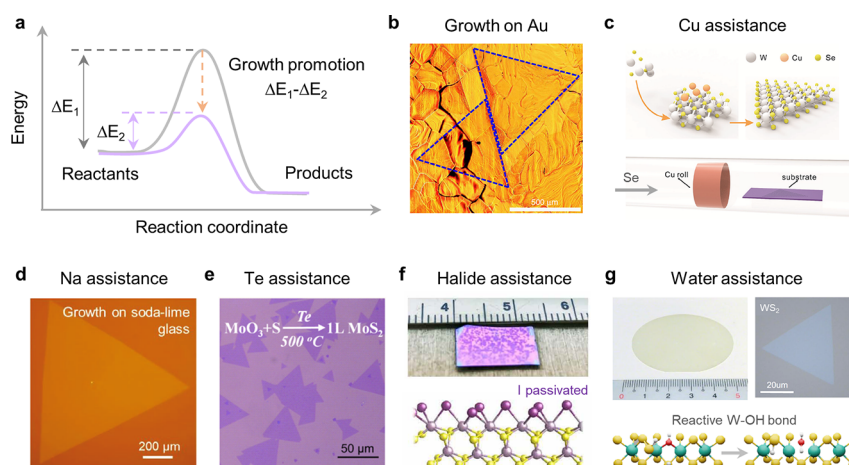


Figure 7. Growth promotion strategies for the vapor deposition of TMDs. (a) Schematic illustration of the energy profile for the lateral growth of TMDs. (b) As-grown millimeter-sized triangular monolayer WS_2 domains on the Au foil. Reprinted with permission from ref 417. Copyright 2015 Springer Nature. (c) Schematic illustration and setup of the Cu-assisted self-limited growth of monolayer WSe_2 . Reprinted with permission from ref 421. Copyright 2016 Wiley-VCH GmbH. (d) Millimeter-size monolayer MoSe_2 single-crystal domain growth on Na-containing soda-lime glass substrate. Reprinted with permission from ref 430. Copyright 2021 Wiley-VCH GmbH. (e) Tellurium-assisted low-temperature synthesis of MoS_2 on SiO_2/Si substrate. Reprinted with permission from ref 439. Copyright 2015 American Chemical Society. (f) Halide-enabled growth of millimeter-sized MoS_2 domains on SiO_2/Si substrate (top panel) and schematic illustration of the Mo-zigzag edge passivated by iodine atoms (bottom panel). Reprinted with permission from ref 431. Copyright 2021 AAAS. (g) Hydroxide vapor phase deposition of low defect density WS_2 monolayers (top panel) and schematic illustration of the presence of W–OH bonds during the growth (bottom panel). Reprinted with permission from ref 437. Copyright 2022 Springer Nature.

designed rectangular ~ 40 nm thick SiO_2 pillars to assist the self-seeding of MoS_2 and obtained large-area continuous films.³⁹⁵ Generally, a lower metal mass flow could efficiently suppress the nucleation density and provide more leave space for large domain expansion. Besides, nucleation density decreases exponentially with substrate temperature due to thermally activated processes. The ultralow nucleation density (several per mm^2) provides a road toward large-area single crystals, which will be further discussed in Section 4.1.

For the nucleation morphology, the center of TMDs sometimes begins with the Mo-contained nanoparticles, referring to a “self-seeding” nucleus accommodating absorbed or diffused feedstocks. Cain et al. carefully explored the nucleus centers of CVD- MoS_2 samples and identified them as the suboxide MoO_{3-x} with a fullerene-like core–shell structure.³⁹⁶ In this regard, a lower reactant concentration on the substrate results in a planar nucleation and growth behavior without the central nanoparticle.³⁹⁷

The sensitive nature of TMDs nucleation provides opportunities for precise control of this process, including substrate modulation and introduction of foreign promoters. Recently, Kim et al. programmed the substrate into arrays with nucleation energy differences by patterning the SiO_2 mask and confined the single nucleus within the target region (Figure 6b), yielding single-domain arrays with high electrical performance and reliably avoiding dealing with undesired grain boundaries.³⁹⁸ This nonepitaxial strategy is compatible with arbitrary substrates that can provide single-crystal channels in a large wafer size. As shown in Figure 6c, Li et al. created local defects at WSe_2 layers by focused laser irradiation, which served as a specific nucleation position for the deposition of periodic top-layer metallic TMDs (such as VS_2 and VSe_2).³⁹⁹ The as-grown scalable heterostructure arrays exhibited excellent device performance and yield due to the atomically clean vdW contact. Furthermore, patterned dispersion of metal precursors (MoO_3 arrays,⁴⁰⁰ Na_2MoO_4 particles,³⁷⁹ $\text{WO}_3/$

NaCl mixture,⁴⁰¹ W pads,^{402,403} and so on) leads to localized high-concentration metal sources that encourage nucleation at these defined locations. Han et al. patterned Mo source using conventional lithographic methods and controlled prepared highly crystalline MoS_2 with predefined positions (Figure 6e).⁴⁰⁴ Innovatively, source and drain metals based on tungsten could directly serve as seeds for the growth of channel TMDs, Cheng et al. demonstrated the selective growth of WS_2 that fills the 40 nm channel between patterned W electrode pads, which keep good short-channel characteristics with high on/off ratios.⁴⁰⁵

Additionally, seeding promoters can artificially facilitate the nucleation process to obtain high-quality crystal growth.^{406,407} Substrate treatment with aromatic molecules such as perylene-3,4,9,10-tetracarboxylic acid tetrapotassium salt (PTAS), 3,4,9,10-perylene-tetracarboxylic acid dianhydride (PTCDA), or reduced graphene oxide (r-GO) significantly facilitates the growth of large-area TMDs crystals at lower deposition temperature.⁴⁰⁸ Notably, inorganic particles exhibit poor performance in nucleation promotion. The discovery of artificial nucleation behaviors then enables spatial-selective nucleation designing. Guo et al. enhanced hydrophilicity through the area-selectively plasma-treated substrate (Figure 6f), and then the hydrophilic PTAS promoted nucleation within the plasma-treated patterns.⁴⁰⁹ Similarly, properly sized artificial metal structures (such as Au dots and Au rods) can govern nucleation due to favorable formation energy of MoS_2 on the Au surface, therefore the nucleus first occurred at metal structures before 2D growth commenced (Figure 6g).^{410–413}

To summarize, as the initial stage of TMDs material growth, surface nucleation behavior has attracted extensive attention in mechanism exploration and material designing. Achieving robust nucleation with precise control over density, positions, and orientations is the prerequisite for further growth promotion toward high-quality TMDs film. More importantly, the nucleation process provides a window to regulate

crystalline orientations, which is the most critical topic in preparing wafer-scale single-crystal TMDs and will be systematically discussed in Section 4.2.

3.1.3. Growth Promotion. From the perspective of the kinetics in TMD growth, the reaction rate is determined by the transition state theory. As shown in Figure 7a, reactants must first overcome an energy barrier to reach an intermediate state at the peak of the energy profile, and finally convert to products. Therefore, it is essential to evaluate the energy barriers that govern serial critical steps during TMDs growth, including precursor decomposition, feedstock diffusion and adatom attachment. A relatively flat energy profile (illustrated by the violet line) is more favorable to promote the transitions through intermediate states and facilitate the growth process. To achieve this, various strategies such as utilizing specific substrates and introducing additives have been developed to substantially lower the energy barriers. By reducing the barrier from ΔE_1 to ΔE_2 , the reaction rate can increase exponentially following the relation of $\exp(\Delta E_1 - \Delta E_2/k_B T)$, where k_B denotes the Boltzmann constant and T is the temperature. Such a fast growth rate enables the rapid and robust preparation of large-sized TMD domains or high-coverage film.

In general, appropriately elevating the growth temperature can improve the growth rate by ensuring sufficient precursor feeding and enhancing the surface migration rate, which is a customary and systematically studied parameter for tuning the growth manner.⁴¹⁴ Zhang et al. employed the reverse flow reactor and demonstrated the up to 45 $\mu\text{m/s}$ growth rate of WS_2 reaching an ultrahigh growth temperature ($T = 1300\text{ }^\circ\text{C}$).³⁸⁸ Benefiting from the advanced growth strategies and characterizations, the temperature-modulated ultrafast growth record has been updated from several micrometers per minute to exceeding 100 $\mu\text{m/s}$.⁴¹⁵ Substrate engineering can also reduce the surface diffusion barrier and improve the overall growth rate. For example, the molten glass substrate (melting above $750\text{ }^\circ\text{C}$), provides an atomically smooth surface and efficiently improves the feedstock migration coefficient and growth rate.⁴¹⁶

Metal catalysts are widely employed in low-dimensional growth of materials such as graphene, hBN, and carbon nanotubes, which also work efficiently in the TMDs growth. Au substrates facilitate the self-limited catalytic surface growth and enable a millimeter-size WS_2 domain growth (Figure 7b).⁴¹⁷ It is also suggested that the low energy barriers and exothermic nature of W and Se diffusion and attachment on the edges of WSe_2 on the Au substrate contributed to the rapid growth process.⁴¹⁸ Besides, nickel particles show a powerful catalyzing effect that enables the rapid decomposition of intermediate MoS_6 to MoS_2 , which is a critical step with a high energy barrier and limits the overall growth rate.^{419,420} Liu et al. introduced Cu into the CVD growth system, where the Cu atoms could adsorb at the WSe_2 surface and facilitate the self-limited monolayer growth (Figure 7c).⁴²¹ Then the W atoms preferred to bond with active edges resulting in an ultrafast lateral growth rate.

Various salts have been harnessed to efficiently promote the synthesis process with their mechanisms broadly falling into two categories: (i) assisting the volatilization/diffusion of metal feedstocks and (ii) decreasing the reaction barrier through the catalytic effect. It is worth mentioning that these additives often perform a complex synergy of the above beneficial effects. For example, halide salts (such as NaCl, KI, and so on) are widely used in decreasing the melting point of

metal precursors discussed above sections; meanwhile, the alkali component (Na, K) serves as an intermediate catalyst and reduces the reaction energy barrier.^{422–429} Zhang et al. adopted Na-containing soda-lime glass as the substrate (Figure 7d) and revealed that the incorporation of Na decreased the highest nucleation energy barrier.⁴³⁰ In addition, halide atoms (I, Cl, Br) also passivate the edges of the TMD domain and modify the growth dynamics (Figure 7f).⁴³¹ The reaction energy barriers are linearly correlated to the dissociation energies of Mo–halogen bonds, and the utilization of KI enables fast growth of ultralarge single crystal MoS_2 domain. Moreover, Wu et al. found that heated additive KI can release I_2 (widely used in CVT synthesis), acting as a transport agent and carrying metal feedstocks to the target substrate.⁴³² Similarly, fluorine released from a high-temperature BaF_2 plate efficiently facilitates the rapid vaporizing of metal precursor and spontaneously facilitates intermediate formation for large-area WS_2 growth.⁴³³ Overall, the growth promotion benefiting from halide salts lies in a complex mechanism deserving detailed exploration.

Diluted hydrogen is a commonly used gaseous additive to create a reduced atmosphere during TMDs growth, especially selenium species sometimes definitely require the assistance of H_2 .^{434–436} As shown in Figure 7g, Wan et al. introduced the H_2O vapor to the CVD chamber reacted with the high-purity metal tungsten foil, and generated the intermediate $\text{WO}_2(\text{OH})_2$.⁴³⁷ Simulations indicated the hydroxide W–OH bonds exhibited lower dissociation energy than the W–O bonds in conventionally used WO_3 precursor. Which facilitated the sulfidation process and enabled the preparation of wafer-scale low-defect-density WS_2 . Similarly, Sassi et al. demonstrated that moisture promoted the defect formation in precursors and enabled a low-temperature growth of WSe_2 .⁴³⁸ Elemental additives such as tellurium powders, when mixed with metal precursors can produce a Te-containing intermediate phase and enable a low-temperature synthesis (Figure 7e).⁴³⁹

Benefiting from the efforts in exploring the growth promotion of TMDs, robust and fast lateral growth has been steadily realized while permitting synthesis under much milder conditions. This progress not only elucidates the intricate growth mechanism but also encourages the development of fabrication techniques better suited to market demands and industrialization.

3.2. Growth Strategies of Large-Area TMD Films

Drawing insights from the successes of commercially established semiconductors such as silicon, gallium arsenide (GaAs), and gallium nitride (GaN), the efficient production of large-area single-crystal stands as the cornerstone of the semiconductor industrial manufacturing processes. For the emergent 2D semiconductors, the uniform film size should be scaled up step by step from micrometer-sized isolated islands to inch-sized standard wafers. Because large-area TMDs wafers meet industry standards can facilitate seamless integration into full-scale manufacturing processes alongside silicon techniques. Furthermore, an expansive operational area within a single-piece TMDs wafer enables the incorporation of complex circuits and a significant increase in device yield per production cycle, leading to cost-saving production. Aiming toward this goal, a number of strategies have been developed to improve the uniform area of the prepared TMD films. In this section, the large-area TMD growth strategies are divided into four

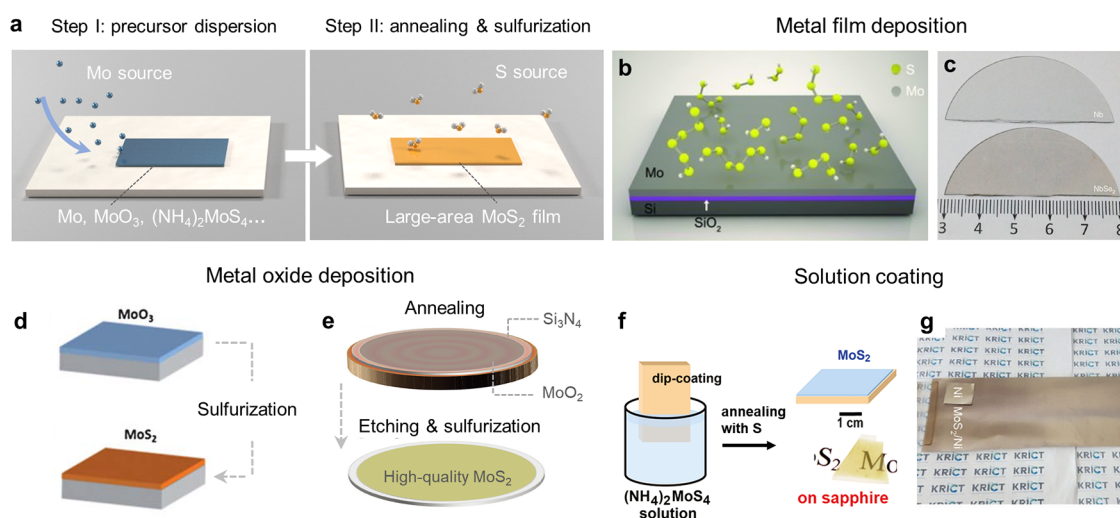


Figure 8. Two-step growth of large-area TMD films. (a) Schematic illustration of the two-step processes of fabrication TMD films. Step I: transition metal precursors such as Mo, MoO₃, or (NH₄)₂MoS₄ are dispersed on a large-area substrate. Step II: the predeposited precursors are annealed and sulfurized into large-area TMD films. (b) Large-area fabrication of MoS₂ by sulfurizing predeposited Mo thin film on the SiO₂/Si substrate. Reprinted with permission from ref 442. Copyright 2012 Wiley-VCH GmbH. (c) As-deposited Nb film and selenization-prepared NbSe₂ film on 2-in. sapphire substrates. Reprinted with permission from ref 253. Copyright 2019 Springer Nature. (d) Synthesis of MoS₂ layers by sulfurizing thermally evaporated MoO₃. Reprinted with permission from ref 443. Copyright 2012 Royal Society of Chemistry. (e) Synthesis of highly crystalline MoS₂ films converted from capping layer annealing process-treated MoO₂ films. Reprinted with permission from ref 456. Copyright 2020 Wiley-VCH GmbH. (f) Schematic illustration of the fabrication process of MoS₂ thin layers by thermolysis of (NH₄)₂MoS₄ precursor. Reprinted with permission from ref 390. Copyright 2012 American Chemical Society. (g) Roll-to-roll prepared MoS₂ film on the Ni substrate by thermal decomposition of (NH₄)₂MoS₄. Reprinted with permission from ref 391. Copyright 2018 Wiley-VCH GmbH.

types according to the supply manner of metal source, that is, two-step, “point-to-face”, “face-to-face”, and vapor phase strategies. Each of these strategies plays an important role in improving the size of TMD films satisfying industrial requirements.

3.2.1. Two-Step Strategy. As discussed previously, the key to synthesizing large-area TMD films lies in the homogeneous supply of metal precursors. A direct and effective strategy is depositing a uniform metal-containing precursor film via established techniques such as spin coating, sputtering, thermal/e-beam evaporating, PLD, and ALD.^{440,441} Then followed by a high-temperature sulfurization process as illustrated in Figure 8a. This proposed two-step strategy clearly offers advantages in terms of robust and scalable fabrication of large-area TMDs films on a range of substrates, making it particularly favorable for cost-effective production. Nevertheless, the limited material quality restricted their potential for high-performance applications in electronics and optoelectronics. Therefore, the main challenges of the two-step strategy lie in two perspectives: (i) acquiring a continuous TMDs film with controlled thickness, especially monolayer and (ii) improving the crystallinity.

In 2012, Zhan et al. pioneered the scalable fabrication of TMDs by depositing a Mo thin layer on the Si/SiO₂ substrate and sulfurizing it into a large-area crystalline MoS₂ film.⁴⁴² It also resulted in introducing critical defects that decayed the mobility of the films (Figure 8b). At the same stage, Lin et al. alternatively thermally deposited MoO₃ and achieved a uniform 2-in. wafer-scale MoS₂ film through sulfurization (Figure 8d).⁴⁴³ Subsequent studies have explored in improving the thickness control of MoS₂ layers by employing various deposition techniques. Lee et al. e-beam evaporated MoO₃ layer at a low rate of less than 0.1 Å/s, enabling the creation of controllably fabricating MoS₂ films ranging from 2 to 12 layers.⁴⁴⁴ The ALD could efficiently govern the precursor

thickness by adjusting the process cycles, yielding uniform MoS₂ films with the desired number of layers.⁴⁴⁵ Moreover, the sulfurization process of MoO₂ microcrystals can be modulated to favor a layer-by-layer growth of MoS₂ films.⁴⁴⁶ The addition of halide salts such as NaCl can further assist with the layer number control process in a two-step strategy. Versatile assembly of deposited metal precursors also provides freedom in patterned growth of diverse TMDs materials and corresponding heterostructures/alloys.^{254,447–452}

The bottleneck of the two-step strategy lies in limited quality of the obtained TMD films. Generally, a high sulfurization temperature and a precisely controlled S vapor flow can lead to a high-quality MoS₂ film ensuring the sufficient reaction.^{453,454} The presence of oxygen in the metal precursor is also crucial for the crystallinity of the TMD films. As shown in Figure 8c, Lin et al. prepared the Nb film in H₂O/O₂-free conditions and then converted it into high-quality NbSe₂ layers, which not only exhibited excellent superconductivity but also remained stable under harsh treatments.²⁵³ Additionally, the pretreatment of precursor layers also can efficiently improve the quality of two-step grown film. For example, Tai et al. preannealed the Mo foil at 1400 °C to smooth the surface and enlarge the grain size, the finally obtained continuous MoS₂ film could be easily transferred by etching the Mo foil using FeCl₃ solution.⁴⁵⁵ Besides, Xu et al. capped a Si₃N₄ layer on the deposited MoO₂ (>5 nm due to the thermal stability, Figure 8e) and preannealed the system at 900 °C.⁴⁵⁶ This recrystallization process could efficiently improve the quality of precursors, therefore the sulfurized MoS₂ films exhibited improved electrical performance. The epitaxy MoO₂ with a defined crystalline orientation could show “heredity” in the converted MoS₂ film, suggesting the potential of synthesizing single-crystalline TMDs on various substrates.^{457,458}

An alternative within the two-step strategy involves utilizing the liquid precursor solutions to fabricate large-area TMD

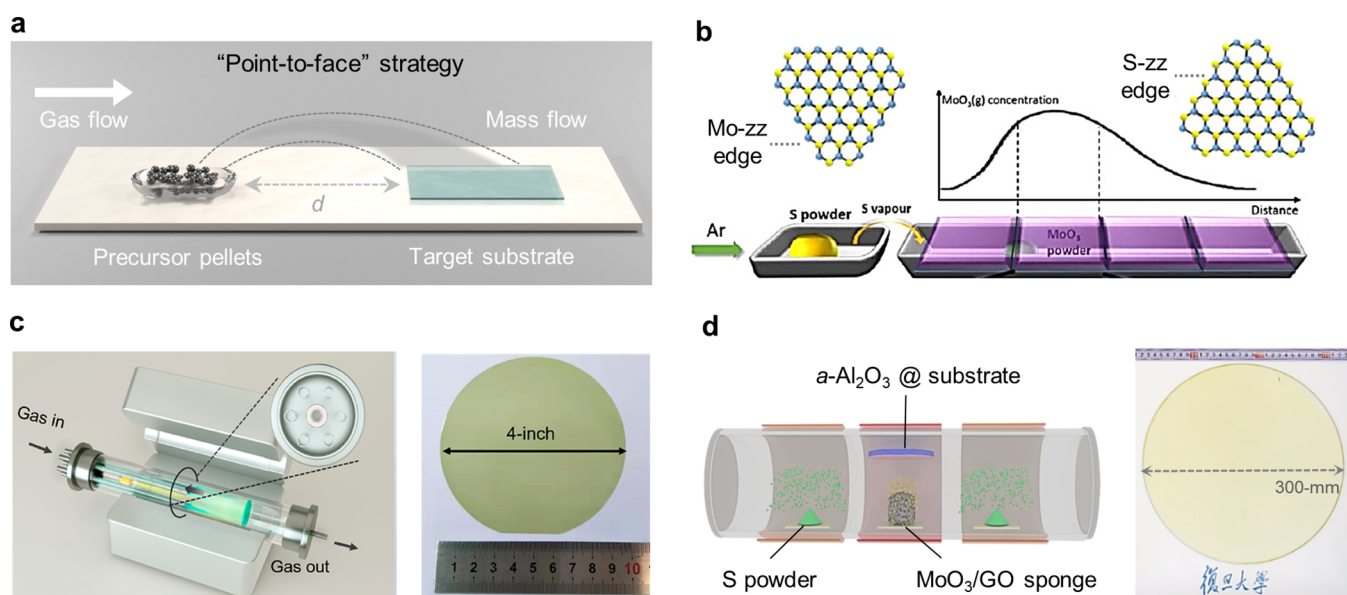


Figure 9. Point-to-face fabrication of large-area TMD films. (a) Schematic illustration of the precursor feeding configuration utilizing a “point-to-face” strategy. (b) Study of the shape evolution of monolayer MoS₂ crystals by the MoO₃ diffusion concentration gradient. Reprinted with permission from ref 478. Copyright 2014 American Chemical Society. (c) Multisource CVD setup and the 4-in. monolayer MoS₂ film prepared on a sapphire substrate. Reprinted with permission from ref 25. Copyright 2020 American Chemical Society. (d) Fabrication of 300 mm monolayer MoS₂ film on amorphous-Al₂O₃/Si substrate. Reprinted with permission from ref 32. Copyright 2023 Springer Nature.

materials.⁴⁵⁹ Liu et al. dip-coated the substrate with a (NH₄)MoS₄ layer and annealing it at high-temperature.³⁹⁰ The thermolysis of precursor yielded a crystalline MoS₂ film and the quality could be further improved with S vapor presence (Figure 8f). This mild thermolysis reaction avoids the high-temperature sulfurization processes and diversifies the available substrates such as plastic plates and metal foils.^{460,461} For example, Lim et al. coated the (NH₄)MoS₄ solution on Ni foil and followed with a roll-to-roll thermal decomposition. This process produced a 50 cm length of MoS₂ layers that demonstrated applicable catalytic activity (Figure 8g).³⁹¹ Similarly, Baidoo et al. coated liquid transition metal precursors on rollable oxide Al foils and sulfurized them by ammonium sulfide, achieving a 14-in. sized SnS₂/ReS₂/MoS₂ heterostructure.⁴⁶² While the liquid precursor coating and converting process may limit the quality of TMD materials compared to vapor-deposited methods, its scalability and operation convenience makes it a promising option for direct patterning growth and mass production of TMDs.^{464,465}

3.2.2. “Point-to-face” Strategy. The point-to-face strategy is the most used method in vapor depositing large-area TMD materials, which starts with solid metal and chalcogen precursors (either in powder or pellet form) positioned upstream or under the target substrates, as shown in Figure 9a. As previously discussed, in this strategy, metal and chalcogen precursors could be spatially separated, which are individually heated due to their differences in vaporizing temperature. Additionally, the substrate could also be ramped to a specific temperature to control the growth manner of TMDs. Consequently, the point-to-face strategy typically requires a multiheating-zone CVD furnace (sometimes using a heating belt to vaporize the sulfur source) to meet these varying temperature requirements. Independently control over each growth parameters allows for more freedom in tuning of crystalline orientation, domain size, crystal morphology, coverage ratio, defect density and so on. Owing to its superior

controllability, this strategy is lab-preferred and efficiently advances the development of TMDs synthesized via bottom-up approaches. While the mechanism of the point-to-face strategy has been discussed above, this section will mainly focus on recent improvements aimed at synthesizing larger-area TMD films.

The operation convenience of the point-to-face strategy has made it a pioneering choice in vapor depositing large-area monolayer TMDs. In 2012, Lee et al. demonstrated the growth of MoS₂ by loading the MoO₃ powder in a ceramic boat and mounting it with SiO₂/Si substrates, where a separate sulfur powder served as the chalcogen source upstream.¹⁹ This setup enabled the formation of star-shaped MoS₂ domains on the substrate, which eventually merged into a large-area monolayer film with sizes of several millimeters. This pioneering work established a framework for using CVD to prepare various large-area TMDs, including MoS₂, MoSe₂, WS₂, WSe₂, MoTe₂, WTe₂, and so on.^{466–473} To further improve the controllability, the sulfur precursor, metal precursor, and substrate were decoupled to separate spatial positions.^{474–476} Yu et al. further refined this method by employing independent carrier gas pathways for MoO₃ and S sources, including a small amount of oxygen into the MoO₃ pathway to prevent premature sulfurization during growth.⁴⁷⁷ This improvement enabled the epitaxial growth of a 2-in. monolayer MoS₂ film on a c-plane sapphire substrate with highly orientated domain distribution. The limited diffusion ability of metal precursors leads to a sharp variation in feedstock concentration spatially, thus altering the precursor ratio with distance from the point-like sources. This feature has inspired a deeper understanding of TMD growth behaviors concerning precursor ratios. For instance, Wang et al. studied the shape evolution of monolayer MoS₂ with Mo/S ratio, observing a transition from S-zigzag to the Mo-zigzag termination while tuning the Mo/S ratio from 1:>2 to 1:<2, as illustrated in Figure 9b.^{478,479} Nevertheless,

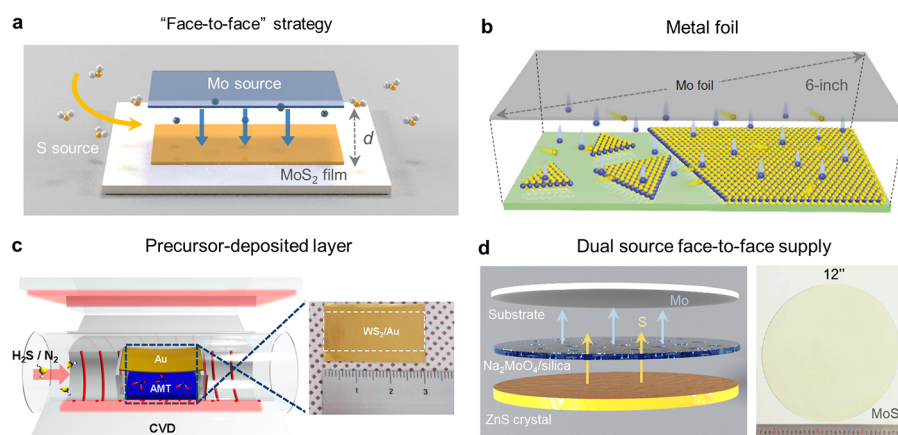


Figure 10. Fabrication of large-area TMD films by face-to-face strategy. (a) Schematic illustration of the face-to-face supplement of Mo source for the large-area growth of MoS₂ film. (b) Fabrication of the 6-in. MoS₂ film on soda-lime glass substrate by face-to-face precursor supply with metal foil. Reprinted with permission from ref 422. Copyright 2018 Springer Nature. (c) Growth of centimeter-scale monolayer WS₂ film on Au foil face down to a precursor plate with ammonium metatungstate (AMT). Reprinted with permission from ref 496. Copyright 2015 American Chemical Society. (d) Fabrication of 12-in. MoS₂ film by both face-to-face supplement of metal and chalcogen precursors. Reprinted with permission from ref 31. Copyright 2023 Elsevier.

supplying precursors in such a point-like manner presents a significant challenge in further enlarging TMD films.

To overcome the challenge related to material size, plenty of modified point-to-face methods have been developed to ensure a more uniform distribution of metal mass flow. One such modification involves placing the substrate vertically relative to the gas flow, which helps avoid the sharp concentration gradient typically seen in the horizontal direction.^{480–482} As shown in Figure 9c, Wang et al. employed a multisource design in the traditional CVD setup.²⁵ This design featured six independent mini-tubes, each containing the same amount of MoO₃ precursors, to deliver feedstocks uniformly and establish a uniform Mo concentration across the cross-section of mass flow. A 4-in. sapphire substrate placed vertically and subjected to precisely controlled growth parameters facilitated the epitaxy of a high-uniform MoS₂ monolayer with superior electrical performance. Recently, Yu et al. optimized this configuration as a designed vertical CVD system, which enabled the epitaxial growth of 8-in. MoS₂ wafers with excellent uniformity.⁴⁸³ This modified point-to-face method also demonstrates its versatility in preparing 4-in. monolayer MoSe₂ wafers.⁴⁸⁴ Yang et al. also designed a showerhead configuration to facilitate the uniform supply of Mo precursors, which is similar to the face-to-face strategy discussed in the following section.⁴⁸⁵ In addition to creating more “points” to guarantee large-area uniformity, He et al. introduced a localized supply of Mo precursor via a small-diameter nozzle, and moved the sapphire substrates under the downward-diffusing feedstock.⁴⁸⁶ This technique enabled the fabrication of 2-in. continuous MoS₂ film, with thickness control achieved by adjusting the number of moving cycles. In another advancement shown in Figure 9d, Xia et al. improved the spatial homogeneity of both chalcogen and metal precursors, successfully fabricating a monolayer MoS₂ film up to 12 in. in diameter.³² Wherein the Mo source was effectively controlled by encapsulating MoO₃ in the porous graphene oxide (GO) sponge, and two sulfur sources were arranged symmetrically at the center MoO₃ source. This setup ensured a uniform Mo and S precursor distribution across a 300 mm amorphous Al₂O₃/Si substrate.

In summary, the widely used point-to-face strategy produces electronics-grade large-area TMDs films due to their excellent controllability and equipment accessibility. Through innovative modifications to the growth system, the size of TMD wafers produced has expanded to inches. However, the efficiency of the point-to-face fabrication process still falls short of meeting the demands of TMD material industrialization. Therefore, enhancing the high-throughput capabilities of this method remains an area in need of further exploration.

3.2.3. “Face-to-Face” Strategy. To achieve a more uniform distribution of precursor concentrations, a face-to-face strategy has been developed for the fabrication of large-area TMDs. This growth system involves positioning a target substrate and a similarly sized source plate in a face-to-face arrangement as is illustrated in Figure 10a. This setup allows for a uniform mass transfer of precursors, especially nonvolatile metal feedstocks, providing a uniform concentration profile at the substrate surface. Due to the efficient precursor feeding capability, this face-to-face strategy is especially advantageous for preparing inch-sized TMD films. Moreover, this arrangement not only conserves space within the furnace but also significantly increases the yield of TMD materials per batch, thereby facilitating efficient mass production.⁴⁸⁷ As a compromise, the bonded substrate and precursors have to be exposed to the same temperature, resulting in a loss of flexibility to independently modulate their heating profiles. As a complement to the point-to-point strategy, the face-to-face approach primarily concentrates on producing large-area TMD films by creating a uniform large-area source and optimizing the source–substrate configuration.

The homogeneous metal foils are naturally suited as an ideal source in face-to-face strategy.^{488,489} As shown in Figure 10b, Yang et al. bridged a Mo foil above the soda-lime glass substrate in a parallel geometry, employing oxygen as a carrier gas to facilitate precursor volatilization.⁴²² This face-to-face approach enabled the rapid growth of uniform monolayer 6 in. MoS₂ films in just 8 min. For comparison, employing a point-to-face feeding route on a similar-sized substrate revealed a distinct precursor concentration gradient during MoS₂ growth. To introduce flexibility in thickness control, Yang et al. utilized a halide salt-coated Mo foil in face-to-face growth. This

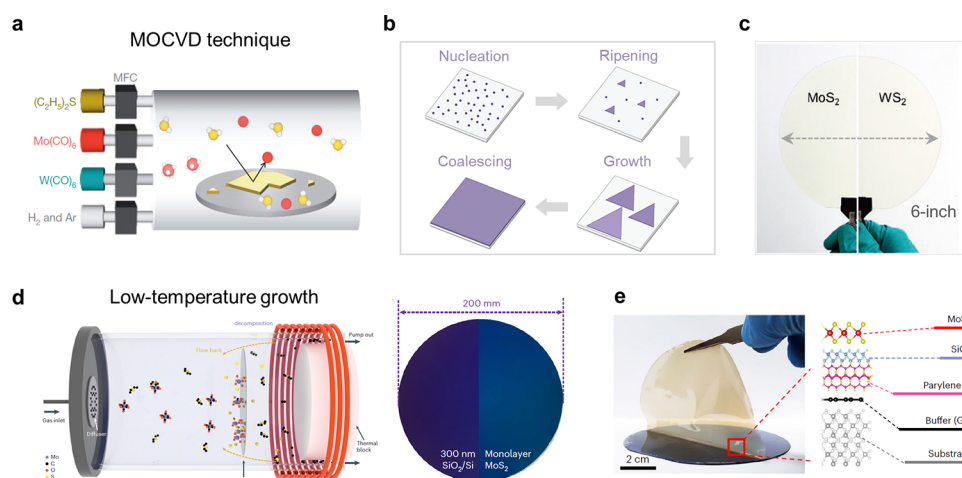


Figure 11. Fabrication of large-area TMDs based on vapor phase strategy. (a) Schematic illustration of a typical MOCVD setup. Reprinted with permission from ref 26. Copyright 2015 Springer Nature. (b) Diffusion-controlled MOCVD consists of controlled nucleation, ripening, and lateral growth processes. Reprinted with permission from ref 506. Copyright 2018 American Chemical Society. (c) Monolayer MoS₂ and WS₂ grown on 6-in. quartz substrates by pulsed MOCVD. Reprinted with permission from ref 507. Copyright 2020 Wiley-VCH GmbH. (d) Low-temperature MOCVD setup and the as-grown 300 mm MoS₂ monolayer on SiO₂/Si substrate. Reprinted with permission from ref 27. Copyright 2023 Springer Nature. (e) Low-temperature growth of a 4-in. MoS₂ film on the parylene C substrate. Reprinted with permission from ref 518. Copyright 2023 Springer Nature.

modification enabled the adjustment of the thickness of the 6-in. MoS₂ film from 1L to over 20L by changing NaCl promoter concentrations.⁴⁹⁰ This face-to-face configuration requires close proximity between the source and substrate to ensure a uniform precursor concentration, often resulting in excessive feeding. This dilemma hinders the adjustment of the Mo/S ratio, which is known as a key parameter in TMDs epitaxy. An innovative solution involves inserting a carbon cloth as a buffer layer between the Mo foil and the target epitaxial sapphire substrate.³⁷¹ This design gently filtered the precursor and ensured a moderate concentration. Employing the face-to-face strategy, this setup facilitated the epitaxial growth of 7 pieces of uniform 2-in. single-crystal MoS₂ films on C/A sapphire in a single batch.

In addition to metal foils, predeposited precursor plates are also commonly used in the face-to-face strategy, allowing for finely controlled amounts of precursor.^{491–495} In 2015, Yun et al. dropped the water-soluble ammonium metatungstate (AMT) on Al₂O₃ to serve as a large-area W source, facing an Au foil substrate.⁴⁹⁶ The parallelly configured system inserted with H₂S gas reacted at high temperature to produce an over 6 cm² WS₂ film on the target Au substrate (Figure 10c). Such solution-processed precursors offer more freedom in source concentration design. Lee et al. dissolved MoO₃ powder in ammonium hydroxide and spin-coated the solution on SiO₂/Si for face-to-face MoS₂ synthesis.⁴⁹⁷ They were able to precisely control low supersaturation levels by optimizing the solution concentration. As a result, parameters such as average nucleation density, crystal size, and MoS₂ coverage were systematically studied as a function of the amount of precursor. To further uniformly supply both chalcogen and metal sources, it is proposed to design a face-to-face supply of both chalcogen and metal precursors. Guo et al. employed Na₂MoO₄-containing perforated carbon nanotube film as a precursor plate, where Mo precursor was released from the solid part and S vapor passed through the hollow part, ensuring the uniform growth of MoS₂ monolayers.⁴⁹⁸ Recently, Xue et al. developed an approach by packaging ZnS plate, Na₂MoO₄-

coated perforated silica, and target substrate into a producing module.³¹ These modules were then stacked as integrated arrays for batch production as shown in Figure 10d. The sufficient and uniform precursor feeding design enabled the fabrication of 3 pieces of 12-in. monolayer MoS₂ wafers in a single process cycle.

Overall, the face-to-face strategy developed from the point-to-face strategy has speeded up the transition of lab-scale sample preparation toward the downstream application of wafer-scale TMDs materials. The low-cost feature and acceptable material quality enable it as a candidate technique for 2D material manufacture. In the future, the expected fabrication based on the face-to-face strategy should balance the mass-producing capability and material crystallinity (lower vacancy density and grain-boundary density) to satisfy the high-end industrialization demand in next-generation electronics and optoelectronics.

3.2.4. Vapor Phase Strategy. The metal–organic compounds are widely known in the production of III–V semiconductor and oxide superconductor thin films. For the MOCVD growth of TMDs, volatile metal precursors efficiently address the issue of insufficient vapor pressure that is often occurred in metal oxide counterparts. For example, the hexacarbonyl compound Mo(CO)₆ can create a vapor pressure of 0.177 Torr at 25 °C, which is several orders of magnitude higher than MoO₃.²³ The excellent volatility of the precursors guarantees the high-throughput growth of TMD films with wafer-scale uniformity. The typical MOCVD setup as illustrated in Figure 11a includes Mo(CO)₆, S(CH₂CH₃)₂, accessory H₂, and inert carrier gas.²⁶ These components are injected into the growth chamber and modulated individually by mass flow controllers during the growth process. The partial pressure of every component can be precisely controlled and supply a wide chalcogen/metal ratio window up to 10⁵.⁴⁹⁹ The TMD thin films prepared by the MOCVD technique were demonstrated earlier with limited control in crystallinity and thickness.⁵⁰⁰ In 2015, Eichfeld et al. presented the fabrication of monolayer WSe₂ with precise control of growth parameters

in MOCVD.²² Remarkably, Kang et al. successfully synthesized 4-in. MoS₂ and WS₂ films with excellent homogeneity and electrical performance.²⁶ The flexible control over precursor partial pressures facilitated a layer-by-layer growth model, ensuring complete coverage and uniform thickness. Recently, Kwon et al. fabricated the 200 mm polycrystalline MoS₂ wafer by MOCVD and demonstrated its compatibility with a commercial fabrication facility.⁵⁰¹ These milestones fully prove the vast potential for scalable 2D TMDs production via MOCVD. Meanwhile, several challenges have emerged as (i) the limited domain size requires further enlargement to improve the crystallinity and (ii) the carbon contamination that stems from precursors should be prevented or removed.

The typical grain size of TMD films prepared by MOCVD is ~100 nm, which is around two orders smaller than the power-based CVD counterparts. Parameters including optimizing growth temperature, metal/chalcogen ratio, H₂ concentration, chamber pressure, and the choice of substrate can tune the nucleation density and grain size in a large range.⁵⁰² Furthermore, the additives such as alkali-metal can be introduced to the MOCVD process to promote the lateral grain size.⁵⁰³ Kim et al. demonstrated that pre-exposing the sapphire substrate to alkali metal halides (NaCl and KI) could suppress nucleation and dramatically increase the lateral island size to the order of 10 μm.⁵⁰⁴ Although the alkali metal residuals were washed out after the transfer process, evidence suggests that the use of these additives disrupted the epitaxial relationship between the TMDs and sapphire due to interfacial alkali adatoms.⁵⁰⁵ Benefiting from the excellent controllability of MOCVD, the nucleation and lateral growth stages can be decoupled, introducing a key ripening process to promote large grain formation. As shown in Figure 11b, Zhang et al. introduced a brief nucleation stage driven by a higher W flow rate, then turned off the W source and ripened the WSe₂ nucleus by annealing in the Se source, finally reintroduced a lower W flow to further promote the lateral growth.⁵⁰⁶ The obtained fully covered WSe₂ film epitaxially oriented with respect to the sapphire substrate. Additionally, the pulsed injection of precursors with periodic interruption also drives a nucleation ripen process, which was employed for high-throughput production of MoS₂ and WS₂ wafers up to 6 in. (Figure 11c).⁵⁰⁷ Further elevating the temperature during the ripening process can significantly increase the grain size to over 20 μm with high crystallinity.⁵⁰⁸ Moreover, Cohen et al. designed a water vapor etching process during pulsed-MOCVD growth, which also suppressed the nucleation density and increased the average grain size.⁵⁰⁹ These advancements in MOCVD fabrication of 2D TMDs preserve its advantages in terms of controllability and scalability while enhancing the quality of the prepared materials.

It is also suggested that an undesired carbon layer could be simultaneously formed at the interface of the substrate and as-grown TMDs during MOCVD.^{510,511} This carbon contamination can limit the lateral growth of islands and hinder the coalescence process. In this regard, an appropriate concentration of H₂ or water flow can be employed to remove the carbonaceous species.⁵¹² Alternatively, a carbon-free chalcogen precursor such as H₂S also reduces the excessive carbon and elemental impurities and produces high-quality TMDs films.^{499,513}

Importantly, the MOCVD techniques are suited for the low-temperature growth due to the utilized active and volatile reactants. Plenty of strategies have been developed to lower the

MOCVD processing temperature to within the BEOL-compatible regime.^{514–516} For instance, Park et al. precisely controlled the flow rate of organic precursors and synthesized high-quality MoS₂ crystals with domain sizes up to the 120 μm at a temperature of 320 °C.⁵¹⁷ In recent studies, the precursor decomposition and target substrate regions have been decoupled, significantly reducing the growth temperature to much below the BEOL limit and enabling the use of various substrates (Figure 11d). Zhu et al. achieved the direct deposition of MoS₂ film on a 200 mm SiO₂/Si substrate at 275 °C with high electrical mobility ~35.9 cm²V⁻¹s⁻¹.²⁷ This demonstrated the potential for integrating 2D semiconductors with advanced silicon CMOS circuits. Similarly, Hoang et al. synthesized MoS₂ monolayers on polymers and 30-μm-thickness glass substrate at an ultralow growth temperature of ~150 °C (Figure 11e).⁵¹⁸ The high-quality material further enables the fabrication of flexible logic circuits and transparent phototransistors.

4. EPITAXIAL GROWTH OF LARGE-AREA SINGLE CRYSTALS

In addition to the size requirements for TMD films, pristine single crystals are considered a promising industrial choice due to several superiorities. First, single-crystal TMD films circumvent the performance degradation associated with defective grain boundaries inherent in their polycrystalline counterparts, ensuring device-to-device consistency during integration. Second, the pristine lattice arrangement in a single-crystal TMD enhances the environmental tolerance of the prepared film, a crucial factor in postprocessing and device durability. Beyond that, the demand for single-crystal TMDs is particularly high in some symmetry-sensitive applications such as valleytronics, nonlinear optics, and polarization detection. Therefore, epitaxial growth of large-area single-crystal TMDs becomes a primary target in envisioning the future roadmap of 2D semiconductor technology. To date, two primary strategies are employed for the epitaxy of large-area single-crystal TMDs: (i) single nucleation growth, involving the evolution of an individual single nucleus into a large-size domain; (ii) multinucleation strategy, which seamlessly stitches together different unidirectionally aligned domains. In the following discussion, we will explore the efforts in single-crystal TMD epitaxy aligned with these two strategies.

4.1. Single-Nucleation Strategy

Similar to the preparation of single-crystal silicon ingots, the most straightforward approach to obtaining single-crystal TMDs involves initiating growth from a single nucleus and expanding it into a large-area film (Figure 12a). This strategy works efficiently in the synthesis of single-crystal graphene up to inch-size.⁵¹⁹ As for the fabrication of TMDs, this single-nucleation strategy is hampered by the multielement requirements and excess nuclei at active sites. The typical domain size is limited to hundreds of nanometers to tens of micrometers, and the stitched domains always lead to the formation of grain boundaries. To provide adequate space for nucleus expansion, the nucleation density should be efficiently suppressed, potentially limited to only one single nucleus during the growth process. Meanwhile, growth promotion should be addressed to guarantee efficient feeding for each nucleus, as discussed in the previous sections. Here, we mainly focus on the nucleation density control toward a pristine large-area TMD single crystal.

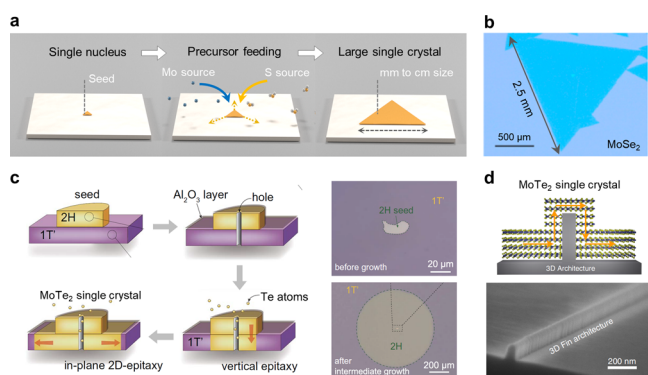


Figure 12. Large-area single-crystal TMDs prepared by a single-domain growth strategy. (a) Schematic illustration of the single-domain growth strategy starting from the feeding of a single nucleus to the eventual formation of a large-sized TMD crystal. (b) As-synthesized triangular monolayer MoSe₂ crystal on a molten glass substrate with size ~2.5 mm. Reprinted with permission from ref 416. Copyright 2017 American Chemical Society. (c) Seeded 2D epitaxy growth of single-crystal 2H-MoTe₂ driven by phase transition. Reprinted with permission from ref 533. Copyright 2021 AAAS. (d) Heteroepitaxial growth of single-crystal 2H-MoTe₂ film on 3D fin architectures. Reprinted with permission from ref 536. Copyright 2022 Springer Nature.

By adjusting the basic parameters such as the amount of precursor, growth temperature, and flow rate, the nucleation density of TMD domains can be significantly suppressed.^{467,520–523} Gong et al. fine-tuned the flow rate of carrier gas and reduced the nucleation density of MoSe₂ from 10⁵ to 25 nuclei per square centimeter.⁵²⁴ The millimeter-scale MoSe₂ single crystals, visible to the naked eye, can be obtained on the SiO₂/Si substrate. Furthermore, the etching effect introduced by oxygen can reduce the nucleation density, leading to large-size single-crystal domains by etching away unstable nuclei from the substrate.⁵²⁵ Xin et al. developed an alternate growth-etching method to obtain submillimeter-scale monolayer single-crystal WS₂.⁵²⁶ Periodic etching stages were introduced during the growth, making the smaller domains etched away and therefore decreasing the nucleation density. Chang et al. proposed a novel self-capping vapor–solid reaction technique for the growth of large-area MoS₂ thin films. In this process, an intermediate liquid phase precursor is formed by the reaction of MoO₃ and NaF, and this precursor subsequently undergoes sulfurization to MoS₂ on the substrate.⁵²⁷ The initially formed MoS₂ seeds acted as a capping layer that reduced the nucleation density and facilitated the lateral growth, leading to the formation of large single-crystal MoS₂ up to ~1.1 mm. The VLS growth of TMDs in a confined space is also demonstrated to enhance the domain size up to millimeter size.⁵²⁸ The mechanism lies in the reduced nucleation density by restricting the supply area of organosulfur to the metal salt source. Chen et al. reported the growth of triangular monolayer MoSe₂ domains with sizes up to ~2.5 mm on the molten glass substrate (Figure 12b).⁴¹⁶ The glass melted above 750 °C allowed a quasi-atomic smooth liquid surface that suppressed the nucleation event, thereby facilitating the growth of ultralarge MoSe₂ crystals.

In a specific scenario, the phase transition from 1T′-MoTe₂ to 2H-MoTe₂ can drive the single-domain growth of a large-area single crystal.^{529,530} The energy difference between 1T′-MoTe₂ and the stable 2H phase is relatively small, at approximately 40 meV/f.u.⁵³¹ In practice, a deficiency of Te

atoms (>2%) asserts the stabilization of 1T′ phase, which can further recrystallize to 2H single crystal by feeding excessive Te source. Polycrystalline 1T′-MoTe₂ can be obtained via the tellurization of deposited Mo thin films, followed by annealing in a Te-rich atmosphere. This process induces the formation of a nucleus, which subsequently expands outward to create a large-sized single-crystal domain. Xu et al. modulated the kinetic rates of nucleation and crystal growth, and successfully synthesized a 2H-MoTe₂ single-crystal domain with a diameter as large as 2.34 mm.⁵³² Further stitching of multiple domains still remained grain boundaries in the full coverage film. Subsequently, as shown in Figure 12c, by dry transferring an exfoliated 2H-MoTe₂ flake on 1T film, which then serves as the “seed” to trigger the phase transition of 1T phase to 2H one, with a deposited Al₂O₃ layer preventing the natural nucleation. Te atoms were only introduced from the probe-punched hole at the seeded region and enabled the fabrication of 1-in. single crystal 2H-MoTe₂ from one nucleus.⁵³³ This phase transition driven in-plane 2D epitaxy is substrate insensitive, which facilitates the homogeneous integration (rapid epitaxy in stacking direction or direct multilayer growth⁵³⁴) and heterogeneous integrations.⁵³⁵ In this regard, Pan et al. demonstrated the universal epitaxy of single crystal 2H-MoTe₂ on arbitrary substrates (silicon, GaN, 4H-SiC, sapphire) without considering their crystal symmetry, lattice mismatch, and even the surface geometry. As shown in Figure 12d, they realized the heteroepitaxy of the 2D single-crystal domain across the 3D fin architectures, which fully unveiled the integration capability of this phase transition method.⁵³⁶

To date, the lateral size of single TMD domain has reached a millimeter size or larger via various innovative designs.⁵³⁷ Despite there is still a gap in single crystal size and fabrication scalability compared with the multinucleation strategy (as discussed in the subsequent section), the single domain strategy is still steadily pursued due to its superior crystallinity, which avoids any imperfectly stitching-induced grain boundaries.

4.2. Multinucleation Strategy

Another proposed strategy for single-crystal TMDs is stitching unidirectional islands into a large-area film. This efficient and scalable strategy relies on the epitaxial technique, that is, the deposited monolayer is well-aligned with the specific orientations on a crystalline substrate. It is well-known that traditional epitaxial growth of 3D film on a 3D substrate requires strict lattice matching (both in lattice constant and lattice symmetry), otherwise the interfacial misfit dislocations would hinder the high-quality epitaxy. Fortunately, as 2D materials are free of dangling bonds, TMDs allow for relaxed conditions concerning lattice constants due to the existence of a vdW gap at the interface during epitaxial growth. Surface symmetry has become the dominant factor in this growth system. The as-grown TMDs islands will be “pinned” and aligned with energetically preferred orientations, resembling the process of stacking a Lego brick onto the surface of another larger Lego brick. In this regard, Dong et al. proposed a theoretical guideline in the epitaxy of directional 2D materials on a crystalline substrate.⁵³⁸ Specifically, the number of equivalent but different directions of a 2D material can be calculated as

$$N_1 = \frac{|G_{\text{sub}}|}{|G_{2\text{D}@\text{sub}}|}$$

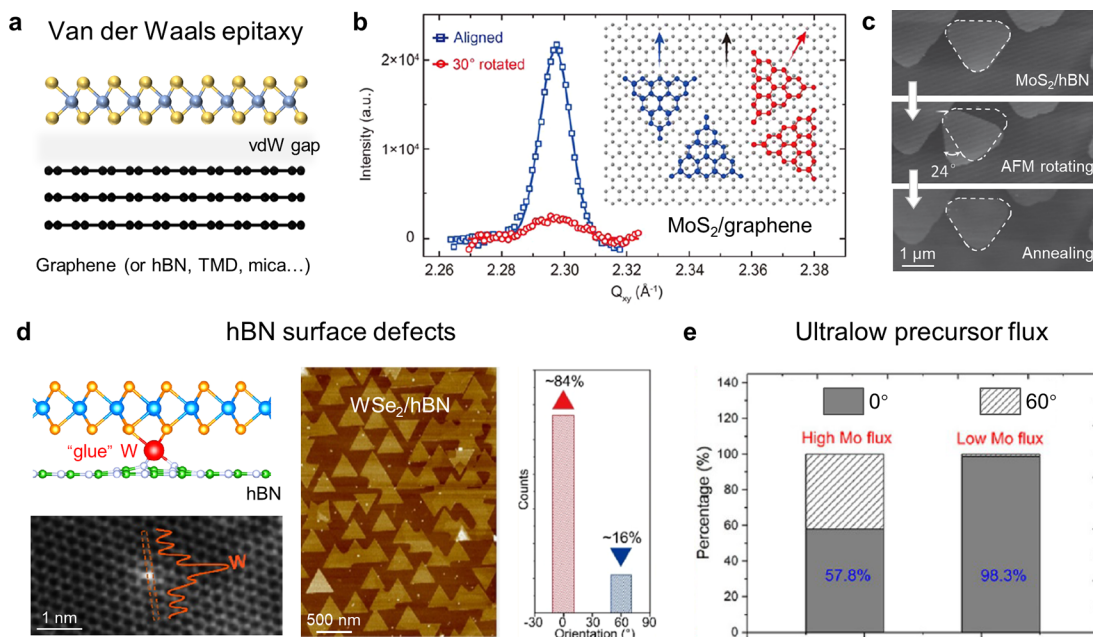


Figure 13. vdW epitaxy growth of TMDs on dangling-bond-free substrates. (a) Schematic illustration of the epitaxial growth of TMDs on vdW materials. (b) GIWAXS data of the MoS₂(010) peak taken along the aligned growth (blue) and the 30° rotated growth (red), Inset, the schematic of the two growth orientations of MoS₂ on graphene. Reprinted with permission from ref 552. Copyright 2016 American Chemical Society. (c) The stable state of MoS₂ on hBN demonstrated by the AFM tip manipulation technique. Reprinted with permission from ref 564. Copyright 2017 Wiley-VCH Verlag GmbH & Co. KGaA, Weinheim. (d) Unidirectional growth of WSe₂ on defective hBN substrate. The single-atom vacancies on the hBN surface trap W atoms and break surface symmetry. Reprinted with permission from ref 567. Copyright 2019 American Chemical Society. (e) Histogram of the percentage of MoS₂ grains growth by MBE with various orientations under different Mo flux. Reprinted with permission from ref 569. Copyright 2017 American Chemical Society.

where G_{sub} and $G_{2\text{D}@\text{sub}}$ are symmetry groups of the substrate and the 2D material-substrate system, respectively. For the epitaxial growth of TMDs with D_{3h} symmetry, the C_{1v} , C_{2v} , C_{3v} , and C_{6v} symmetric substrates would lead to 1, 2, 1, and 2 types of equivalent directions, respectively. In other words, unidirectional TMD islands can be accessed via the substrates in the surface symmetry group is a subgroup of D_{3h} . Therefore, substrate engineering is the key to the epitaxial growth of large-area single-crystal TMDs. In this chapter, we will first review the epitaxial growth of TMDs on vdW substrate in Section 4.2.1, a “flatland” that dominates the island direction mainly by lattice symmetry. Then we turn to the 3D textured crystalline substrates with “terrace” reconstructed by metal (Section 4.2.2) and insulating substrates (Section 4.2.3).

4.2.1. Epitaxy on vdW Materials. vdW epitaxial growth was first achieved by Koma et al. via growing ultrathin selenium film on cleaved tellurium surfaces and ultrathin NbSe₂ film on cleaved MoS₂ surfaces.⁵³⁹ Remarkably, an accommodatable lattice mismatch of even 50% for vdW epitaxy enables it a powerful technique in the field of film epitaxy.^{540,541} When it comes to the epitaxy growth of large-area TMD materials, 2D vdW materials like graphene and hBN (Figure 13a) naturally appear as ideal substrates for several reasons: (i) The as-growth TMDs coupled with these dangling-bond-free substrates via the vdW force and additional growth-induced strain can be alleviated in the vdW gap.⁵⁴² (ii) The bottom-up synthesis of large-area single-crystal graphene and hBN have been realized earlier, offering a high-quality platform for TMDs epitaxial growth. (iii) The extensive 2D material family encompasses numerous categories together with rich surface symmetries and chemical properties. This

diversity enables the selection of suitable substrates for the critical single-crystal TMDs epitaxy.

Chemically inert epitaxial graphene layers have emerged as proper templates due to their scalable synthesis and transfer techniques. In 2012, Shi et al. directly prepared high-quality MoS₂ flakes on the CVD graphene/Cu substrate by thermally decomposing a low dose of (NH₄)₂MoS₄ precursor at 400 °C.⁵⁴³ Besides, leaving the easily sulfurized Cu foil by transferring the graphene layer elsewhere or directly preparing the graphene/SiC substrate further enables high-temperature TMD growth strategies.^{544–548} In general, during the vdW epitaxy, the TMD materials with D_{3h} symmetry growth on C_{6v} symmetry graphene (or the surface of graphite) would result in two preferred orientations.^{549–551} As shown in Figure 13b, Liu et al. demonstrated the rotational commensurability in CVD-MoS₂ and epitaxial graphene, which was driven by the energetically favorable alignment in spite of the existence of ~28% lattice mismatch.⁵⁵² Besides, the epitaxy behavior of TMDs on graphene has been systemically studied, revealing that various factors including grain boundaries, dislocations, layer number, and stacking order of the graphene layers significantly affect TMD growth.^{553–556} Although high-symmetric graphene seems not to be the optimal substrate for single-crystal TMDs growth, this direct synthesis route can produce heterostructures with a clean interface and some degree of lattice alignment.^{557,558} Hoang et al. reported the low-temperature epitaxial growth of highly orientated MoS₂ on a 4-in. wafer-size graphene/sapphire substrate, leading to the construction of MoS₂/graphene heterostructures with ultra-high photoresponsivity.⁵⁵⁹

Electrically insulating hBN layers have proven to be a superior alternative for the epitaxy growth of TMDs. The

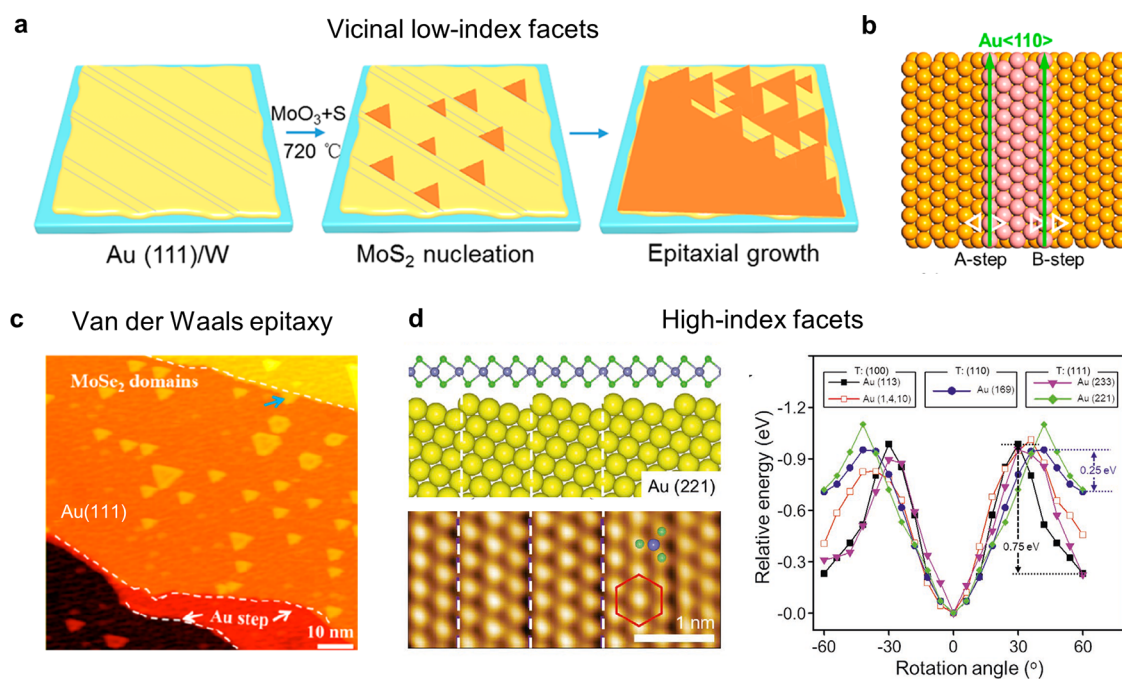


Figure 14. Large-area epitaxy growth of single-crystal TMDs on metal substrates. (a) Schematic illustration of epitaxy growth of centimeter-scale MoS₂ on vicinal low-index Au(111) substrate. (b) Two typical step edges (A-step and B-step) along the <110> direction of the vicinal Au(111) surface. (a,b) Reprinted with permission from ref 33. Copyright 2020 American Chemical Society. (c) STM image of MoSe₂ domains on the Au(111) grown by MBE. Reprinted with permission from ref 597. Copyright 2022 American Chemical Society. (d) Structural model and STM image of a WS₂ film grown on a high-index Au (221) substrate (left panel). Relative binding energies of a W₃S₆ cluster on different atomic sawtooth Au surfaces as a function of rotation angle (right panel). Reprinted with permission from ref 599. Copyright 2021 Wiley-VCH Verlag GmbH & Co. KGaA, Weinheim.

reasons lie in that (i) the atomically flat surface and outstanding dielectric properties of hBN make it efficiently suppress the extrinsic scattering from charged impurities compared with oxide substrates;^{560,561} and (ii) in theory, the diatomic hBN with inversion symmetry broken naturally has the potential to relieve the energy degeneracy of the as-grown twinned TMD domains. In 2014, Okada et al. achieved the direct synthesis of WS₂ on exfoliated hBN flakes, the results indicated that the triangular WS₂ domains were crystalline into two dominant orientations.⁵⁶² Similar growth behavior has also been reported in subsequent studies. For instance, Yan et al. observed the aligned growth of MoS₂ on hBN with rotation angles of less than 5 degrees.⁵⁶³ Yu et al. found the twinned CVD MoS₂ triangular (0° and 60°) epitaxy on hBN occurred with a ratio of nearly 1:1.⁵⁶⁴ And the artificially rotated as-grown domains could rotate back to the initial states after annealing due to the superlubricating MoS₂-h-BN interface (Figure 13c).

Indeed, the orientational preference of twinned TMD structures is still nearly degeneracy although using the inversion asymmetric hBN substrate, and a more controllable epitaxy strategy is required for realizing the large-area single crystal growth.^{565,566} In this regard, Zhang et al. identified the point defects (e.g., B vacancies) in the hBN substrate could enhance the orientational epitaxy of TMD materials and obtained ~90% MoS₂ flakes with the same orientation (Figure 13d). Moreover, Zhang et al. employed plasma treatment to introduce defects in hBN, and a 95% major WSe₂ orientation could be achieved during the nucleation window of MOCVD growth.⁵⁶⁷ The mechanism stemmed from the vacancies of hBN which traps the W atoms and further breaks the surface symmetry.⁵⁶⁸ Besides, Fu et al. adopted a high growth

temperature and ultralow precursor flux to reduce the twinned domains (only ~1.3% antialigned grains) during the MBE growth of MoS₂ on the hBN substrate (Figure 13e).⁵⁶⁹ The success in synthesizing large-area hBN layers further fuels the epitaxial growth of large-area TMDs. Steady progress has been achieved by preparing the desired hBN substrate such as transferring it from the Cu foils or directly depositing it on sulfide-resistant surfaces such as Au foil,⁵⁷⁰ Ni–Ga alloy,⁵⁷¹ and sapphire,^{572,573} then follows the epitaxial growth of TMD materials. Lee et al. synthesized the large-area single-crystal WS₂ film (aligned orientations within ±1.33°) using the single crystalline hBN/Au substrate, where the hBN film was substituted or etched away during the growth of the WS₂ film.⁵⁷⁴

Obviously, the dangling-bond-free TMD material could also work as a vdW epitaxial substrate and form vertical or lateral heterostructures^{575–578} (e.g., MoS₂/WS₂ and MoS₂/WSe₂). Surface-inert mica with an atomically flat surface such as fluorophlogopite mica (KMg₃AlSi₃O₁₀F₂) is also considered an excellent substrate for vdW epitaxy.^{82,579–581} Its in-plane hexagonal lattice matches with TMD materials and can be cleaved into a transparent and flexible thin sheet for further device fabrication. Distinguished from the twinned growth manner of TMDs, Wang et al. realized the epitaxial growth of unidirectional transition-metal oxide nanosheets on mica,⁵⁸² which inspired the single crystal epitaxy of other similar materials on this substrate.

Nearly immune to the dangling bonds and textures of conventional 3D substrates, vdW epitaxy on atomically flat substrates could provide large-area TMDs with more uniform and intrinsic properties. Nevertheless, this also indicates there are still limited methods that can be introduced to break the

energy degeneracy of antiparallel growth orientations. In the future, more universal, reliable and powerful growth strategies should be proposed in this attractive system to realize robust growth of large-area TMD single crystals.

4.2.2. Epitaxy on Metal Substrates. Single-crystal metal foils with various facets provide rich surface structures and serve as a substrate library for the epitaxial growth of 2D materials. Notably, face-centered cubic (fcc) metals like Cu, Ni, and Au can be acquired as single crystals with large areas from centimeters to even meters.⁵⁸³ This is achieved by thermodynamically transforming commercial polycrystalline foils into low-index facets ($\{100\}$, $\{110\}$ and $\{111\}$) through an appropriate annealing process. Single-crystal graphene is already accessible through epitaxial growth on single-crystal Cu(111) foil with a size of up to 0.5 m.⁵⁸⁴ However, when dealing with diatomic materials with broken inversion symmetry, such as hBN and TMDs (with C_{3v} and D_{3h} symmetry, respectively), the use of perfect high-symmetry facets (such as C_{6v} for $\{111\}$ surface) as templates is no longer suitable due to the formation of twinned crystals. This dilemma was previously addressed in the epitaxy of hBN by utilizing low-symmetry Cu(110) vicinal surface and direct lateral docking hBN to Cu(111) steps.^{585,586} Although there is a similar symmetry between hBN and TMDs, the Cu foil is still not suitable for scalable TMD growth because it is susceptible to sulfurization.

Subsequently, the focus shifted toward employing the chemically inert Au substrates, which also possess an fcc structure, as the alternative epitaxial templates for TMD materials. At the early stage, noble single-crystal Au(111) substrate was unitized as an ideal template for TMDs islands growth under ultrahigh vacuum conditions, primarily for STM research.^{587,588} In practice, in 2014, Shi et al. selected polycrystalline Au foil as the substrate for large-area TMD growth.^{589,590} This metallic substrate combined with as-grown nanosized MoS₂ flakes exhibited remarkable hydrogen evolution reaction (HER) activity. As discussed in the previous section, the catalytic effect from the Au surface also enhances the grain size and growth rate, through the commercial polycrystalline Au foil leading to the formation of a film composed of randomly oriented TMD domains.^{591,592} In 2016, Zhang et al. demonstrated the twinned growth behavior of ReS₂/WS₂ vertical heterostructure on Au(111), which is indicative of epitaxial growth of large-area orientated TMDs on Au foil.⁵⁹³ Similarly, Lu et al. achieved epitaxial growth of MoSe₂ on Au(111) by MBE, observing domain alignment along two preferred directions.⁵⁹⁴

While the epitaxy manner of TMDs on Au foil shed light on preparing large-area single crystal film by domain stitching, a critical scientific problem arose regarding how to break the energy degeneracy of two preferred orientations when using the Au(111) substrate with C_{6v} symmetry of top layer atoms.⁵⁹⁵ In 2020, Yang et al. realized the fabrication of $\sim 3 \times 3$ cm single-crystal MoS₂ film on vicinal Au(111) substrate (Figure 14a).³³ Insight STM characterizations and density functional theory (DFT) calculations suggested the presence of steps along the Au $\langle 110 \rangle$ direction played a crucial role in breaking the symmetry of the antiparallel orientations. The mechanism hinges on that, for both A- and B-steps (two types of steps along the Au $\langle 110 \rangle$, Figure 14b), the Mo-zz edge docking acts as the minimum energy configuration compared to other possibilities (such as S-zz or AC docking). In this regard, an energy difference of 0.16 eV/f.u. between Mo-zz/A-

step and Mo-zz/B-step favored the latter, driving the epitaxial growth of MoS₂ domains in that direction. The single crystal substrate was prepared by melting and resolidifying commercial Au foils on W foils, which reduced the substrate cost and enabled the large-size film growth. Moreover, Li et al. sputtered a 600 nm-thick Au onto a 2-in. sapphire substrate and annealed it into the desired (111) facet.⁵⁹⁶ This wafer-size flat substrate enabled the fabrication of the 2-in. MoS₂ film with over 99% unidirectional ratio by carefully controlling the growth temperature. Ding et al. investigated the epitaxial mechanism of TMD growth on Au(111) via cross-sectional STEM,⁵⁹⁷ which revealed that $\sim 90\%$ of TMDs seeds nucleated on the surface terraces rather than on surface steps, yet they still exhibited the unidirectional growth manner (Figure 14c). In other words, the Au(111) surface-guided vdW epitaxy could directly lead to the growth of single-crystal TMDs. The surface steps further determined the thickness and integrity of the TMDs film. Based on this mechanism, Xia et al. successfully prepared wafer-scale MoSe₂ and WSe₂ single-crystal on Au(111) substrate at low temperatures (200–400 °C) by the MBE method.⁵⁹⁸

The extensive library of high-index Au facets with low surface symmetry provides a versatile platform for the universal growth of single-crystal TMDs. Choi et al. demonstrated the resolidified Au foil could randomly produce high-index facets such as (5,7,11), (169), and (114).⁵⁹⁹ These “sawtooth” surfaces as shown in Figure 14d (left panel) featured periodic step edges and low-index terraces including (111), (110), and (100). Remarkably, centimeter-sized single-crystal WS₂, WSe₂, MoS₂, MoSe₂/WSe₂ heterostructure and W_{1-x}Mo_xS₂ alloy were universally prepared on these sawtooth surfaces, regardless of specific Miller indices (Figure 14d, right panel). The underlying mechanism is explained as the presence of energetically favorable adsorption sites at periodic sawtooth gullet step edges, which guided the unidirectional growth of TMD domains. Additionally, some low-symmetry high-index facets vicinal to low-index surfaces also facilitate the robust growth of single-crystal TMDs. For instance, Hu et al. reported the epitaxial growth of single-crystal MoS₂ aligned with the high-symmetric directions of the 2-fold symmetry vicinal Au(101) surface (e.g., (627), (839), (10,1,12)).⁶⁰⁰ Such a symmetry-mismatched epitaxy further supports the notion of a step-edge-guiding effect during the unidirectional TMD domain growth.

In addition to surface symmetry engineering, the growth parameters can also dominate the epitaxial growth of TMDs on metal substrates. First, a higher heating temperature favors the formation of unidirectional islands. This can be explained as that, although the designed surface structures break the energy degeneracy of two favorable twinned directions, an energy barrier still needs to be overcome to rotate one metastable direction into another. Therefore, sufficient thermal energy is required to facilitate this process during the nucleation stage. Second, the appropriate precursor flux ratio plays a vital role in the epitaxial growth of TMDs. In general, a higher chalcogen/metal ratio is more favorable for the preparation of single-crystal TMD films. For example, the proportion of 0 and 60° oriented MoS₂ domains on Au(111) was tuned from ~ 49 to 98% by changing the S/MoO₃ ratio from $\sim 2:1$ to 3:1. Besides, Yang et al. controlled a specific Mo/S ratio of 2:1 to design the morphology of MoS₂ into aligned ribbons on high-index Au facets vicinal to Au(111).⁶⁰¹ By extending the growth time,

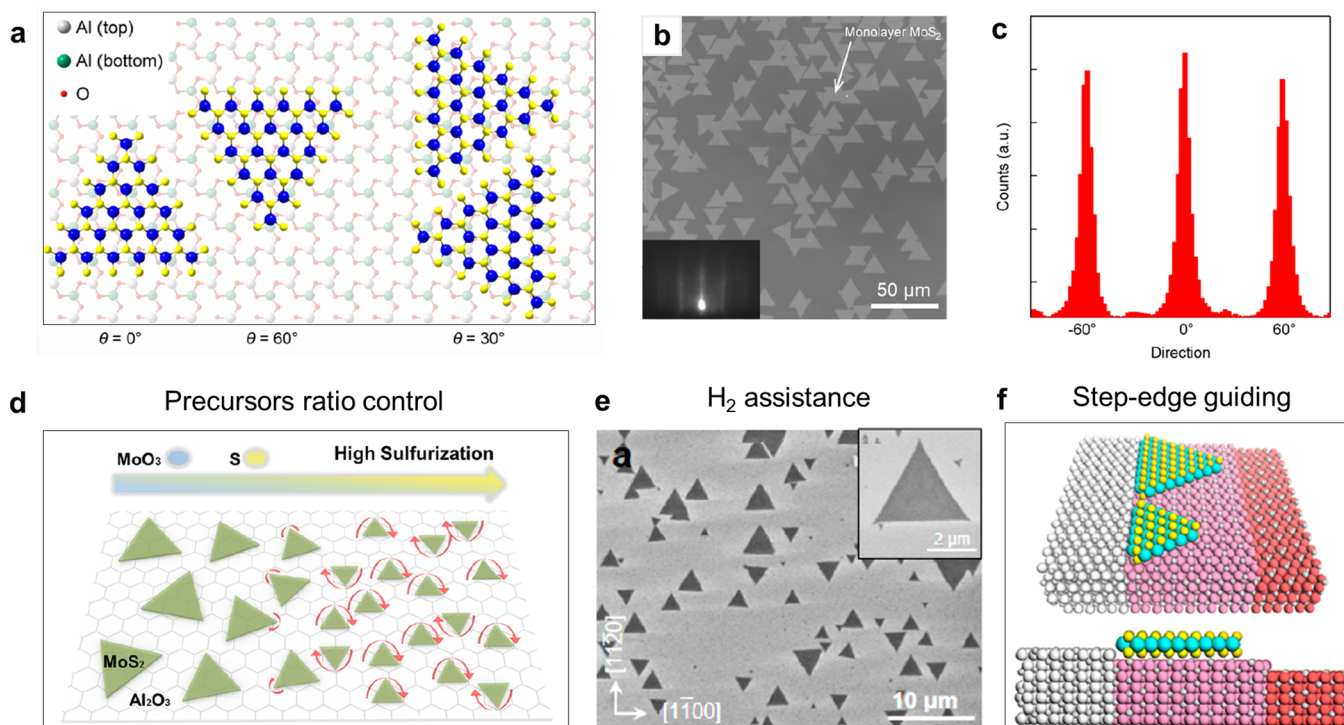


Figure 15. Large-area epitaxy growth of TMDs on sapphire substrates. (a) Schematic illustration of relative lattice orientations between monolayer MoS₂ and c-plane sapphire (b) Optical image of monolayer MoS₂ grains grown on atomically smooth annealed sapphire, inset, RHEED pattern acquired on the as-grown sample. (c) Orientation histogram based on the area shown in part (b) exhibits that the majority of MoS₂ grains are oriented along 0° and ±60°. (a–c) Reprinted with permission from ref 605. Copyright 2015 American Chemical Society. (d) Schematic illustration of the ratio between sulfur and molybdenum oxide controlling the orientation of MoS₂ islands on sapphire. Reprinted with permission from ref 606. Copyright 2017 American Chemical Society. (e) SEM images of as-grown aligned WS₂ islands on sapphire with the assistance of H₂. Reprinted with permission from ref 609. Copyright 2018 American Chemical Society. (f) Schematic illustration of the step-edge guided aligned nucleation of WS₂ on c-plane sapphire. Reprinted with permission from ref 619. Copyright 2015 American Chemical Society.

these unidirectional monolayer TMD ribbons could be stitched together into an inch-sized continuous single crystal.

Overall, chemically inert metal with rich surface structures have demonstrated their excellent capability in producing inch-sized single-crystal monolayer TMDs. These metallic substrates also bring convenience in the electrochemical bubbling transferring of the film to arbitrary substrates. Meanwhile, versatile characterizations that require substrate conductivity such as LEED and STM, could be directly carried out to investigate the material quality and epitaxial behavior. However, this poses challenges for electronic device fabrication directly on the as-grown metal substrate without subsequent transfer. Looking ahead, several promising research directions include (i) the reliable and industry-compatible fabrication of large-area single-crystal substrates with specific facets and (ii) an in-depth understanding of the epitaxy mechanism, especially regarding the step- and surface-guided effect. These insights will not only advance our fundamental understanding but also enable the robust production of single-crystal TMDs.

4.2.3. Epitaxy on Insulating Substrates. Thermal stable sapphire (α -Al₂O₃) substrate is commercially used in the III–V semiconductor epitaxy for light-emitting diodes (LEDs) manufacturing.⁶⁰² After decades of development, its low-cost production and mature processing techniques provide sufficient freedom in designing suitable surfaces for the oriented growth of nanomaterials. Sapphire is also considered an ideal mate with TMDs due to several reasons: (i) its insulating and transparent nature facilitates the further fabrication of electronics and optoelectronic devices; (ii) the

negligible reaction with chalcogen atoms and the hexagonal symmetry of the sapphire substrate enables the high-temperature epitaxy growth of directional TMD islands; (iii) single-crystalline sapphire wafers sliced from an ingot provide rich choices in substrate sizes (ranging from 1 to 12 in.) and crystallographic planes (c, a, m, r, v planes along with desired miscut angles). Over the past decade, electronic-grade wafer-scale TMD single crystals have been successfully synthesized on designed sapphire substrates. Sapphire has become one of the most promising epitaxial substrates for TMD semiconductors toward industrialization. In this section, we will review the journey of the epitaxial growth of TMDs on sapphire from random orientation to bicrystalline structures, and further to single crystalline.

In practice, the TMD islands sometimes grow randomly (nonepitaxially) on the as-received sapphire substrate rather than aligning as desired.⁶⁰³ Considerable efforts have been devoted to regularizing them into oriented epitaxial growth manner. In 2014, Ji et al. analyzed the orientation distribution of the MoS₂ domain growth on the commonly used c-plane (0001) sapphire, identifying there were two preferred directions along with misaligned species.⁶⁰⁴ Subsequently, Dumcenco et al. indicated that a high-temperature (1000 °C) preannealing of the sapphire substrates could produce atomically smooth terraces, facilitating the oriented growth of MoS₂.⁶⁰⁵ As shown in Figure 15a–c, 91.5% of domains aligned well with 0° and ±60°, while a small fraction (6%) exhibited orientations of ±30°. During the nucleation window, small clusters could rotate or slide along the surface until they

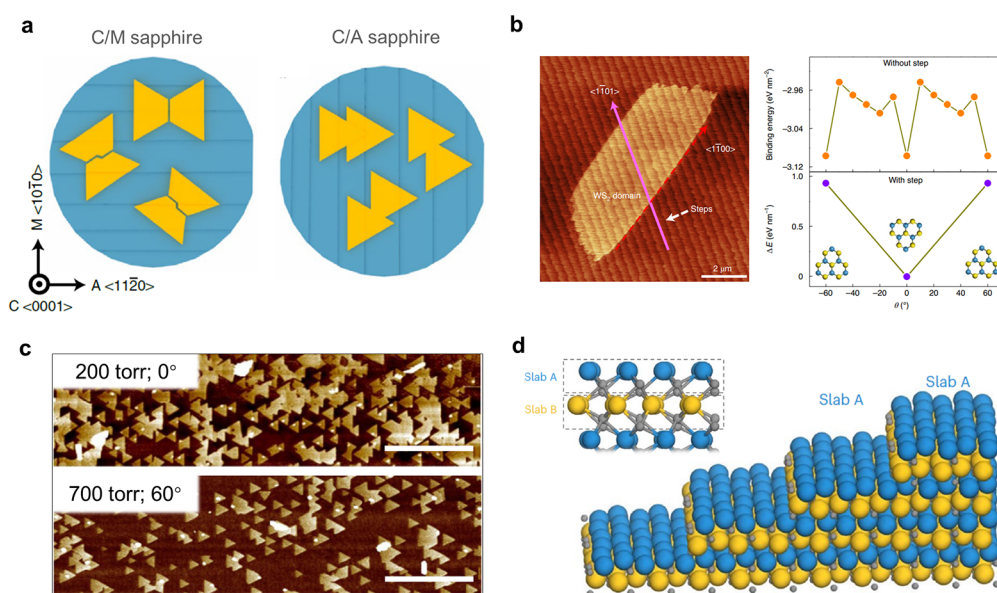


Figure 16. Large-area epitaxy growth of single-crystal TMDs on sapphire substrates. (a) Step orientations on C/M and C/A sapphire wafers and the corresponding epitaxial MoS₂ domain alignment. Reprinted with permission from ref 34. Copyright 2021 Springer Nature. (b) AFM image of a WS₂ island growth on a-plane sapphire (left panel) and DFT calculations of the binding energies of the WS₂ island with different rotation angles on the a-plane sapphire surface (right panel). Reprinted with permission from ref 35. Copyright 2021 Springer Nature. (c) AFM images WS₂ domains grown on c-plane sapphire at 200 Torr (top panel) and 700 Torr (bottom panel), showing the preferred orientations of 0° and 60°, respectively. Reprinted with permission from ref 629. Copyright 2023 Springer Nature. (d) Atomic structure of c-plane sapphire with single-type terraces whose step height is equivalent to two slabs, insert, the A and B slab stack alternately exhibits a mirror-symmetric arrangement. Reprinted with permission from ref 632. Copyright 2023 Springer Nature.

are eventually anchored in the most stable orientation upon reaching a certain size. This substrate pretreatment technique has been widely adopted in subsequent studies. Furthermore, critical growth parameters such as temperature, the chalcogen-to-metal source ratio, and hydrogen flow have been systematically investigated to ensure the aligned arrangement of TMDs on sapphire substrates. Yu et al. employed a much higher growth temperature of 930 °C to obtain thermally stable 0° and 60° domains on annealed sapphire, which was finally stitched into 2-in. highly oriented MoS₂ film.⁴⁷⁷ However, a lower growth temperature below 820 °C would result in misorientations due to insufficient thermal energy for TMD nuclei to rotate or slide into the most stable configurations. Aljarb et al. explored the impact of the S/Mo source ratio on the orientation control of MoS₂ on sapphire, indicating that the S-rich environment during nucleation would promote the 0°/60° oriented growth (Figure 15d).⁶⁰⁶ Suenaga et al. further demonstrated the MoS₂ grain alignment could be tuned between 0°/60° (edge parallel to [1100]) and ±30° (edge normal to [1100]) by changing the sulfur supply.⁶⁰⁷ A similar behavior was also observed by Lai et al. while introducing an appropriate oxygen flow.⁶⁰⁸

Surface structures of sapphire, such as termination type, passivating layer, reconstructed step, and crystalline plane, directly dominate the growth behavior of TMDs. Ji et al. introduced a high concentration (more than 40%) of H₂ gas during the growth process, leading to the formation of Al-rich sapphire surface.⁶⁰⁹ This surface is more strongly coupled with WS₂ compared to the O-rich surface, and can effectively suppress the randomly oriented grains (Figure 15e). Similarly, Park et al. showed that a high growth temperature could convert the sapphire surface from OH-termination to half-Al termination, and further promoted the epitaxial growth of MoS₂.⁶¹⁰ A passivation layer between 3D sapphire and 2D

TMDs is also observed during the oriented growth, which is considered as a “quasi” vdW epitaxy system proposed by Koma et al. in 1989.^{611,612} For instance, Lin et al. revealed the existence of a Se-rich layer at the WSe₂/sapphire interface during the MOCVD epitaxial growth.⁵¹³ Cohen et al. found an ordered WO₃ interface layer at the sapphire surface, which played a key role in the oriented quasi-vdW epitaxial growth of WS₂.⁶¹³ In addition to the above widely used c-plane sapphire, Ma et al. carried out the epitaxial growth of MoS₂ on a-plane (1120) sapphire and obtained rectangle domains aligned to the [1100] direction.⁶¹⁴

These explorations in reaction condition and substrate engineering have guaranteed the robust oriented epitaxial growth of TMDs on sapphire, and significantly inspired chemists and physicists to further pursue the breaking of the energy degeneracy toward single-crystal films. A key step in achieving large-area single-crystal is designing a lower symmetry sapphire template (such as C_{3v}, C₁, and C_s), which thermodynamically suppresses twinned islands. The most proposed strategies involve utilizing atomic step and surface symmetry.

The atomic steps originate from the vicinal sapphire surface, a crystalline surface miscut slightly deviated from a low-index plane.⁶¹⁵ A proper annealing process could reconstruct this surface into the sawtoothed structure with periodical step edges and flat terraces. For example, commercial c-plane sapphire wafers are always prepared by miscutting ~0.2° toward M-axis (1100) (defined as C/M)⁶¹⁶ after annealing at ~1,000 °C, which always leads to the formation of terraces with ~50–70 nm width and step height of 0.22 nm (*c*/6, *c* is the lattice constant of α-Al₂O₃) along the <1120> direction.⁶⁰⁵ These periodical nanostructures on sapphire have been widely used in the anisotropic growth of 1D nanotubes and nanowires over the past decade.^{617,618} As for the epitaxial growth of

Table 1. Summary of Epitaxial Growth of Large-Area Single-Crystal TMDs

| Substrate | Strategy | Growth technique | Materials | Size | Performance | | Ref |
|---|-----------------------------|------------------|---|-----------------------|---|----------------------------------|-----|
| | | | | | Mobility (cm ² V ⁻¹ s ⁻¹) | On/off ratio | |
| hBN | Low precursor flux | MBE | MoS ₂ | 2-in. | 23.2 ± 0.2 | ~10 ⁶ | 632 |
| hBN | Defects assistance | MOCVD | WSe ₂ | — | 4.2 | — | 632 |
| Au(111) | Step-edge guiding | CVD | MoS ₂ | 1-in. | 11.2 | 7.7 × 10 ⁵ | 33 |
| Sawtooth Au surface | Step-edge guiding | CVD | WS ₂ (WSe ₂ , MoS ₂ , MoSe ₂ /WSe ₂ , W _{1-x} Mo _x S ₂ alloy) | cm scale | ~3 | ~10 ⁸ | 599 |
| Au(111) | Temperature guiding | CVD | MoS ₂ | 2-in. | — | — | 596 |
| Au(111) vicinal facets | Step-edge guiding | CVD | MoS ₂ (WS ₂ , MoSe ₂ , WSe ₂ , MoS _x Se _{2-x}) | 1-in. | 7–11 | 10 ⁵ –10 ⁶ | 601 |
| Au(101), Au(001), Au(111) vicinal facets | Step-edge guiding | CVD | MoS ₂ | mm scale | 6.6–11.7 | 1.0–3.7 × 10 ⁷ | 600 |
| Au(111) | Enhanced Au/TMD interaction | MBE | MoSe ₂ , WSe ₂ | 2-in. | — | — | 598 |
| c-plane sapphire | Step-edge guiding | MOCVD | WS ₂ | 2-in. | 16 | ~10 ⁷ | 621 |
| a-plane sapphire | Dual-coupling guiding | CVD | WS ₂ | 2-in. | 0.8–1.6 | — | 35 |
| a, c, m, n, r, and v-plane sapphire, MgO and TiO ₂ | Time sequence control | CVD | MoS ₂ (WS ₂ , NbS ₂ , MoSe ₂ , WSe ₂ , NbSe ₂) | — | ~38 | ~10 ⁸ | 627 |
| c/a-plane sapphire | Step-edge guiding | CVD | MoS ₂ | 2-in. | 77.6 | ~10 ⁹ | 34 |
| c/a-plane sapphire | Step-edge guiding | CVD | MoSe ₂ | 2-in. | — | — | 625 |
| c-plane sapphire | Surface termination control | CVD | MoS ₂ | cm scale | — | — | 610 |
| c-plane sapphire | Step-edge guiding | CVD | Fe-doped MoS ₂ | 2-in. | ~54 | ~10 ⁸ | 622 |
| c-plane sapphire | Step-edge guiding | CVD | Fe-doped MoS ₂ | 4-in. | ~100 | ~10 ⁹ | 623 |
| c-plane sapphire | Decoration layer control | CVD | MoS ₂ | 2 × 1 cm ² | 12 | 10 ⁷ –10 ⁸ | 624 |
| c/a-plane sapphire | Step-edge guiding | CVD | MoS ₂ | 2-in. × 7 | ~44 | ~10 ⁷ | 371 |
| c-plane sapphire | Sapphire/TMD interaction | CVD | MoS ₂ | 2-in. | 30.7 | 1–4 × 10 ⁷ | 632 |
| c-plane sapphire | Step-edge guiding | MOCVD | WSe ₂ | 2-in. | ~0.4 | ~10 ⁶ | 629 |
| c-plane sapphire | Buffer layer control | CVD | MoS ₂ | 2-in. | ~140 | 10 ⁹ | 631 |

TMDs, in 2015, Chen et al. employed the atomic steps on c-plane sapphire to guide the aligned nucleation and growth of WSe₂ (Figure 15f),⁶¹⁹ and Hwang et al. further suggested a controlled introduction of H₂ could promote the step-edge aligned nucleation of MoSe₂ on sapphire.⁶²⁰ This step-guiding effect can directly facilitate the unidirectional growth of TMDs. Chubarov found that maintaining a suitable temperature (850 °C) during the nucleation stage led to aligned steps and corresponding unidirectional WS₂, otherwise, a higher temperature (1000 °C) would distort the steps and misorient TMD islands.⁶²¹ Li et al. reported that introducing Fe significantly reduced the formation energy of periodical steps on sapphire, successfully fabricating a 4-in. Fe-doped MoS₂ single crystal mainly relying on these steps.^{622,623} Chang et al. reported the Fe₂O₃ decoration layers could boost the single-orientated growth of MoS₂ on c-plane sapphire.⁶²⁴

Designing step orientations with careful consideration of the epitaxial relationship between sapphire and TMDs has proven to be an efficient strategy for breaking the energy degeneracy of twined structures. In 2021, Li et al. suggested the R30° epitaxial relationship between c-plane sapphire and as-grown MoS₂, that is, the MoS₂ in-plane lattice vectors ($\langle 11\bar{2}0 \rangle$ direction) have a 30° rotation from the A axis ($\langle 11\bar{2}0 \rangle$) of sapphire.³⁴ Consequently, the $\langle 11\bar{2}0 \rangle$ steps on standard C/M sapphire just go along with the armchair direction of MoS₂ during the epitaxial process, which could not break the energy degeneracy in this configuration (Figure 16a). To address this, they innovatively customized the C/A sapphire substrate for the single crystal MoS₂ growth, wherein the ~1° miscut toward the A-axis ($\langle 11\bar{2}0 \rangle$) could generate atomic steps along $\langle 1\bar{1}00 \rangle$

direction. These steps paralleled the zigzag edge of MoS₂ islands further broke the energy degeneracy and led to a more than 99% unidirectional alignment. This miscut strategy has shown universality and Li et al. subsequently utilized the C/A sapphire to realize the fabrication of the 2-in. sized MoSe₂ single crystal.⁶²⁵ Yang et al. combined the “face-to-face” strategy with C/A sapphire to batch-produce wafer-scale single crystal MoS₂ films.³⁷¹ Moreover, Liu et al. achieved aligned nucleation of bilayer MoS₂ on high-temperature annealed C/A sapphire with critical step height, which will be further discussed in Section 5.1.1.⁶²⁶

The synergy of epitaxial relationship and atomic steps was explained as a “dual-coupling effect” by Wang et al.³⁵ They employed the vicinal a-plane ($11\bar{2}0$) sapphire as an epitaxial template. Initially, the interaction between C₂ symmetry a-plane and D_{3h} symmetry WS₂ resulted in two preferred antiparallel domains (zigzag edges along the $\langle 1\bar{1}00 \rangle$ direction). The coupling between vicinal-cutting induced steps ($\langle 1\bar{1}01 \rangle$ direction) and WS₂ islands further broke the energy degeneracy (Figure 16b), finally enabling the fabrication of 2-in. sized single crystal films. The proposed dual-coupling mechanism appears as a universal strategy for the epitaxy of single-crystal noncentrosymmetric TMDs (MoS₂, WS₂, NbS₂, MoSe₂, WSe₂, and NbSe₂).^{627,628} By precisely controlling of simultaneous formation of grain nuclei and substrate steps, the growth of twined MoS₂ grains could be suppressed due to the existence of steps, regardless of step edge orientations. This unidirectional aligned behavior has been realized on textured insulating substrates including vicinal a($11\bar{2}0$), c(0001),

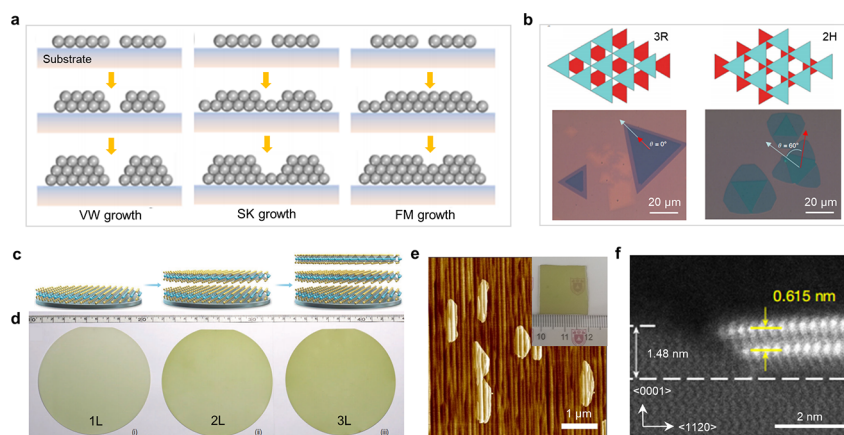


Figure 17. Strategies for the growth of multilayer TMDs. (a) Schematic for the three thin-film growth modes. Reprinted with permission from ref 653. Copyright 2021 American Chemical Society. (b) Reverse-flow CVD growth of AA and AB stacking bilayer MoS₂. Reprinted with permission from ref 656. Copyright 2019 Springer Nature. (c) Schematic diagram of the layer-by-layer epitaxy of wafer-scale multilayer MoS₂ film. (d) Optical images of the as-prepared 1L, 2L, and 3L MoS₂ wafers. (e,f) Reprinted with permission from ref 648. Copyright 2022 Oxford University Press. (e) AFM and Optical images of the uniform nucleation and epitaxy bilayer MoS₂. (f) HAADF-STEM cross-sectional image of bilayer MoS₂ nucleating at the sapphire step edge. (e,f) Reprinted with permission from ref 626. Copyright 2022 Springer Nature.

$m(1\bar{1}00)$, $n(11\bar{2}3)$, $r(1\bar{1}02)$, and $v(22\bar{4}3)$ plane sapphire as well as MgO(100) and TiO₂(110).

In addition to the step-guide effect, the reaction conditions could also dominate the unidirectional growth of TMDs on sapphire. Zhu et al. systematically studied the epitaxial behavior of WSe₂ on c-plane sapphire via MOCVD, focusing on precursor supplement and reactor pressure. Besides the step-assisted nucleation, the surface chemistry of the sapphire (terminal OH removal and Se passivation) could tune the nucleation orientations to either 0° or 60° (Figure 16c).⁶²⁹ And the areal coverage of twin boundaries could be suppressed as <15% over wafer-scale substrates. The importance of surface reconstruction was also demonstrated in the epitaxial growth of MoS₂ on β -Ga₂O₃ (001) substrate, wherein the interfacial layer could be tuned between Mo⁵⁺ and Mo⁴⁺ by precursor concentration, then changed the atomic registry either 0° or 60°.⁶³⁰ Recently, Li et al. reported that a suitable Mo/S precursor ratio led to the formation of a specific interfacial reconstructed layer, which enabled the epitaxial growth of ultrahigh-quality MoS₂ single-crystal on commercial sapphire substrates.⁶³¹

In fact, the atom arrangement of an ideal c-plane sapphire (without steps) naturally possesses the C₃ symmetry that is suitable for single-crystal TMDs growth. Fu et al. suggested that the confusion of twined domains on c-plane sapphire originates from the exposed surface existing compositionally equivalent but symmetrically reflected crystal slabs A and B interfaced by steps (one slab thickness 2.17 Å).⁶³² A precise design of step height (even number of slab thicknesses, i.e., ~0.43 nm) by controlling the miscut angle and annealing temperature could lead to a single-type slab surface for the single crystal TMDs growth (Figure 16d). The universal growth of unidirectional MoS₂ domains on both stepped C/A and C/M sapphire further confirmed this claim. This result strongly demonstrated the critical role of surface atomic symmetry in the epitaxial growth of wafer-scale single-crystal TMDs.

These steady advancements in the epitaxial technique of TMDs on sapphire have efficiently improved their electrical performance due to the suppression of grain boundaries. For example, Wang et al. achieved a remarkable average room-

temperature device mobility of ~70 cm²V⁻¹s⁻¹ and an on/off ratio of ~10⁹ based on the as-grown 4-in. highly oriented MoS₂ monolayer.²⁵ The single-crystal prepared by Li et al. exhibited a FET mobility of 102.6 cm²V⁻¹s⁻¹ and a saturation current of 450 μ A μ m⁻¹, together with >94% device yield and a 15% variation in mobility at the centimeter scale.³⁴ More detailed results on epitaxial growth and the corresponding performance are summarized in Table 1. In this regard, the challenge in material quality has been addressed step by step on the eve of the application of 2D semiconductors. In addition to the sapphire, numerous sulfide-resistant 3D crystalline substrates have also been fully explored in the growth of TMDs, such as quartz,^{633,634} SrTiO₃,^{635–638} LaAlO₃,⁶³⁹ Ga₂O₃,^{630,640} ZnO,⁶⁴¹ TiO₂,^{642,643} MgO,⁶²⁷ SiC,⁶⁴⁴ GaN,^{645,646} and GaAs^{21,647} substrates. The epitaxial TMD islands are also regulated into preferred orientations which can be explained similarly to the case of sapphire.

In summary, seamless stitching of the single orientational domains into a film seems to be the key to the industrial-scale production of large-area single-crystal TMD film. The puzzle of epitaxial growth of TMDs on sapphire has also been gradually unraveled thanks to the combination of experimental and theoretical efforts. Nevertheless, several challenges remain to be addressed, (i) the epitaxial mechanism should be more clarified. Indeed, the epitaxy of TMDs on sapphire is a “black box” coupled with growth dynamics, surface chemistry, step edge, and atomic symmetry. These factors collectively contribute to complex results in both epitaxial registry and dominating factors in unidirectional growth. (ii) the reproducibility should be improved. For instance, the widely adopted step-guiding strategy requires a precise miscut angle and annealing process, to form atomic steps with the desired height, density, and orientation. Otherwise, the misoriented or multilayered TMD domains would hinder the uniform single-crystal growth.

5. STRUCTURAL MODIFICATION OF LARGE-AREA TMDs

Structural modifications, such as altering the arrangement of atoms, introducing defects, or incorporating different elements, have been widely proven to be effective strategies to tune

electronic properties and customize functionalities in both the traditional bulk and 2D semiconductors. Furthermore, the diverse polymorphisms of 2D TMDs provide an additional platform to enrich electronic structures and explore related physics, such as novel topological state in 1T' phase monolayer MoS₂ and superconducting state in NbSe₂. Moreover, the pristine vdW interface of TMDs enables property tailoring via interlayer stacking engineering. Structures with varied layer numbers and stacking orders have attracted extensive investigations in electrical performance, interlayer excitons, nonlinear optics and so on. In this section, we will primarily review the diverse modification techniques for TMD materials, which include (i) component engineering via doping and alloying; (ii) defect engineering, (iii) phase engineering, and (iv) stacking engineering. These flexible structural modifications significantly diversify the application scenarios of TMDs.

5.1. Stacking Engineering

5.1.1. Multilayer Growth. As investigations into TMD advance, there is an increasing recognition that thickness exerts on their electrical and optical performance. Typically, as the number of layers increases, TMDs (such as MoS₂ and WSe₂) exhibit enhanced current density and higher carrier mobility, making them more suitable for the channel materials of ideal transistors. This advantage stems from the intrinsic properties of few-layer TMDs, including a reduced band gap and an increased screening effect that mitigates electron/phonon scattering.^{648,649} Meanwhile, the stability of few layers helps minimize defects-induced Fermi-level pinning during the fabrication, and hence the Schottky barrier and contact resistance.^{650–652} These attributes render them well-suited for demanding applications, including advanced transistors and high-performance sensing devices, where robust current-driving capabilities are essential. Moreover, multilayer TMD materials possess high capacitance and conductivity, making them valuable for manufacturing energy storage devices such as supercapacitors and lithium-ion batteries.

To elucidate the epitaxial growth mode of multilayer TMDs, a qualitative analogy can be drawn with conventional film growth. Generally, the growth of multilayer films can be classified into three types, depending on the interplay between adsorbate–adsorbate and adsorbate–substrate interactions (Figure 17a).⁶⁵³ The main growth modes are (i) Volmer–Weber (VW) growth (3D growth), which happens when the adsorbate–adsorbate interaction is stronger than the adsorbate–substrate interaction. In this case, adsorbate molecules tend to bond to each other rather than spread out on the substrate, leading to the formation of islands that may coalesce over time. (ii) Frank–van der Merwe (FM) growth (2D growth), characterized by stronger adsorbate–substrate interactions than adsorbate–adsorbate interactions. Adsorbate molecules on the film surface uniformly cover it, forming a continuous layer. This mode, also known as layer-to-layer growth, typically occurs during the initial stages of thin film deposition, with new layers forming only after the completion of the underlying layers. (iii) Stranski–Krastanov (SK) growth (from 2D to 3D growth), lies between the VW growth and FM growth modes, where a few initial layers form uniformly before transitioning to island growth, resulting in a nonuniform film. The ideal vapor-phase deposition of multilayer TMDs is expected to follow a layer-by-layer growth mode. However, during the vapor deposition, the 2D growth mode is always

favorable for the first few layers and then evolves into 3D mode for thick layers.

To explore this growth behavior in-depth, Shang et al. developed an integrated DFT and phase diagram modeling approach that demonstrated the existence of a substrate-related critical size, influencing both in-plane lateral and out-of-plane vertical growth during the layer-by-layer growth process.³⁹⁴ Beyond this critical size, the bilayer MoS₂ becomes stable. In addition, Ye et al. theoretically and experimentally proved that lateral and vertical growth is mainly determined by the domain size, temperature, and adatom flux from the vapor of the initial layer.⁶⁵⁴ To date, several strategies have been employed to ensure consistent and controllable layer-by-layer growth during the vapor deposition. A notable example is presented by Zheng et al., who introduced a strategy for layer-by-layer growth of MoS₂ in a confined space, utilizing a gas-phase rapid sulfurization technique with Mo oxides.⁶⁵⁵ The precursors oxidized by Mo foil exhibited varied oxidation states to provide a rapid and continuous source flow, which enabled fine-tuning of the thickness of the MoS₂ flakes ranging from monolayer to more than 20 layers. Moreover, temperature and gas fluctuations during TMD growth often result in uncontrolled and undesired thick nucleation on the initial monolayer, which hinders uniform multilayer epitaxial growth. Zhang et al. introduced a reverse-flow CVD approach through precise control of process temperature and airflow direction during the unstable growth stages.⁶⁵⁶ Bilayer MoS₂ with controllable AA and AB stacking structures were successfully prepared as shown in Figure 17b. Notably, FET devices based on AA stacking bilayer MoS₂ samples demonstrated superior electronic performance than the AB stacking counterpart. Recent studies have further confirmed this electronic difference attributed to the stronger interlayer coupling in AA stacking layers and thus the enhanced electron transport performance in the vertical direction.^{657,658} The growth of large-area stacking-controlled bilayer WS₂ was achieved by a high flux feeding of the W source at high-temperature a-plane sapphire substrates.⁶⁵⁹ The prepared R-stacked bilayers exhibited excellent carrier mobility (~30 times greater than monolayer WS₂) and interfacial ferroelectricity. Recently, Qin et al. developed an interfacial epitaxy strategy by continuously delivering metals and chalcogens to the interface between single-crystal nickel substrates. This methodology formed a consistent 3R stacking sequence, enabling the growth of various TMD single crystals with thicknesses ranging from a few layers to 15,000 layers.⁶⁶⁰

Epitaxial growth of large-area multilayer TMD films is more challenging from a thermodynamic perspective, where the surface energy of MoS₂ increases with the number of layers, which is unfavorable for the epitaxy of multilayer uniform films.^{394,652,661,662} Research indicates that engineering the surface energy of MoS₂ through the substrate proximity effect could potentially overcome this thermodynamic limitation. In this regard, Wang et al. reported a layer-by-layer epitaxial growth strategy to prepare high-quality 4-in. multilayer (1L to 3L) MoS₂ films on sapphire substrate, as illustrated in Figure 17c,d.⁶⁴⁸ The FET arrays based on the multilayer MoS₂ showed excellent average field-effect mobility at room temperature of 110 and 145 cm²V⁻¹ s⁻¹ for bi- and trilayers, respectively. To circumvent limitations from layer-by-layer growth, the direct stitching of aligned multilayer TMD islands is proposed as an alternative strategy. In theory, the free energy is relatively small when the multilayer MoS₂ domains are edge-aligned on the sapphire steps. Therefore, it is possible to grow

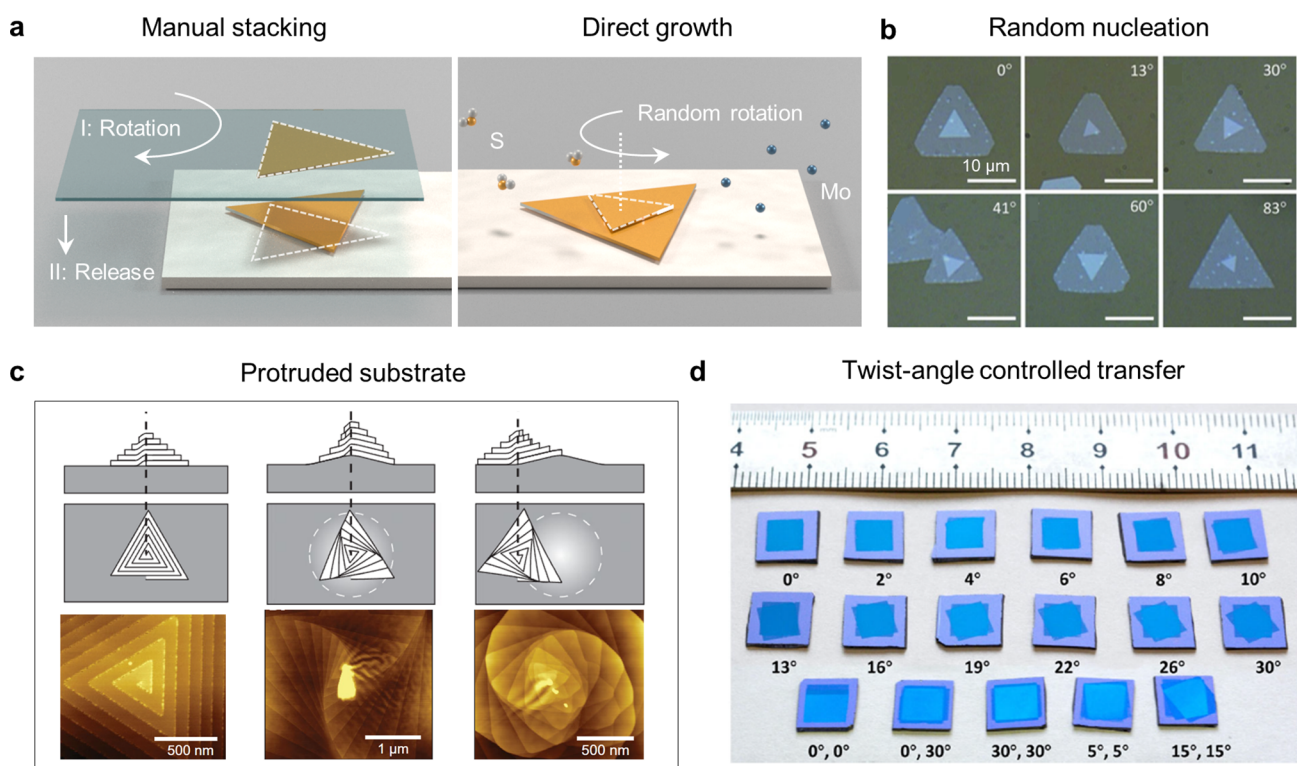


Figure 18. Fabrication strategies of large-area twist TMDs. (a) Schematic illustrations of manual stacking and direct growth of twist designing. (b) Optical images of CVD-grown bilayer WS₂ with twist angles 0°, 13°, 30°, 41°, 60°, and 83°, respectively. Reprinted with permission from ref 673. Copyright 2015 Wiley-VCH Verlag GmbH & Co. KGaA, Weinheim. (c) Controlled synthesis of supertwisted TMD spirals by introducing non-Euclidean curvatures. Reprinted with permission from ref 678. Copyright 2020 AAAS. (d) Optical images of centimeter-scale transferred MoS₂ bilayers with precisely controlled interlayer twist angles. Reprinted with permission from ref 679. Copyright 2020 Springer Nature.

multilayer islands with a controlled thickness on the surface with a certain step height and then stitch them together to obtain a uniform film.⁶⁶³ Experimentally, Liu et al. successfully fabricated centimeter-scale bilayer MoS₂ films on sapphire substrates through edge nucleation and epitaxy.⁶²⁶ C-plane sapphire substrates with a designed miscut angle allowed for the unidirectional alignment of MoS₂ domains. Furthermore, by carefully tuning the atomic terrace height, >99% of nucleations could be controlled as bilayer MoS₂ and finally coalesced into continuous film (Figure 17e and f).

Besides, strategies including ALD, MOCVD, and sulfuration of metal oxide precursors can realize the wafer-scale synthesis of multilayer TMDs.^{26,664,443} In 2020, Liu et al. demonstrated the synthesis of wafer-scale, thickness-controllable MoS₂ films using ALD.⁶⁶⁵ By utilizing MoCl₅ and hexamethyldisilathiane as precursors, and with the reaction temperature set at 350 °C under a pressure approaching 5 mbar, wafer-scale MoS₂ films were synthesized on wafer-scale sapphire and SiO₂ substrates. The thickness of MoS₂ layers was modulated by the ALD cycles. Furthermore, the experiment utilized these MoS₂ films to produce large-scale FET arrays and logic circuits, including inverters, NAND, AND, NOR, and OR gates, showcasing the potential for their scalable applications. In addition, Kalanyan et al. reported a pulsed MOCVD method to grow MoS₂ films with different thicknesses at the wafer scale.⁶⁶⁴ Experimentally, they used metal–organic and organosulfur as precursors, and they deposited MoS₂ films with thickness from ~1 nm to ~25 nm with a growth rate of 0.12 nm/pulse. These methods provide new avenues for high-throughput production of wafer-scale multilayer TMDs, but the controllability and crystallinity required to be further improved.

The unique structure and properties of multilayer 2D TMDs offer new freedom for innovation in electronics and optoelectronics. However, the production of multilayer TMD materials poses practical challenges that necessitate careful consideration and resolution. (i) The precise stacking order (2H or 3R) between layers profoundly influences the performance of multilayer TMDs, which must be precisely controlled across the large-area multilayers. (ii) The thickness uniformity and single-crystallinity of the TMD multilayers are crucial to guarantee reproducibility and stability of corresponding devices. (iii) The synthesis of large-area uniform four or thicker TMD layers has not been validated on dielectric substrates.

5.1.2. Twist Design. Introducing arbitrary twist angle (θ) between bilayer 2D layers provides the θ -dependent moiré superlattice at the vdW interface. This distortion has attracted extensive attention in both TMD systems for exploring exotic phenomena such as strong correlation physics, moiré topionics, and optoelectronics. Experimentally, these artificial twisted crystals are mainly prepared by the “tear-and-stack” technique, where unavoidable contaminations, strains, and lattice reconstruction could limit the reproducibility and uniformity of the twisted samples.⁶⁶⁶ Therefore, the direct synthesis of twist TMDs with a clean interface is promising for constructing ideal moiré materials (Figure 18a). However, the nontwisted AA and AB stacking are energetically favorable compared with arbitrary twisted structures. The main challenge lies in how to introduce perturbations to overcome this energy barrier and definitely design the interlayer twist angles.⁶⁶⁷

During the CVD growth of TMDs, twist bilayers could emerge randomly.^{668–672} In 2015, Zheng et al. directly grew

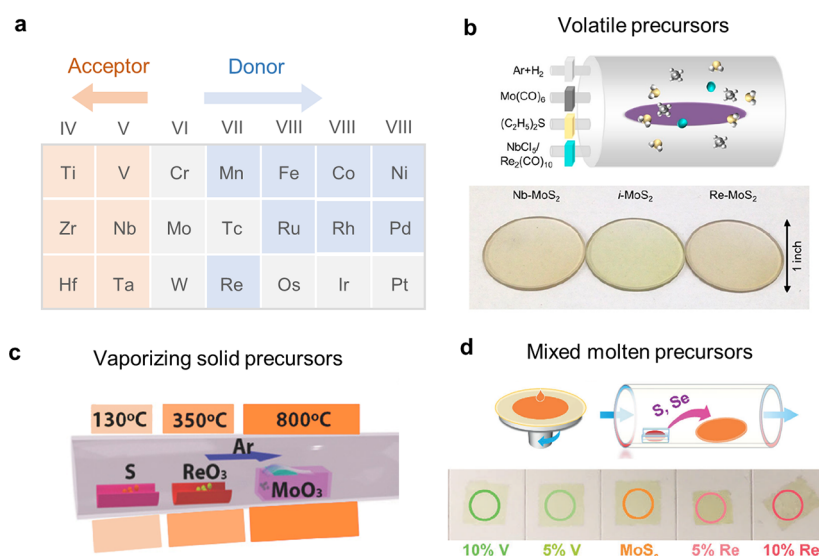


Figure 19. Donor/acceptor substitution of large-area TMDs. (a) Elements that can substitute the metal sites of Group VI TMDs, the orange and blue colors indicate their roles as either acceptors or donors, respectively. (b) Schematic illustrations of the MOCVD system for the growth of doped MoS₂ using volatile precursors (top panel) and the optical micrograph of intrinsic and doped MoS₂ grown on 1-in. fused silica (bottom panel). Reprinted with permission from ref 693. Copyright 2020 American Chemical Society. (c) Schematic for the synthesis of monolayer Re-MoS₂ using ReO₃ powder as the precursor. Reprinted with permission from ref 695. Copyright 2018 Wiley-VCH Verlag GmbH & Co. KGaA, Weinheim. (d) Schematic illustrations of the CVD growth of Re- and V-doped TMDs by mixed salt solution (top panel) and optical images of the transferred samples with different dopant concentrations (bottom panel). Reprinted with permission from ref 712. Copyright 2021 Wiley-VCH Verlag GmbH & Co. KGaA, Weinheim.

WS₂ bilayers with random twist angles of 0°, 13°, 30°, 41°, 60°, and 83° using the CVD method (Figure 18b).⁶⁷³ Yu et al. found that the collision and coalescence of monolayer TMDs with different orientations led to twisted bilayers with high probability in a range of 20° < θ < 55°.⁶⁷⁴ The mechanism was explained as the strain generated by coalescence induced the second-layer nucleation and preserved the original crystal misorientation angle. Recently, Xu et al. proposed a reconfiguring nucleation CVD strategy and synthesized a large number of TMD bilayers with random twist angles ranging from 0° to 120°.^{675,676} Systematic examinations indicated that increasing the molar ratio of NaCl to MoO₃ or decreasing the gas flow rate could improve the yield (17.2%) and density (28.9 pieces/mm²) of twisted MoS₂ samples. In addition, precise control of the interlayer twist in multilayer TMD spirals has been achieved through substrate engineering. These supertwist spiral structures are driven by screw dislocation, a typical line defect that enables the continuous growth of layered TMD in an out-of-plane direction.⁶⁷⁷ Zhao et al. introduced the curved substrate surfaces and demonstrated the controlled growth of super-twisted spirals of WS₂ and WSe₂ materials (Figure 18c).⁶⁷⁸ The success of this model can be attributed to its utilization of nanoparticles as protrusions on planar substrates, which introduces non-Euclidean curvature into the growth process. Experimental evidence provides further validation for the formation of moiré superlattices between atomic layers, emphasizing the potential for precise control of twist angles in TMD materials.

To date, the direct growth of twist TMDs is still limited by the small sample sizes and random twist angles. The production of large-area twist structures constitutes a pivotal step for applications in twistrionics, which could be addressed by manually transferring large-area as-grown monolayers. In 2020, Liao et al. reported the centimeter-scale multilayer MoS₂

stacks with precisely controlled interlayer twist angles by water-assisted transfer of 2-in. highly oriented monolayer MoS₂ (Figure 18d).⁶⁷⁹ Although this combination of epitaxial growth and transfer technique facilitates the realization of vdW stacked structures with precise twist angles over large areas, the interfacial imperfect still degenerates the quality of the prepared twisted crystals.

In summary, the emergence of as-grown twisted 2D TMDs offers an exciting avenue for exploring novel physics and enables promising electronic and optoelectronic applications. Nevertheless, the controlled and uniformly twist angles across the large-area synthesized multilayer TMDs are still challenging due to the competition with nontwist cases during the high-temperature growth process. New modulation mechanisms and growth strategies are requisite to satisfy the demands of high-quality moiré material in this field.

5.2. Component Engineering

5.2.1. Donor/acceptor Substitution.

Introducing impurity atoms into a perfect crystal lattice would lead to disturbances in period potential, allowing for the modulation of electronic structures. This component engineering is utilized as a powerful tool in bulk semiconductors for tuning the carrier types and concentrations. Selective n- and p-doping is crucial for constructing p–n junction in high-rectification diodes and high-response photodetectors. However, the ion implantation techniques, widely used in the silicon industry, can be challenging when applied to 2D materials due to the potential damage to their atomically thin structures. Alternatively, various strategies have been tailored for direct synthesizing doped 2D semiconductors such as MOCVD, vaporizing solid precursors, mixed dopant salts, and so on. For the functionalization of Group VI TMD materials (e.g., MoS₂ and WSe₂), Group V (e.g., V and Nb) and Group VII (e.g., Re and Mn) dopants work as acceptors and donors, resulting in p-

and n-type doping, respectively (Figure 19a). The isoelectronic doping (Mo and W) will be further discussed in Section 5.2.2. Besides electrical properties modulations, magnetic dopants such as Fe and Co elements could introduce fascinating magnetic properties to 2D semiconductors.^{680–685}

To date, the main challenges of TMDs doping lie in the following respects: (i) diversity of doped elements. The range of dopants is limited due to concerns about lattice distortion extent and thermodynamic stability of impurity-doped structures. Precise tuning of doping conditions, selection of suitable precursors, and adoption of appropriate strategies are demanded to further reduce the formation energy and enable a flexible doping process.⁶⁸⁶ (ii) fine-tuning doping concentration. Due to the quantum confinement and reduced screening in 2D materials, the ionization energy of dopants in TMDs is higher compared with the cases in bulk species. Consequently, a high doping concentration of up to several percent with excellent controllability is required for material performance modulation. (iii) spatial uniformity in doping. A steady precursor/dopant ratio during growth is the prerequisite for achieving large-area doped TMDs. Besides, numerous factors such as substrate surface, edge termination of TMDs, doping concentration, and annealing process can affect the uniformity of the prepared sample.^{687–689}

The MOCVD technique using volatile metal precursors (e.g., heated NbCl_5 , $\text{Re}_2(\text{CO})_{10}$) works as a powerful tool for controlled doping of TMDs materials.^{690–692} This method offers the advantage of fine-tuning the doping concentration over a wide range managed by a gas flow controller. Additionally, the use of active and volatile dopants facilitates large-area doping with excellent uniformity. As shown in Figure 19b, Gao et al. fabricated homogeneous 1-in. Nb-doped, intrinsic, and Redoped MoS_2 monolayer wafers using MOCVD.⁶⁹³ The doping concentration can be reproducibly adjusted up to 20% and the electrical conductance of the Nb-doped MoS_2 was tuned over 7 orders of magnitude. Besides, benefiting from the precise control over precursor partial pressure in MOCVD, Kozhakhmetov et al. realized highly precise doping down to 0.0001% Re atoms in the WSe_2 lattice, and the growth and doping processes were carried out below the BEOL temperature limitation.⁶⁹⁴ It is also suggested that the dilute Re doping (down to 500 ppm) could reduce the sulfur vacancy and improve the carrier transport.⁶⁹¹

Solid dopant powders (e.g., ReO_3 , NbCl_5 , FeCl_2) are also widely employed in high-temperature CVD chambers to facilitate the doping process, which can be vaporized under similar conditions to those used for MoO_3 or WO_3 precursors. For instance, Zhang et al. utilized the “point-to-face” strategy to supply Re dopants by thermally evaporating ReO_3 powder at 350 °C (Figure 19c).⁶⁹⁵ This process led to a Re doping concentration of 1 at% in MoS_2 crystal, which behaved as the n-type transport feature, and the defect-bound emission was significantly quenched. This is a universal technique benefiting from various available dopants and operation convenience, which has proven effective in preparing on-demand doped samples by introducing adequate Nb, Re, Fe, Co, Mn, V, Zn, Sn, Eu, and other impurities into TMD materials.^{622,623,696–704} Similar to the challenge faced in power-based TMDs growth, as discussed in the previous sections, the diffusion-induced dopant concentration gradient should be carefully controlled to ensure large-area uniformity. To date, modified strategies such as halide salt assistance and molten salt mixing also have been developed for efficient doping.^{705,706} Specifically, soluble

precursors dispersed on the target substrate can provide a uniform dopant supplement for large-area sample growth.^{707–711} Li et al. mixed the additive $\text{NaVO}_3/\text{NaReO}_3$ with $\text{Na}_2\text{MoO}_4/\text{Na}_2\text{WO}_4$ precursors, followed by sulfurization, which enabled the fabrication of high-crystallinity TMDs films with tunable doping concentrations (Figure 19d).⁷¹²

In addition to the substitution of metal elements, the doping at chalcogen sites also facilitates property modifications. The Group XV (e.g., N and P) and Group XVII (e.g., F and Cl) atoms act as p- and n-dopants, respectively.^{713–716} In-situ substitution with these nonmetal elements is challenging due to the high formation energy required in the vapor deposition conditions. Consequently, postprocessing of intrinsic TMDs provides an alternative way. The doping of corresponding nonmetal atoms has been realized by various methods, including plasma implanting, laser irradiation, solution soaking, and so on.^{717–720} For example, Azcatl et al. exposed MoS_2 layers in N_2 plasma and realized the p-type covalent nitrogen doping together with a compressive strain.⁷²¹ Another strategy is predoping the target atoms into precursor films, Cao et al. prepared WO_xN_y film using the ALD technique with controllable thickness, and the following sulfurization resulted in the N-doping WS_2 showing excellent p-type behavior.⁷²²

5.2.2. Isoelectronic Substitution. When adequate amounts of impurity atoms are introduced into a host TMDs material, it can be regarded as the alloying of different components.⁷²³ This allows for the continuous tuning of basic properties like lattice constants and band gaps over a wide range, depending on the concentration ratios. Isoelectronic atoms act as appropriate alloying pairs due to their similar lattice constants and M-X bond lengths, which are mixing-energy favorable and thermodynamic stable in structures. In 2013, Dumcenco et al. demonstrated the random alloying of metal elements (Mo or W) in monolayer $\text{Mo}_{1-x}\text{W}_x\text{S}_2$ as visualized using STEM.⁷²⁴ To date, the disordered isoelectronic substitution of both chalcogen sites and metal sites has been realized experimentally (Figure 20a) to form a series of monolayer alloys including ternary^{725–733} $(\text{MoS}_2(1-x))\text{Se}_{2x}$

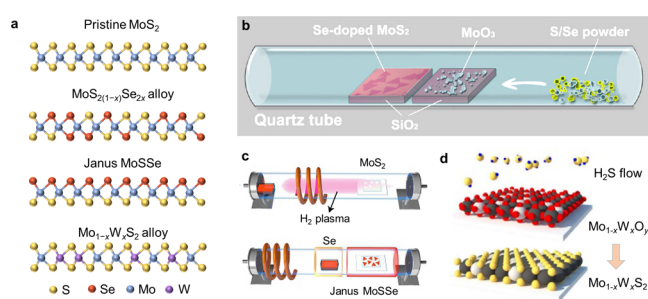


Figure 20. Isoelectronic substitution of large-area TMDs. (a) The atomic models of the isoelectronic substitutional monolayer MoS_2 , from top to bottom, pristine MoS_2 , $\text{MoS}_2(1-x)\text{Se}_{2x}$ alloy, Janus MoSSe , and $\text{Mo}_{1-x}\text{W}_x\text{S}_2$ alloy. (b) Controlled synthesis of large-area $\text{MoS}_2(1-x)\text{Se}_{2x}$ via CVD with S/Se powder positioned at low temperature zone. Reprinted with permission from ref 737. Copyright 2013 American Chemical Society. (c) Synthesis of the Janus MoSSe monolayer by stripping the top-layer S via H_2 plasma and followed by thermal selenization. Reprinted with permission from ref 750. Copyright 2017 Springer Nature. (d) Controlled synthesis of $\text{Mo}_{1-x}\text{W}_x\text{S}_2$ alloys by sulfurizing supercycle ALD prepared $\text{Mo}_{1-x}\text{W}_x\text{O}_y$ layer. Reprinted with permission from ref 774. Copyright 2015 Springer Nature.

$\text{WS}_{2(1-x)}\text{Se}_{2x}$, $\text{Mo}_{1-x}\text{W}_x\text{S}_2$, and $\text{Mo}_{1-x}\text{W}_x\text{Se}_2$) and quaternary^{366,734} ($\text{Mo}_{1-x}\text{W}_x\text{Se}_{2(1-y)}\text{S}_{2y}$ and $\text{MoS}_{2(1-x-y)}\text{Se}_{2x}\text{Te}_{2y}$) species. This flexible component design enables precise bandgap engineering, which is crucial for photon absorption/emission-related applications such as displays, sensors, and photodetectors. Specifically, the chalcogen site substitution selectively takes place at the top or bottom sublayers of TMDs resulting in structures known as Janus monolayers (e.g., MoSSe and WSSe).⁷³⁵ Their intrinsic out-of-plane inversion asymmetry raises attractive properties such as out-of-plane SHG and piezoelectricity. In this section, we mainly focus on the preparation strategies for these disordered alloys and novel structures by isoelectronic substitution.

The isoelectronic substitution of chalcogen sites is feasible because these atoms are exposed at the surface of TMD materials and the structure is free to relax.⁷³⁶ In 2013, Gong et al. utilized the mixed S and Se powders (Figure 20b) as the chalcogen precursors for vapor deposition of large-area $\text{MoS}_{2(1-x)}\text{Se}_{2x}$ monolayers on SiO_2/Si .⁷³⁷ The band gap of the film could be arbitrarily tuned from 1.8 eV (pure MoS_2) to 1.5 eV (pure MoSe_2) by varying the S/Se atoms ratio. The detailed emission energies showed a bowing behavior while changing the composition. The operation convenience of this mixed chalcogen source has led to its widespread use in the one-pot deposition of random ternary alloys, with alloy content controlled by the source ratio.^{488,738,739} For example, Fortin-Deschênes et al. employed a two-step strategy to construct the $\text{WS}_y\text{Se}_{2-y}/\text{WS}_x\text{Se}_{2-x}$ bilayer alloys with different chalcogen contents, achieving high-quality moirés with a tunable period from 10 to 45 nm, controlled by the lattice mismatch.⁷⁴⁰ Moreover, Feng et al. simultaneously heated the MoS_2 and MoSe_2 powders and deposited them onto the target substrate to form $\text{MoS}_{2(1-x)}\text{Se}_{2x}$ ($x = 0-0.4$) alloys.⁷⁴¹ Higher Se concentration ($x = 0.4-1.0$) was also achieved by adding Se vapor in this PVD system.⁷⁴² Besides, the exposed chalcogen layers of TMDs can easily be decomposed and substituted by other chalcogen atoms at high temperatures.⁷⁴³⁻⁷⁴⁵ Su et al. achieved fine-tuning of components by selenizing preprepared MoS_2 in selenium vapors, with substitution temperatures as a control factor.⁷⁴⁶ Similarly, Taghinejad et al. exchanged the Se atoms of host MoSe_2 with S atoms and obtained $\text{MoS}_{2(1-x)}\text{Se}_{2x}$ structures, indicating that CVD-grown films with abundant vacancy defects are more easily alloyed.⁷⁴⁷ This exchange strategy is also suitable in the tellurization process, Yun et al. converted MoS_2 and WS_2 into $\text{MoS}_{2-x}\text{Te}_x$ and $\text{WS}_{2-x}\text{Te}_x$ alloys with the assistance of sodium atoms.⁷⁴⁸ Conversely, prepared $1\text{T}'\text{-MoTe}_2$ could be alloyed with sulfur, triggering a phase transition to the 2H phase with varying alloy content.⁷⁴⁹

The postsubstitution of chalcogen layers indicates the novel Janus structure could be artificially designed by precisely controlling mild substituting conditions. In 2017, Lu et al. used H_2 plasma to strip the top S atom layer of monolayer MoS_2 , forming the intermediate MoSH structure. This was then thermally selenized into a Janus MoSSe layer at 450 °C (Figure 20c).⁷⁵⁰ The asymmetric structure was carefully examined by cross-section STEM, energy-dependent XPS, and out-of-plane SHG. Moreover, H_2 plasma-activated chalcogen powders could directly transform TMDs into Janus structures at room temperature, where active H radicals significantly reduce the reaction energy barriers.^{751,752} This method has led to the creation of various Janus materials such as 2H-MoSSe , $1\text{T}'\text{-MoSSe}$, WSSe , NbSSe , and their heterostructures.⁷⁵³⁻⁷⁵⁵ Besides, low-energy Se implantation by PLD can kinetically

convert WS_2 into desired Janus WSSe .^{756,757} Alternatively, directly high-temperature substitution also gives similar results, Zhang et al. sulfurized the as-grown MoSe_2 monolayers at a specific temperature window of 750–850 °C, forming a Janus MoSSe structure.⁷⁵⁸

Oxygen atom substitution is a well-known isoelectronic dopant in TMDs, which always occurs during ambient condition oxidation or the introduction of oxygen during the growth process.⁷⁵⁹⁻⁷⁶¹ Pető et al. revealed that under ambient exposure, sulfur atoms in MoS_2 could be individually replaced by oxygen, ultimately leading to a $\text{MoS}_{2-x}\text{O}_x$ crystal.⁷⁶² The single-atom oxygen centers significantly improved the catalytic activity in electrochemical H_2 evolution. Besides the mild oxidation, the oxygen plasma treatment can quantitatively introduce O atoms into the TMD lattice and improve the electrical performance.^{763,764} Jadwiszczak et al. applied O_2/Ar plasma to pristine MoS_2 layers and observed an initial deterioration in mobility, which then recovered to above-original levels after a critical 6-s treatment.⁷⁶⁵ This phenomenon was attributed to the formation of a 2D MoO_x layer that screened charges associated with sulfur vacancies.

The isoelectronic substitution at metal sites in TMDs needs to overcome the challenge of inhomogeneous mixing of metal atoms.⁷⁶⁶⁻⁷⁷⁰ Their limited diffusion ability hinders the formation of large-area uniform alloys, leading to a gradient composition or even the formation of heterostructures. To bridge the growth temperature gap between MoS_2 and WS_2 when using oxide powders, Wang et al. replaced WO_3 with the more volatile WCl_6 , successfully synthesizing large-area uniform $\text{Mo}_{1-x}\text{W}_x\text{S}_2$ alloy with tunable components.⁷⁷¹ Steady cofeeding of metals can also be achieved by uniformly dispersing precursors. For example, Lee et al. applied a solution processing method where MoO_3 and WO_3 were spin-coated onto the substrate and then heated to target temperature windows.⁷⁷² This approach enabled the controlled synthesis of a series of structures including $\text{Mo}_{1-x}\text{W}_x\text{S}_2$ alloy, $\text{MoS}_2/\text{alloy}$, alloy/WS_2 , and MoS_2/WS_2 heterostructures. Similarly, Kim et al. dispersed MoO_2 and $\text{W}_{18}\text{O}_{49}$ nanoparticles across the substrate, adjusting the components by varying the Mo/W precursor ratio.⁷⁷³ Additionally, the two-step strategy efficiently avoids the precursor diffusion issues by codepositing metal layers. Song et al. carried out the supercycle ALD process (consisting of n cycles of ALD MoO_x and m cycles of ALD WO_3) to obtain a $\text{Mo}_{1-x}\text{W}_x\text{O}_y$ layer (Figure 20d).⁷⁷⁴ This layer was then sulfurized into $\text{Mo}_{1-x}\text{W}_x\text{S}_2$ alloy by heating in H_2S gas. The alloying Mo/W ratio corresponded to the n/m ratio of the ALD supercycles. Park et al. cosputtered a $\text{Mo}_{1-x}\text{W}_x$ metal film and subsequently sulfurized it to form $\text{Mo}_{1-x}\text{W}_x\text{S}_2$ multilayers, where postlaser processing could thin the film into a monolayer alloy.⁴⁴⁸ Zheng et al. used PLD to prepare centimeter-sized $\text{Mo}_{0.5}\text{W}_{0.5}\text{Se}_2$ alloying films. Their work demonstrated that alloying engineering in TMDs could significantly suppress the deep-level defect states and further improve the device performance.⁷⁷⁵

5.3. Phase Engineering

The polymorphic nature of TMDs and corresponding diverse electronic structures provide extra freedom for functionalization by phase engineering. For group VI TMDs, the access to metastable $1\text{T}/1\text{T}'$ phase inspires fruitful explorations such as hydrogen evolution, contact optimization, and topological FETs.⁷⁷⁶⁻⁷⁷⁸ Electrochemical ion intercalation-based exfoliation of TMD serves as a high-yield producing strategy for

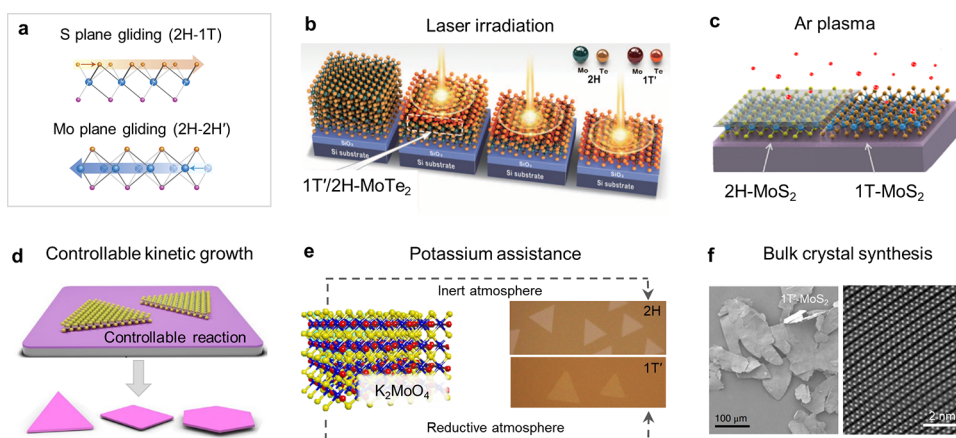


Figure 21. Phase engineering of large-area TMDs by phase transition and selective synthesis. (a) Atomic mechanism of the 2H/1T phase transition of MoS₂ by gliding atomic planes of S and Mo planes, which results in the 2H → 1T and 2H → 2H' transition, respectively. Reprinted with permission from ref 786. Copyright 2014 Springer Nature. (b) Laser-driving 2H → 1T' phase transition of MoTe₂. Reprinted with permission from ref 787. Copyright 2015 AAAS. (c) Formation of 1T phase MoS₂ by Ar plasma treatment. Reprinted with permission from ref 788. Copyright 2017 American Chemical Society. (d) Kinetic growth mode for the controllable synthesis of transition metal chalcogenides with different phases and compositions. Reprinted with permission from ref 804. Copyright 2023 Springer Nature. (e) K-assisted selective CVD growth of 1T' and 2H phase MoS₂ monolayers. Reprinted with permission from ref 811. Copyright 2018 Springer Nature. (f) The SEM image of the prepared micrometer-sized 1T'-MoS₂ bulk crystals (left panel) and the STEM image of single-layer 1T'-MoS₂ nanosheet (right panel). Reprinted with permission from ref 812. Copyright 2018 Springer Nature.

preparing metallic 1T/1T' nanosheets, but it potentially suffers from limited phase purity and lateral size.^{779,780} Alternatively, the controllable phase transition and direct-growth approaches enabled the phase engineering of large-area TMDs. In theory, the energy barriers (ΔE) between the 2H and 1T/1T' species should be overcome to obtain metastable phases, which vary in TMDs with different chemical components. For example, in Mo-dichalcogenides, the ΔE are evaluated to be $\Delta E[\text{MoSe}_2] > \Delta E[\text{MoS}_2] > \Delta E[\text{MoTe}_2]$.⁵³¹ Specifically, WTe₂ inherently possesses the 1T' ground-state structure. In this section, we mainly focus on various phase engineering strategies aimed at large-area phase transition and selective synthesis of metastable phase TMDs.

The phase transition of TMDs could be triggered via various modulations such as electron beam irradiation, laser irradiation, electrostatic doping, plasma bombardment, chemical treatment, strain engineering, and plasmon excitation.^{781–785} As shown in Figure 21a, the atomic mechanism of the 2H/1T phase transition in MoS₂ lies in the gliding atomic planes of S and/or Mo, where an intermediate phase acts as an important precursor.⁷⁸⁶ Chalcogen vacancies in TMDs can serve as electron donors and facilitate the phase transformation. For example, laser irradiation was employed to create irreversible Te vacancy and derive the phase transition of 2H-MoTe₂ to 1T' species (Figure 21b).⁷⁸⁷ The transistors based on the 2H/1T' patterns exhibited excellent performance due to the ohmic contact. Similarly, the bombardment from gentle Ar plasma with certain kinetic energy also induced a phase transition from 2H to 1T in monolayer MoS₂ (Figure 21c).⁷⁸⁸ Besides the defect induction, another commonly used phase transition strategy is the introduction of alkali ions by chemical treatment. The mechanism lies in the charge transfer from the alkali ions to the host 2H species leading to the change of electron counts in *d* orbitals of transition metal atoms, thereby stabilizing the metallic 1T phase.^{789–792} For example, Kappera et al. immersed the poly(methyl methacrylate) (PMMA) masked 2H-MoS₂ sample in *n*-butyl lithium and realized the locally patterned transition to the 1T phase.⁷⁹³ Moreover, this

phase transition process is layer-dependent, where the phase stability for 2H-MoS₂ is demonstrated to decrease in thicker layers.⁷⁹⁴

Besides the phase transition strategy, phase selectable synthesis of large-area TMDs is also a favorable approach because of the high phase purity and crystallinity. The direct synthesis of metastable phases of TMDs can be achieved by techniques such as optimizing reaction kinetics, composition tuning, additive assistance, interface engineering, and precursor design.^{795–803} As shown in Figure 21d, Zhou et al. demonstrated a competitive-chemical-reaction-based growth mechanism and controllably synthesized 67 types of transition metal chalcogenides (TMCs) and transition metal phosphorus chalcogenides (TMPCs) with defined phase, controllable structure, and tunable component.⁸⁰⁴ Low-concentration doping and wide-range alloying process facilitate the phase controlling between the H and T phases.^{805–807} For example, the WTe_{2-x}S_{2(1-x)} alloys prepared via the one-step CVD method processed a phase transition from 1H to 1T' while the Te concentration *x* increasing.⁸⁰⁸ Moreover, the interfacial interaction between as-grown material and substrate also provides the freedom for the phase-controlled growth of TMDs. The Se-pretreated Au(111) is more favorable for 1T'-MoSe₂ growth due to the Mo intercalation of the Au–Se interface stabilizing the 1T' phase.⁸⁰⁹ The in-plane compressive strain at the interface of WSe₂ and SrTiO₃ (100) substrate enabled the 100% pure 1T' phase growth via MBE.⁸¹⁰

Liu et al. demonstrated a K-enriched CVD growth of high-phase-purity 1T'-MoS₂ monolayers using K₂MoS₄ as the precursor (Figure 21e).⁸¹¹ The 1T' phase was calculated as more stable than the 2H phase while increasing K concentration exceeding 44%. Similarly, these K-contained precursors were also utilized to synthesize high-phase purity 1T' TMDs bulk crystals. As shown in Figure 21f, by designing a two-step reaction between K₂MoO₄ and S powders, micrometer-sized metallic-phase 1T'-MoS₂ was robustly fabricated.⁸¹² The as-prepared metastable structures were convertible to 2H species by thermal annealing or laser

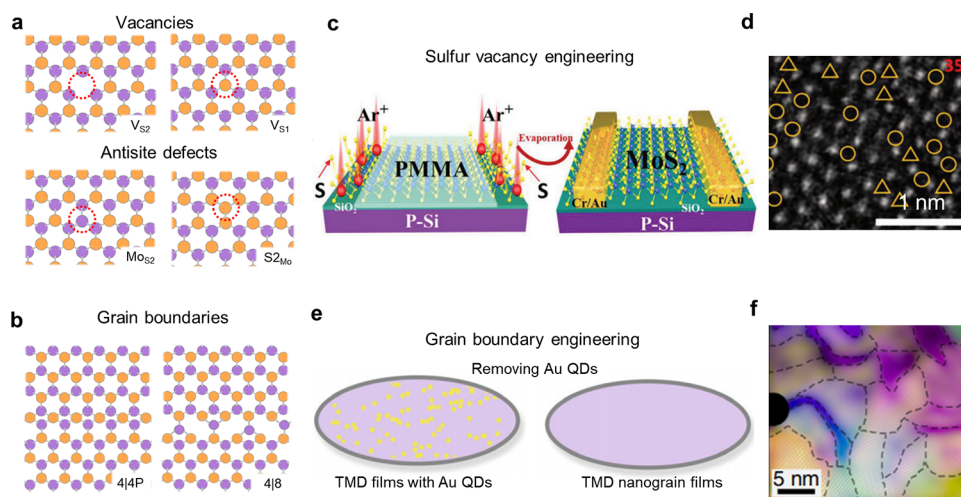


Figure 22. Defect structures and corresponding engineering in large-area TMDs. (a) Typical atomic structure diagram of point defects (vacancies and antisite defects). (b) Typical atomic structure diagram of line defect (grain boundaries). (c) Schematic for the monolayer MoS_2 FET with ohmic contact by sulfur-vacancy engineering. (d) HAADF-STEM image of monolayer MoS_2 after 35 s of argon plasma processing. (c,d) Reprinted with permission from ref 829. Copyright 2015 Wiley-VCH Verlag GmbH & Co. KGaA, Weinheim. (e) Growth of wafer-scale nanograin TMD films by the Au quantum dots assist CVD. (f) False-colored frequency filtered images of TMD films with ultrahigh grain boundary densities. (e,f) Reprinted with permission from ref 839. Copyright 2020 Springer Nature.

irradiation. Furthermore, this synthetic method appeared general for large-scale fabrication of metastable 1T'-phase TMDs including WS_2 , WSe_2 , MoS_2 , MoSe_2 , $\text{WS}_{2x}\text{Se}_{2(1-x)}$, and $\text{MoS}_{2x}\text{Se}_{2(1-x)}$.⁸¹³

Despite significant advancements in the phase engineering of TMDs, the development of techniques for direct synthesizing large-area, thickness-controlled, and phase-pure metastable TMDs is still in its nascent stages due to the constraints imposed by formation energy. Their applications are also constrained by challenges in large-scale production and the limited thermal stability of metastable TMDs, which leads to phase transitions and the formation of mixed phases. Therefore, in-depth studies of the growth mechanisms and structural changes of metastable TMDs, utilizing advanced in situ techniques, may provide valuable insights for developing new synthesis strategies to produce metastable TMDs and promote their widespread application.

5.4. Defects Engineering

Atomically-thin TMDs typically possess a high defect density of $\sim 10^{13} \text{ cm}^{-2}$ that crucially modulates their electronic and optical properties. Defect engineering strategies involve the deliberate introduction, healing, or modification of defects within the crystal lattice that can tailor TMDs for diverse application scenarios. Suppressing the defect density toward the perfect single crystal is the ultimate goal of the TMD material synthesis, to take advantage of their fascinating intrinsic characteristics. An alternative proposal is employing the defects to functionalize TMDs. For example, defects can reduce the metal contact resistance, improving the device performance based on 2D TMDs.⁸¹⁴ In addition, the density of catalytic sites can be increased by introducing specific types of defects in the hydrogen evolution process, thus improving the reaction rate and efficiency.⁸¹⁵ In this section, we will briefly introduce the 0D and 1D defects in the vapor-deposited TMDs, and then discuss the potential applications based on these intrinsic or extrinsic defects.

In practice, owing to the ultrathin 2D nature and exceedingly high surface area of TMDs, the introduction of defects during

sample synthesis remains inevitable regardless of the synthetic method employed. Defects within TMDs are disruptions in the orderly geometric arrangement of atoms in a crystalline solid, and the classification of defect structures can be divided into two categories, namely 0D point defects and 1D line defects. Point defects occur at specific locations within the TMD lattice as shown in Figure 22a, including the vacancies (monosulfur vacancy V_S , disulfur vacancy V_{S_2} , vacancy complex of Mo and nearby three sulfur V_{MoS_3} and so on) and antisite defects (Mo atom substituting a S2 column Mo_{S_2} and a S2 column substituting a Mo atom $\text{S}_{2\text{Mo}}$).⁸¹⁶ The dominant category of point defects is different depending on the synthetic methods, for instance, the sulfur vacancies are frequently observed in the CVD and mechanical exfoliation sample, but Mo antisites are dominant in PVD samples.⁸¹⁷ Line defects involve atoms or lattice dislocations arranged linearly along distinct orientations, the dominant line defects in TMDs are the 1D grain boundaries. The complex dislocation cores compose various grain boundaries in vapor-deposited polycrystalline TMDs (such as 5/7, 4/4, 4/6, 4/8, and 6/8 fold rings).⁸¹⁶ For example, two 60° rotated grains could give different boundary structures (Figure 22b), 4-fold rings with point sharing at a common S2 site (4/4P structure), and 4-fold rings with edge-sharing (4/4P structure). These rich defect structures hold the potential to modulate the electronic structure of TMDs, and corresponding engineering has provided a range of opportunities in fields such as optics, electronics, and catalysis.^{814,815,818–821}

The defects have a double-sided effect on the electrical performance of TMD-based devices. On the one hand, these defects can serve as localized scattering centers, degenerating the mobility of charge carriers. On the other hand, defect states provide extra freedom in functionalizing electronic and optoelectronic devices.⁸²² In 2016, Ly et al. demonstrated that grain boundaries in MoS_2 reduced its electrical properties, and the performance is misorientation-angle-dependent on the grain boundaries.⁸²³ Therefore, how to reduce the defect density and access ultrapure TMDs has become a widely concerned topic. In recent years, numerous strategies such as poly(4-styrenesulfonate) processing, grain boundary sliding,

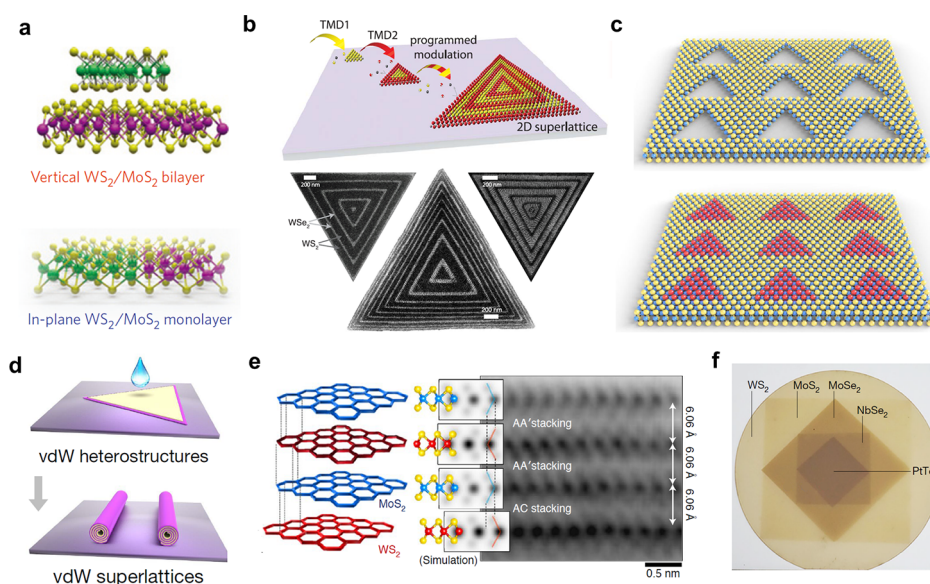


Figure 23. Preparation strategies of large-scale lateral and vertical TMD heterostructures. (a) Schematic of the vertically stacked WS_2/MoS_2 heterostructures synthesized at 850°C and corresponding in-plane heterojunctions grown at 650°C . Reprinted with permission from ref 843. Copyright 2014 Nature Materials. (b) Schematic of 2D superlattices based on monolayer TMDs and SEM images of three monolayer WS_2/WSe_2 superlattices. Reprinted with permission from ref 852. Copyright 2018 Science. (c) Schematic of a holey WS_2 structure featuring a periodic array of triangular holes (up) and the $\text{WS}_2\text{-WSe}_2$ monolayer mosaic heterostructures produced on the holey WS_2 templates (down). Reprinted with permission from ref 854. Copyright 2022 Nature Nanotechnology. (d) Schematic illustration of the fabrication process of roll-up vdW superlattices. Reprinted with permission from ref 380. Copyright 2021 Nature. (e) Schematics (left) and bright-field STEM images (right) with the corresponding atomic model simulations for coherent SL stacks. Reprinted with permission from ref 861. Copyright 2021 Nature Nanotechnology. (f) Optical image of wafer-scale multiblock vdW superconductor heterostructure films for a five-block heterostructure consisting of WS_2 , MoS_2 , MoSe_2 , NbSe_2 , and PtTe_2 (from bottom to top) grown on sapphire. Reprinted with permission from ref 452. Copyright 2023 Nature.

electrode-induced healing, and modulating precursor ratio have been carried out to obtain TMDs with ultralow defect density.^{824–827} Reducing the line-defects by epitaxial techniques were systematically discussed in the previous chapter. In addition, studies have shown that chalcogen atom vacancies in TMDs at contact regions can significantly reduce contact resistance and improve device performance.^{814,828} Xiao et al. reported the defect engineering to achieve ohmic contact (as low as $1.7\text{ k}\Omega\cdot\mu\text{m}$) between the metal and CVD monolayer of MoS_2 with a large number of sulfur vacancies introduced by mild Ar plasma treatment (Figure 22c,d).⁸²⁹ The prepared monolayer MoS_2 FETs behaved ultrahigh carrier mobility of $153\text{ cm}^2\text{ V}^{-1}\text{ s}^{-1}$ and large on/off ratio of 4×10^9 .

The defective sites of TMDs usually have high reactivity, which can adsorb and activate reaction substances and promote the catalytic reaction. In 2015, Deng et al. demonstrated for the first time that single-atomic Pt metal doping in HER can increase the catalytic activity of MoS_2 .⁸³⁰ Single-atomic doping including elements like Ru, Co, Au, Pd, and so on, has also demonstrated improved catalytic activity within TMDs.^{831–834} In 2015, Li et al. reported optimizing HER performance by introducing S vacancies and strain in monolayer MoS_2 .⁸³⁵ Theoretical and experimental results show that the S vacancy serves as a catalytic site, and the gap states around the Fermi level allow hydrogen to directly bind with exposed Mo atoms and improves the catalytic activity. In recent years, improving the catalytic activity of TMDs by grain boundary engineering has attracted widespread attention.^{815,836–838} For example, He et al. fabricated wafer-scale nanograin TMD films by Au quantum dot assisted CVD, with ultrahigh grain boundary densities up to $\sim 10^{12}\text{ cm}^{-2}$ (Figure 22e,f).⁸³⁹ The excellent catalytic properties were examined by

microelectrochemical measurements, characterized by onset potentials of -25 mV and Tafel slopes of 54 mV dec^{-1} , further demonstrating the high activation of the grain boundaries in TMDs.

Moreover, defect engineering based on TMDs also shows great promise in fields such as magnetism, piezoelectricity, and nonvolatile resistive switching.^{819,840,841} From the aspect of material synthesis, achieving accurate location and density (from ultralow to ultrahigh) control of TMDs still remains a challenge. This also requires high-throughput and high-resolution characterization techniques to ensure the precise density and configuration of defects. Overall, defect engineering is a powerful tool that expected to modulate the performance of TMD materials and provide new designing freedom in multiple fields such as electronics, catalysis, and energy conversion.

5.5. Heteroepitaxial Growth

Flexible assembly of two or more different semiconductors produces artificial heterostructures, a fundamental archetype in solid-state physics, enlightening applications in LED, solar cells, and semiconductor lasers. Atomically-thin TMDs without interlayer dangling bonds serve as ideal “nanoLogo” building blocks to form desired heterostructures taking no account of lattice mismatching. In practice, proof-of-concept TMD heterostructures could be fabricated layer-by-layer restacking using a micromanipulator. However, the low throughput and unavoidable interfacial imperfections (such as bubbles and adsorbed hydrocarbons) block further exploration and application of these artificial structures. In this regard, bottom-up epitaxial synthesis acts as a clean and scalable method for producing TMD heterostructures, avoiding exposure to external contaminations and size limitations

during the transfer process, thereby facilitating the reliable production of heterostructure devices. Besides the vertical (out-of-plane) structures, seamless stitching of TMDs constructs the atomic lateral (in-plane) TMD heterostructures—the ultimate-thickness heterojunctions that are not achievable by transfer technique. The main challenge of heteroepitaxy lies in the controllable switching of metal or chalcogen sources. Therefore, vapor-based techniques (CVD or MOCVD) with flexibly modulated precursors have developed as the most common method to access high-quality heterostructures. In this section, we mainly focus on the vapor-based synthesis for large-scale TMD heterostructures, including lateral/vertical species and corresponding superlattices.

Inspired by the access of pure monolayer TMDs via vapor deposition, in 2014, three independent groups reported the direct synthesis of both vertical and lateral TMD heterostructures. Huang et al. employed the PVD strategy with a combination of WSe_2 and MoSe_2 powder as sources, and successfully obtained the monolayer $\text{WSe}_2/\text{MoSe}_2$ lateral heterostructure.⁸⁴² Gong et al. demonstrated a one-step CVD approach to selectively produce vertically stacked or lateral heterostructures of WS_2/MoS_2 by controlling the growth temperature.⁸⁴³ At high growth temperatures (850 °C), the WS_2 epitaxially grew over MoS_2 monolayers and formed vertically heterostructure bilayers with a preferred stacking order. Besides, the low-temperature growth process (650 °C) resulted in lateral epitaxy of WS_2 at MoS_2 edges, forming seamless in-plane heterostructures with the atomically sharp interface (Figure 23a). The underlying mechanism of this selective growth behavior was further explored later by the nucleation kinetics model.⁸⁴⁴ Duan et al. reported a precise design enabling in situ switching of vapor-phase precursors, facilitating lateral epitaxial growth of single- or few-layer TMD lateral heterostructures (including WS_2/WSe_2 and $\text{MoS}_2/\text{MoSe}_2$).⁸⁴⁵ These advancements demonstrated the flexibility and efficiency of constructing large-scale TMD lateral/vertical heterostructures via vapor-based growth techniques, which also underscore the importance of precise control of precursors over source versatility and timing.

As for the controlled synthesis of lateral TMD heterostructures, the aforementioned one-step strategy leads to a clean heterointerface and is relatively limited in versatility due to the unavoidable alloying during the high-temperature process.^{846,847} In this regard, the two-step synthesis of lateral TMD heterostructures serves as the complementary design. For instance, Li et al. fabricated $\text{WSe}_2/\text{MoS}_2$ lateral heterostructures by following the epitaxial growth of MoS_2 along the edges and on the top surface of as-synthesized WSe_2 . The interfacial alloying was prevented by precisely controlling the relative vapor amounts of MoO_3 and sulfur during the subsequent MoS_2 growth.⁸⁴⁸ Moreover, lateral heterostructures such as MoS_2/WS_2 , $\text{WSe}_2/\text{MoSe}_2$, WS_2/WSe_2 , $\text{MoS}_2/\text{MoSe}_2$, and WS_2/ReS_2 can also be obtained based on similar processes.^{844,849–851}

Furthermore, the direct fabrication of more complex lateral heterostructures/superlattices is the ultimate goal in lateral epitaxy. Significant efforts have been dedicated to precisely tuning various precursors during synthesis toward desired superlattices. In 2018, Xie et al. synthesized lateral WS_2/WSe_2 superlattices using a modulated MOCVD process (Figure 23b). This setup possesses two distinctive features: first, it enables individual and precise control over the concentration of each precursor, facilitating direct tuning of the supercell

dimensions. Second, it allows for the rapid switching of TMD composition, such as from WS_2 to WSe_2 and vice versa, with the width of each component determined by controlling the timing of the switch.⁸⁵² During the sequential growth process, the main challenge lies in managing excessive thermal degradation or uncontrolled nucleation during temperature fluctuations between growth steps, which limits the reliable formation of monolayer heterostructures. Zhang et al. developed the step-by-step CVD process by introducing a reverse flow during the sequential vapor deposition growth process. This innovation facilitated the cooling of existing 2D crystals and effectively prevented undesired thermal degradation and uncontrolled homogeneous nucleation.³⁸⁹ Furthermore, Sahoo et al. achieved controlled growth of lateral TMD heterostructures simply by altering the carrier gas. Specifically, they found that a combination of N_2 and H_2O facilitated the growth of MoX_2 , while Ar and H_2 halted the growth of MoX_2 and instead promoted the growth of WX_2 .⁸⁵³ A similar setup can also be utilized to prepare heterophase structures such as $2\text{H-1T}'\text{WS}_2\text{-ReS}_2$.⁸⁵¹

In addition to the step-by-step vapor-phase methods discussed above, a thermal etching process is introduced to create precise heterostructure arrays on as-prepared TMD films. In 2022, Zhang et al. introduced an ingenious synthetic strategy for producing mosaic heterostructure arrays in monolayer 2D atomic crystals. This method involves creating periodic triangular hole arrays in 2D crystals with precisely controlled sizes and atomically clean edges through laser patterning and an anisotropic thermal etching process. These arrays then serve as templates for the endoepitaxial growth of another 2D crystal, resulting in monolayer mosaic heterostructures with atomically sharp heterojunction interfaces (Figure 23c). They further improved the thermal etching process by combining it with laser irradiation, resulting in more controllable etched hole arrays on 2D-TMDs with clear atomic terminations and atomic sharp edges.⁸⁵⁴ These methods can be extensively applied to the synthesis of various TMD heterostructures, including WS_2/WSe_2 , WS_2/MoS_2 , and $\text{WSe}_2/\text{MoS}_2$, thereby aiding in the establishment of a customizable material platform for 2D heterostructures.⁸⁵⁵

The layer-by-layer synthesis of vertical TMD heterostructures follows the growth behavior introduced in the vdW epitaxy introduced in Section 4.2.1. The precise control over their epitaxial registry, layer number, and stacking order have been systematically explored, enabling the fabrication of diverse vertical heterostructures such as $\text{NbS}_2/\text{MoS}_2$, $\text{NbSe}_2/\text{WSe}_2$, CdI_2/WS_2 , $\text{CdI}_2/\text{WSe}_2$, $\text{CdI}_2/\text{MoS}_2$, PbI_2/WS_2 , $\text{PbI}_2/\text{WSe}_2$, and $\text{PbI}_2/\text{MoS}_2$.^{58,856–860} In 2022, Wu et al. employed a CVD approach to fabricate bilayer WSe_2 transistors with synthetic VSe_2 vdW contacts by inducing controlled crack formation. Width-controllable nanogaps emerged between the connected VSe_2 domains during the cooling process, enabling the fabrication of transistors with atomically clean interfaces and minimal damage to the underlying WSe_2 .⁶⁴⁹ Zhao et al. introduced a novel capillary-force-driven rolling-up process that could effectively delaminate synthesized $\text{SnS}_2/\text{WSe}_2$ vdW heterostructures from the growth substrate. This process resulted in the formation of $\text{SnS}_2/\text{WSe}_2$ roll-ups with alternating monolayers of WSe_2 and SnS_2 , thereby creating high-order $\text{SnS}_2/\text{WSe}_2$ vdW superlattices (Figure 23d). This rolling-up strategy can be extended to create diverse 2D/2D vdW superlattices and complex three-component 2D/2D/2D

vdW superlattices ($\text{SnS}_2/\text{MoS}_2/\text{WS}_2$), as well as structures beyond 2D materials, including 3D or 1D materials.³⁸⁰

The direct synthesis of complex vertical heterostructures or superlattices requires a more precise modulation of precursor feeding, nucleation position, and deposition sequence. In 2021, Jin et al. utilized kinetics-controlled vdW epitaxy near the equilibrium limit via MOCVD to achieve precise layer-by-layer stacking growth.⁸⁶¹ In this method, TMD monolayers exhibiting preferred in-plane crystal orientations are initially epitaxially grown and transferred onto SiO_2/Si substrates to serve as templates. Subsequently, TMD superlattices with programmable stacking periodicities can be controllably synthesized by fine-tuning the feeding circles of metal–organic precursors. The heteroepitaxial vertical superlattices comprised more than two types of different TMD monolayers, such as MoS_2 , WS_2 , and WSe_2 , and were free of interlayer atomic mixing (Figure 23e). Li et al. selectively patterned nucleation sites on monolayer or bilayer semiconducting TMD, allowing for precise control over the nucleation and growth of various metallic TMD with designable periodic arrangements and tunable lateral dimensions at predetermined spatial locations. This process resulted in the fabrication of a series of vdW heterostructure arrays, including $\text{VSe}_2/\text{WSe}_2$, $\text{NiTe}_2/\text{WSe}_2$, $\text{CoTe}_2/\text{WSe}_2$, $\text{NbTe}_2/\text{WSe}_2$, VS_2/WSe_2 , $\text{VSe}_2/\text{MoS}_2$, and VSe_2/WS_2 .³⁹⁹

Complementary to the layer-by-layer heteroepitaxial growth, the two-step chalcogenization of deposited metals facilitates the fabrication of large-area vertical heterostructures with diverse TMDs.⁸⁴⁶ Recently, Zhou et al. introduced a multicycle vapor-deposition process employing a high-to-low temperature strategy for growing wafer-scale vertical TMD superconductor heterostructures.⁴⁵² The diverse TMD blocks were grown by chalcogenization of corresponding sputtered metal films with controlled thickness. During the stacking process, the material with the highest growth temperature typically serves as the bottom layer, with other TMD layers sequentially grown based on chalcogenization temperature from high to low. As shown in Figure 23f, this general strategy enabled the flexible fabrication of inch-sized multiblock TMD heterostructures, which feature a scalable pathway for constructing complex vertical heterostructure arrays.

In summary, the heteroepitaxial growth of TMDs demonstrates excellent freedom in synthesizing artificial structures with vdW materials as “nanoLogos”. Most developed methodologies and growth mechanisms including both lateral edge-epitaxy and vertical vdW-epitaxy are based on the concepts in fabricating pure TMDs. Specifically, there are still several challenges that require to be addressed. (i) Most synthetic strategies involve prolonged or multicycle high-temperature processes for the sequential fabrication of TMD blocks, which may lead to decomposition, etching, or alloying of the as-grown 2D layers. (ii) The heterostructure scalability including their thickness, stacking order, twist angle, and material universality should be further improved to satisfy customized demands. (iii) From aspects of high-end electronics and optoelectronics, efficient production of wafer-scale single-crystalline TMD heterostructures still serves as a critical topic in this field.

6. POSTPROCESSING OF LARGE-AREA TMDs

As previously discussed, significant advancements have been achieved in the large-area epitaxial growth and property tailoring of TMDs. On this basis, postprocessing techniques

aimed at future industrialization have emerged as a key research focus at the current technological stage. As an emerging channel material, TMDs necessitate techniques for high-throughput and precise quality characterization. On the other hand, hybrid integration with well-developed silicon circuits will be a key node for the industrialization of TMD materials. In this section, we will mainly focus on the developments in characterization techniques for TMDs, followed by a systematic review of the large-area transfer techniques and advanced patterning strategies. These studies are essential for optimizing material fabrication and establishing unified technological standards, and will further boost the compatibility of 2D TMDs with well-developed silicon industry.

6.1. Quality Characterization

Comprehensively evaluating the synthesized TMD materials helps to establish a standard grading system like traditional semiconductors with different levels, which is essential for finding their specific application scenarios. For example, the electronic-grade wafer-scale TMDs with ultralow defect density hold the potential in fabricating high-end integrated circuits. Meanwhile, TMD films with high-density point defects or grain boundaries are more suitable for catalytic applications due to the increased active sites. Therefore, reliably characterizing the quality of the as-prepared TMD material acts as a key “bridge” that connects the material synthesis and related applications. Benefiting from pivotal advancements in both scientific instruments (e.g., electron microscopes, scanning probe microscopes, and X-ray diffractometers) and intrinsic physical mechanisms (e.g., exciton physics and nonlinear optics in TMDs), diverse characterization methods have been proposed and applied in publications of TMDs from material synthesis, high-performance devices, and new physics explorations. In this section, we provide a brief overview of the key evaluation criteria for large-area TMD materials. And then introduce some detailed characterization techniques for both 0D and 1D defects in TMDs. In particular, we will further discuss characterizing the single crystallinity of large-area epitaxial TMD films.

6.1.1. Determinants of Quality. Different generations of semiconductor materials have varied standards for evaluating their crystal quality based on their elemental composition, preparation method, and technical maturity. For instance, the single-element silicon materials typically sliced from single-crystal ingots exhibiting ultralow impurity densities of $\sim 10^{-11}$. III–V gallium nitride films epitaxially grown by MOCVD primarily contain dislocation defects ranging from 10^4 – 10^6 cm^{-2} . For the large-area 2D TMD, the key points in evaluating their intrinsic crystal quality are concluded as follows:

- (i) Defect density: The vapor-deposited TMDs always possess high-density point defects, typically in the range of 10^{12} to above 10^{13} cm^{-2} , and the sulfur vacancies are dominant in the CVD and mechanical exfoliated samples. This value is orders greater than that in 2D elemental graphene.⁸²³ These defects can significantly impact the optical and electrical performance of monolayer TMDs that act as centers for strong carriers scattering and nonradiative recombination.^{862,863}

As discussed in previous sections, to date, the point defect density of the vapor-deposited TMD monolayers could be suppressed in the order of 10^{12} cm^{-2} by optimizing the precursors and growth parameters. Liu et

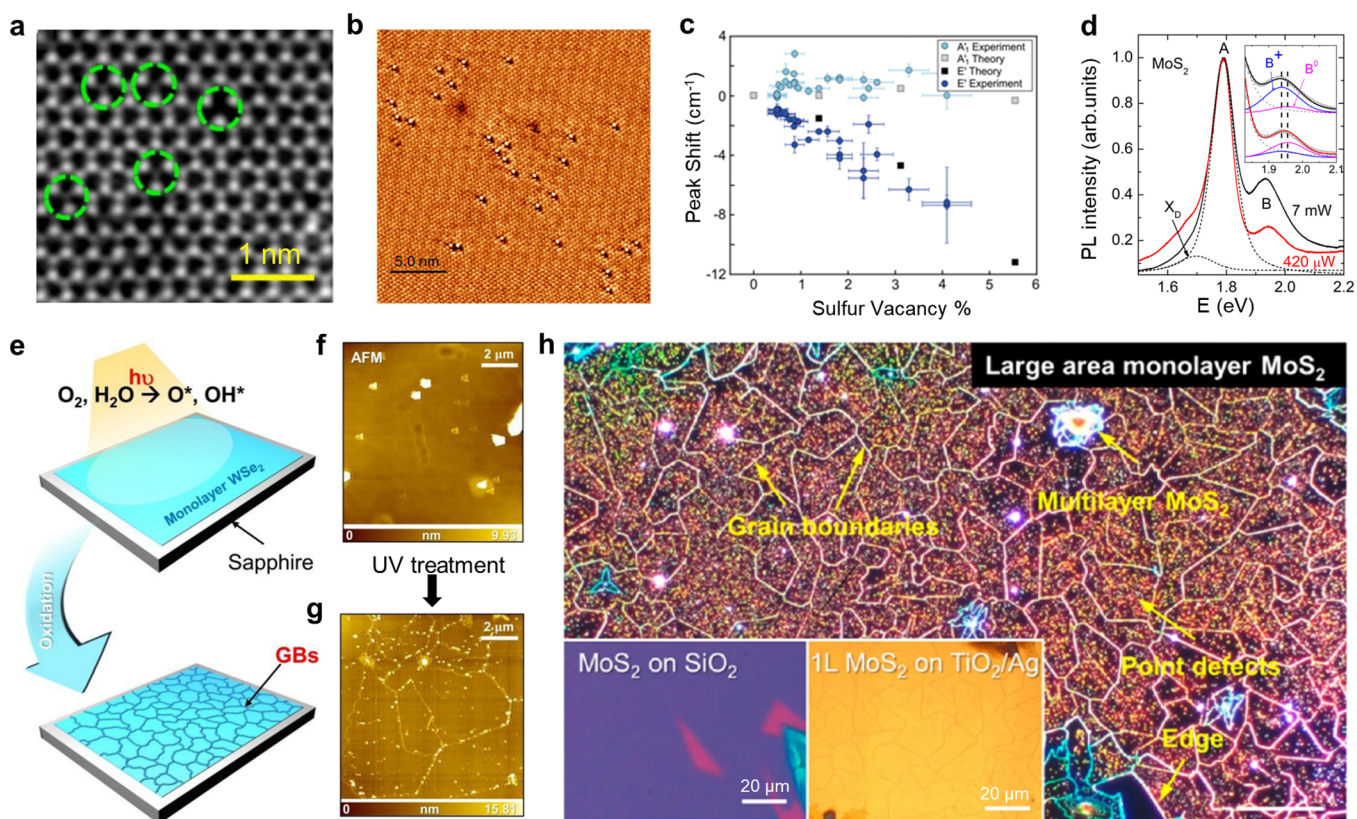


Figure 24. Characterizations of the defect distribution in large-area TMDs. (a) STEM characterization of V_S and V_{Se} vacancies in monolayer MoS_2 . Reprinted with permission from ref 817. Copyright 2015 Springer Nature. (b) Atomic resolution STM image of oxidized monolayer MoS_2 . Reprinted with permission from ref 762. Copyright 2018 Springer Nature. (c) Experimental and theoretical Raman peak shifts versus sulfur vacancies in MoS_2 . Reprinted with permission from ref 872. Copyright 2016 American Chemical Society. (d) Normalized room temperature PL spectra of MoS_2 monolayer measured at different laser powers. Reprinted with permission from ref 875. Copyright 2018 Wiley-VCH Verlag GmbH & Co. KGaA, Weinheim. (e–g) Schematic for the visualization of grain boundaries by UV treatment. (e–g) Reprinted with permission from ref 878. Copyright 2014 American Chemical Society. (h) Visualization of the defects in CVD-grown MoS_2 by dark-field optical images, including grain boundaries, point defects, and edges. Reprinted with permission from ref 879. Copyright 2015 American Chemical Society.

al. demonstrated a two-step flux method to fabricate ultrapure WSe_2 bulk crystals with $\sim 10^9 \text{ cm}^{-2}$ for charged defects and $\sim 10^{11} \text{ cm}^{-2}$ for isovalent defects.⁸²⁷ The exfoliated monolayer exhibited ultrahigh room-temperature hole mobility above $840 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$. These results indicate it is still a valuable synthetic topic in pursuing the direct synthesis of an ideal large-area TMD monolayer.

- (ii) **Single crystallinity:** Stitching of TMD domains with random orientations forms 1D grain boundaries in large-area films. The FETs with interdomain channels show much degeneration in carrier mobility compared with intradomain devices. And the interdomain mobility varied with the misorientation angles nonlinearly.⁸²³ Therefore, the single-crystal TMD film is desired to ensure consistent electronic properties and minimize device-to-device variations. Grain boundaries should be efficiently avoided to guarantee the repeatability and reliability of the integrated device arrays. Numerous epitaxial growth strategies have been developed to address these line defects and to date, the wafer-scale single crystal TMDs are accessible toward high-performance electronics.
- (iii) **Uniformity:** The concept of uniformity in large-area TMDs includes lots of factors such as defect density, coverage rate, multilayer nucleations, growth-induced

strain, adsorption of hydrocarbons, and so on. The spatial distribution of these intrinsic or extrinsic imperfections is always nonuniform in experiments. For instance, the varied precursor concentrations across inch-sized substrates result in different coverage rates and defect densities at different regions. The uniformity serves as an important standard in evaluating the applicational capabilities of large-area TMD films. However, this parameter is sometimes ignored in publications and leads to an overstate of the material quality.

In summary, accurately evaluating the quality of a piece of as-synthesized large-area TMDs should take multiple aforementioned structural parameters into account. Certainly, these results are also influenced by synthetic strategies, growth parameters, characterization methods, and other factors. In the future, more detailed technological standards and characterization processes are required to be unified collaboratively by the research and industrial community.

6.1.2. Defects Distribution. Precise defect information on TMDs including the locations, densities, and atomic configurations is the key parameter of the quality of TMDs, which could further guide the optimization of the material growth and device fabrication process. In general, researchers should find the appropriate defect characterization techniques by balancing the resolution, efficiency, cost, and damage to

samples. Here we mainly introduce several frequently used characterization techniques including electron microscopes, scanning probe microscopes, spectral measurement, electrical measurement, and direct visualization.

The development of aberration correction technology has further improved the spatial resolution of transmission electron microscopy (TEM), enabling the atomic-scale imaging of TMD materials.⁸⁶⁴ To date, high-resolution transmission electron microscopy (HRTEM) and STEM serve as the routine methods used to characterize the crystal structure of TMDs at the microscopic scale. HRTEM is a phase contrast-based imaging technique that can directly observe the atomic configuration of a sample and clearly distinguish defects by comparing the intensity distribution in the image. HRTEM techniques typically provide lattice images rather than actual atomic images. In contrast, STEM techniques can provide images of atoms whose intensity is proportional to the atomic number (Z-contrast), and atoms can be distinguished by brightness (Figure 24a).⁸¹⁷ For example, the contrast of point defects (such as vacancies) is significantly different from the intrinsic atomic columns, while dislocations can cause distortions in atomic arrangements, presenting irregular contrast patterns. Both approaches can provide microscopic information about a sample at atomic spatial resolution, including layered structures, lattice defects, grain boundaries, and electronic structures. In addition, samples need to be transferred to specific microgrids before characterization, which is a complex process that is not compatible with large-area characterization.

Scanning tunneling microscopy (STM) is also a significant method for high-resolution defect characterization.⁸⁶⁵ When characterizing oxygen atoms on the surface of TMDs, STEM technology faces challenges due to the low contrast and variability of oxygen atoms. In contrast, STM measurements can reveal the structure of these oxygen defects thanks to their atomic resolution and low-energy tunneling electrons (Figure 24b).⁷⁶² At the same time, STM has the advantage of revealing electronic properties affected by point defects. However, STM is limited by the sample environment and is not suitable for samples directly grown on an insulating substrate. Moreover, for defect detection, STM technology can only handle weakly adsorbed atoms (~ 1 eV).⁸⁶⁶ Detecting mobile defects, doping, and their corresponding structural evolution requires much higher energies (~ 10 eV), presenting a challenge for STM technology.⁸⁶⁷

The comprehensive characterization of large-area TMDs often employs fast optical spectroscopic techniques such as Raman, PL, and SHG. These methods facilitate nondestructive material characterization and do not depend on substrate species. Raman spectroscopy, for instance, features molecular vibrations and lattice modes by analyzing the frequency shifts of scattered light in the sample. This technique offers a unique advantage in structurally characterizing materials, as factors like layer number, doping, alloy composition, and stress-induced effects are all manifest within the Raman scattering (peak positions, intensities, and peak widths).^{648,695,868–871}

Defects, in particular, can induce alterations in lattice vibrations, resulting in shifts or the appearance of characteristic peaks in the Raman spectra. Taking MoS₂ as an example, both experimental and theoretical investigations demonstrate that the typical in-plane vibration mode E_{2g} (~ 384 cm⁻¹) and out-of-plane vibration mode A_{1g} (~ 405 cm⁻¹) shift with increasing sulfur vacancy concentration (Figure 24c), and the difference

between these two peaks exhibits a linear correlation.⁸⁷² Moreover, Mignuzzi et al. have explored Mn⁺ ion bombardment induced new Raman scattering peaks resulting from Mn⁺ ion bombardment in monolayer MoS₂ flakes.⁸⁷³ The Raman spectra of MoS₂ with different line defect densities show that as line defect density increases (indicating increased defect density), the E_{2g} peak shifts to lower wavenumbers, while the A_{1g} peak shifts to higher wavenumbers. DFT calculations suggest that these shifts are attributed to phonon localization. Moreover, the new Raman peak appears at about 227 cm⁻¹, and its strength is proportional to the defect density.

Furthermore, defects in monolayer TMDs with direct band gaps can be detected using PL spectroscopy. PL spectra typically encompass fluorescence peaks arising from free carriers and excitons.⁸⁷⁴ Excitons are bound states of electrons and holes, and their formation and recombination are influenced by material defects. Certain defects can provide trap levels, capturing free carriers and forming excitons. For electronic states, the appearance of defects brings about defect states between the conduction and valence band, and causes PL peak position deviation and intensity attenuation. Hence, by analyzing the intensity and position of excitonic peaks in PL spectra, information about relevant defects within the material can be inferred. For example, typical room-temperature PL spectra of MoS₂ exhibit distinct A and B excitonic bands at around 1.79 and 1.95 eV, respectively (Figure 24d).⁸⁷⁵ Additionally, a weak X_D peak can be observed at 1.69 eV, which is associated with defect-bound excitons. In higher-quality samples, the defect-related X_D peak may not be observable at room temperature. To attain more precise characterization of sample quality, techniques such as BN encapsulation and low-temperature testing are often employed.^{876,877} These methods effectively reduce the spectral broadening caused by phonons and the influence of the substrate. However, these strategies can sometimes increase the complexity of defect analysis. Moreover, PL mapping is an approach to detect the presence of defects, which can identify the grain boundary and show differences in quantum yield, peak location, and peak width of PL.⁸⁷⁸ However, the PL spectrum itself has drawbacks, which are susceptible to other factors such as strain, electron doping, and substrate. In addition, PL spectroscopy is not effective for nonluminescent metal materials and semiconductors.

With the continuous expansion of the production scale of TMD materials, the need for high-throughput characterization methods is becoming increasingly urgent. Currently, for the comprehensive characterization of large-area 2D TMDs, two strategies have been prominently employed. One approach involves defect visualization techniques. It is challenging to recognize ambiguous grain boundaries due to their weak optical contrast. By selective etching and controlled adsorption, the optical contrast of defects can be greatly improved, thus realizing defect visualization of large-area TMD.^{879–881} These methods have the advantages of convenience and fast defect imaging in a large range. For instance, Ly et al. introduced a method utilizing ultraviolet irradiation and selective oxidation to characterize defects (grain boundaries) on large-area monolayer WSe₂ (Figure 24e).⁸⁷⁸ Atomic force microscopy (AFM) was utilized to contrast the distribution of grain boundaries before and after ultraviolet exposure (Figures 24f, g), revealing distinct grain boundaries. This grain boundary visualization method can also be achieved through wet-etching techniques using water, H₂O₂

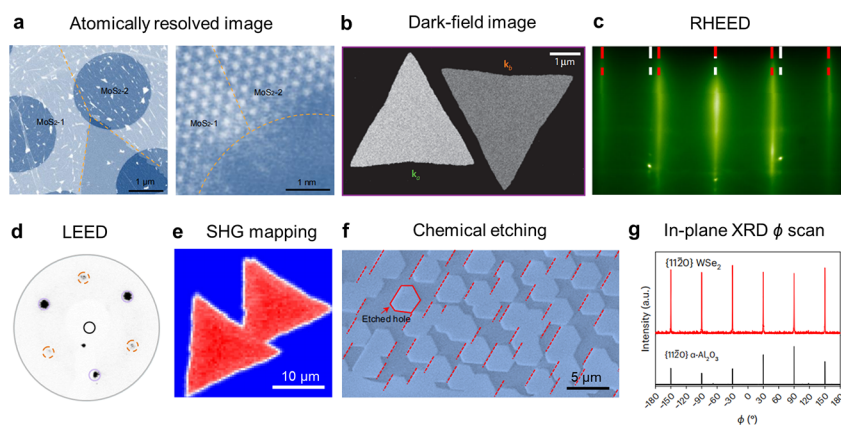


Figure 25. Characterizations of the single crystallinity in large-area TMDs (a) STEM image of the stitching position of two MoS₂ crystal domains. Reprinted with permission from ref 627. Copyright 2023 Springer Nature. (b) Dark-field image of MoS₂ crystals as the triangles are rotated 180° from one another. Reprinted with permission from ref 357. Copyright 2013 Springer Nature. (c) RHEED pattern of the MoS₂/sapphire along the Al₂O₃ ⟨10 $\bar{1}$ 0⟩ direction. Reprinted with permission from ref 34. Copyright 2021 Springer Nature. (d) Typical LEED pattern for the single-crystalline monolayer WS₂ film. Reprinted with permission from ref 35. Copyright 2021 Springer Nature. (e) Polarized SHG mapping of two unidirectional MoS₂ domains. Reprinted with permission from ref 34. Copyright 2021 Springer Nature. (f) False color SEM image of single-crystalline WS₂ film after O₂ etching. Reprinted with permission from ref 35. Copyright 2021 Springer Nature. (g) In-plane XRD azimuthal angle (ϕ) scans of planes of WSe₂ and α -Al₂O₃ confirming the 6-fold [11 $\bar{2}$ 0] WSe₂(0001)//[11 $\bar{2}$ 0] α -Al₂O₃(0001) epitaxial relationship. Reprinted with permission from ref 629. Copyright 2023 Springer Nature.

solution, and calcium hypochlorite solutions.^{880–882} Additionally, surface adsorption serves as another means of defect visualization. Jeong et al. directed Ag nanoparticles generated from annealed TiO₂/Ag thin films to aggregate at defect sites on TMDs under white light irradiation, effectively anchoring them to those positions, thereby visualizing large-area MoS₂ defects (Figures 24h).⁸⁷⁹ Notably, while most etching techniques can merely identify the position of grain boundaries, surface adsorption allows precise anchoring of point defects. However, both adsorption and etching will damage TMD films in different degrees. Another strategy involves the utilization of extensive electrical performance statistics. This requires fabricating a large number of devices and subjecting them to electrical testing, thereby obtaining statistical data to assess overall material performance and defect status. For instance, Liu et al. calculated mobility data for 150 bilayer MoS₂ film FETs.⁶²⁶ The results indicated an average mobility of 107.0 ± 7.8 cm²/V·s, with the optimum mobility being 122.6 cm²/V·s, and a mobility variation of 7.3% achieved through Gaussian fitting. These outcomes underscored the high quality and uniformity of MoS₂ films.

In-depth investigation of defects provides a unique opportunity to unveil the properties of materials, facilitating the design and optimization of materials to meet the diverse requirements of various applications. However, the diversity of defect types and the nanoscale nature of these materials pose challenges to accurate defect quantification. Moreover, with the gradual expansion of the production scale of TMD materials, there are technical obstacles to achieving high-throughput defect characterizations.⁸⁸³

6.1.3. Single Crystallinity. Driving by the great demands of wafer-scale TMD single crystals to eliminate the influence from grain boundaries, substantial progress has been achieved in the production of single-crystal TMDs, such as wafer-scale single-crystal MoS₂, WS₂, MoSe₂, and so on. However, the comprehensive examination of the single crystallinity across the inch-sized TMD films is still challenging. In this section, we will provide a detailed discussion of the methods associated with characterizing single-crystallinity of TMDs.

Similar to the previous section on point defect characterization, atomic-resolution techniques including TEM and STEM are also employed as the most powerful tools to characterize the single-crystallinity in TMDs. When two unidirectional TMD domains are stitched seamlessly, they appear as an ordered and consistent arrangement of atoms in STEM (Figure 25a).⁶²⁷ Besides, dark-field TEM producing by selecting the scattered electrons was first utilized by van der Zande et al. to identify the single crystallinity of monolayer MoS₂.³⁵⁷ Unlike the 6-fold symmetric graphene, the monolayer MoS₂ lattice is divided into molybdenum sublattices and sulfur sublattices, resulting in a 3-fold symmetric selected area electron diffraction (SAED) pattern. The six [1100] diffraction points are divided into two families, k_a and $k_b = -k_a$. The experimental and simulated results indicate that the k_a spots are ~10% higher in intensity for an 80 kV electron beam, which points toward the molybdenum sublattice. Therefore, this asymmetry in diffraction intensity enables the characterization of TMD domain orientations using dark-field images formed by positing an aperture at specific diffraction spots (Figure 25b). Similarly, dark-field low-energy electron microscopy (DF-LEEM) can also verify the unidirectional arrangement between crystal domains.⁵⁹⁰ Although high-resolution electron microscopes could give an atomic insight into single-crystallinity and corresponding growth mechanism, their limited characterizing efficiency and complex sample preparation hinder comprehensively evaluating large-area TMD films.

Low-energy electron diffraction (LEED) serves as a critical technique for analyzing the single-crystal characteristics of 2D materials. Due to the low energy of the electron beam, the incident electrons can only enter the depth of a few atomic layers on the surface, so the obtained information is the crystal surface structure. It is employed to characterize the periodic structure of the sample surface over a large area, and is an effective method to study the atomic arrangement of the surface layer of the single crystal. Compared with the real image obtained by TEM, the data obtained by LEED is the result of computational transformation. The electron beam

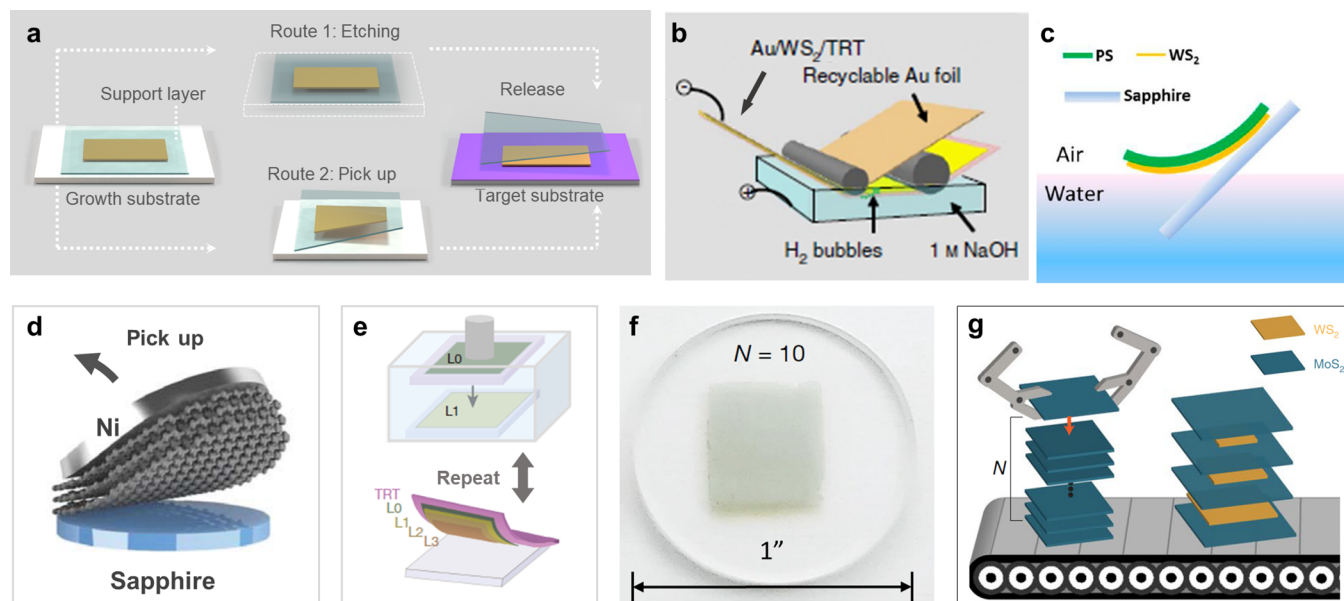


Figure 26. Transfer techniques of large-area TMDs. (a) Schematic of techniques for transfer techniques of TMDs. (b) Schematic of the roll-to-roll/bubbling process. Reprinted with permission from ref 417. Copyright 2015 Springer Nature. (c) Schematic of the water-assisted direct pick-up transfer. Reprinted with permission from ref 916. Copyright 2015 American Chemical Society. (d) Schematic of the metal-assisted direct pick-up transfer. Reprinted with permission from ref 920. Copyright 2018 AAAS. (e) Schematic of the vdW force assisted direct pick-up transfer. Reprinted with permission from ref 925. Copyright 2017 Springer Nature. (f) Photograph of large-area MoS₂ films transferred onto 1-in. wafer-scale fused silica substrates. Reprinted with permission from ref 926. Copyright 2021 Springer Nature. (g) Schematic of automated transfer by a robotic instrument. Reprinted with permission from ref 927. Copyright 2022 Springer Nature.

utilized in LEED can cover an area of up to 1 mm², demanding high uniformity of the sample over extensive areas.^{596,601} The principle of diffraction dictates that the LEED pattern should represent the reciprocal lattice of the sample's 2D surface lattice. For most TMD materials with a hexagonal lattice on the surface, the reciprocal lattice remains a hexagonal lattice. However, due to symmetry breaking, under certain electron energies, the LEED pattern will appear alternately between light and dark (Figure 25d).³⁵ This phenomenon is usually considered a characteristic of TMD materials with highly aligned orientation. However, LEED measurement can be challenging for samples on insulating substrates due to potential charge accumulation, often requiring additional steps to enhance sample conductivity.

Reflection high-energy electron diffraction (RHEED) is also a surface characterization technique that depends on electron diffraction.^{884,885} Unlike LEED (20–300 eV), the electron beam energy used in RHEED is usually higher (30–100 keV), and the high-energy electron beam is guided to the sample surface at a grazing angle. Due to the incident angle, the RHEED result obtained from a single-crystal sample is streaky patterns formed along a certain direction by the reciprocal lattice of the sample's 2D surface lattice (Figure 25c).³⁴ For instruments capable of rotating the sample, reciprocal lattice rods in more directions can be obtained, and the lattice information on the sample can be calculated through the streak spacing and instrument parameters. However, the high cost of the instrument, strict vacuum requirements, and possible electron beam damage to the sample are also significant disadvantages in the application of RHEED.

The sensitive optical spectroscopic strategies are in great demand to visualize the grain boundaries quickly and noninvasively.⁸⁸³ The PL intensity and peak position mappings could recognize the stitched twin grains attributed to the

defects and strains at the grain boundaries.⁸⁸⁶ Besides, inversion asymmetric monolayer TMDs with strong second-order nonlinear response enabled the probe of the crystal orientations with polarization-dependent SHG detection. The grain boundary region can also be clearly revealed by SHG mapping, where the SHG signals generated from the neighboring grains with different orientations are canceled.^{178,818,887} Experimental results demonstrated destructive SHG signals at the grain boundaries when there is a misoriented angle. On the contrary, the SHG signal shows consistent intensity across the domain and stitching region of two unidirectional TMD domains as shown in Figure 25e.³⁴ Furthermore, Karvonen et al. reported using multiphoton (SHG and THG) microscopy to detect grain boundaries between crystalline domains regardless of the degree of crystal axis rotation.⁸⁸⁸

Chemical etching is also a high-throughput method to examine the single crystallinity of TMDs over a large scale using an optical microscope. For example, when the TMD film is placed in an oxidative environment or thermal annealing for etching, the etched holes on the single-crystalline region have similar shapes and the same orientation (Figure 25f).^{35,854} Besides, as discussed above, the etching will first occur at the defective grain boundaries if there are any twist angles between different domains. Compared with other methods, these etching strategies are effective, low-cost, and operation-convenient for visualizing the single crystallinity of large-area TMD films. However, the etching effect is invasive to the crystal lattice, and the accuracy required to be further improved.

The X-ray diffraction (XRD) measurements also work as a nondestructive and rapid characterizing technique in analyzing the large-area crystalline orientation of TMDs and their epitaxial relationship with growth substrate. Due to the lack of

periodicity along the $\{000\}$ direction of the as-grown 2D TMDs, only $\{hki0\}$ planes could be studied by the in-plane XRD.⁸⁸⁹ In which the X-ray incidence plane (defined by the incident and diffracted wave vectors) should nearly coincide with the 2D basal plane. A typical characterization result is shown in Figure 25g, in which initial alignment is performed on the $\{11\bar{2}0\}$ planes of the c-sapphire substrate, then setting 2θ at $\{11\bar{2}0\}$ planes of 2D WSe₂ and azimuthal angle (ϕ) scan provided six sharp peaks.⁶²⁹ Which indicated the 6-fold $[11\bar{2}0]$ WSe₂// $[11\bar{2}0]$ α -Al₂O₃ (0001) epitaxial relationship, and full-width and half-maximum (fwhm) of the narrow ϕ -scan peaks demonstrated there were few twisted WSe₂ domains in-plane. Synchrotron grazing-incidence wide-angle X-ray scattering (GIWAXS) with a high-intensity beam is also utilized to study the epitaxial relationship of TMDs with low electron density substrates such as graphene/SiC.⁵⁵² Furthermore, X-ray photoelectron diffraction (XPD) could probe the orientation information on TMDs mirror domains due to different core-level photoemission intensities from the different atom layers.⁸⁹⁰

6.2. Transfer Techniques

The vdW integration enables damage-free integration of 2D TMDs, producing nearly ideal atomically smooth surfaces that enable the efficient interface control and multifunctional heterojunctions, thereby significantly enhancing the performance and integration density of electronic devices. The vdW integration via transfer techniques is a crucial step in advancing TMD materials from laboratory to industrial fabrication (from “lab” to “fab”), as it is compatible with various device types and complex surface morphologies. Essential in the gate-first process of TMD IC, transfer techniques effectively prevent the degradation of component formed during the front-end-of-line process in IC fabrication. This is because the preprepared electrode and gate dielectric cannot withstand the high temperature during the growth of TMDs, which can reach temperatures as high as 800 °C or higher. Transfer techniques help maintain a reasonable thermal budget for IC fabrication and ensure compatibility with existing industrial fabrication methods. Typically, the flat 2D TMDs without dangling bonds couple with the substrate via weak vdW force. Moreover, the unique mechanical properties of TMDs, including low surface energy (e.g., MoS₂, 35–48.3 mJ·m⁻²)^{891,892} and high Young’s modulus (e.g., MoS₂, 270 GPa),⁸⁹³ lend these materials the requisite stability and resilience throughout the transfer process. These characterizations enable the seamless dissociation and subsequent transfer of uniform, atomically thin films onto various substrates, granting TMDs an advantage over conventional non-vdW materials.

In this section, we mainly focus on the large-area transfer of the as-grown TMDs. Two primary transfer techniques have been developed: chemical etching transfer and direct pick-up transfer (Figure 26a). The former is typically employed when TMDs are grown on substrates with strong adhesion, like certain metals, necessitating chemical reactions to sever these interactions. Conversely, when the coupling between TMD and the substrate (such as sapphire or SiO₂/Si) is comparatively weak, a physical lift-off facilitates a direct pick-up by manipulating surface energy without resorting to chemical etching. These methods have successfully transferred a range of large-area TMD films, up to inch-scale dimensions, which have found applications in fundamental physical

property exploration,^{894,895} electronic devices^{896,897} and optoelectronic devices.^{898,899}

Nonetheless, the uniformity and quality of the transferred TMD films are of great importance in preserving their intrinsic properties. In practice, many transfer methods suffer from imperfections, which may arise due to several factors: (i) Wrinkles and cracks would be introduced because of thermal and mechanical perturbations during the transfer process, surface energy differences between the supporting layer and TMDs, capillary forces in the solution evaporation, and other processes. (ii) Bubbles at the interface are usually introduced because of trapped air pockets, residual water or reagents during the transfer process, which lead to poorer contact, proximity effects and varying stress effects on interlayer excitons. (iii) Polymer residues are unavoidable during the chemical transfer process, which reduce device conductivity. In response to these issues (wrinkles, cracks, bubbles, and polymer residues), concerted efforts are being made to enhance the standard transfer methodologies, with a focus on minimizing contamination and maintaining film integrity.

6.2.1. Chemical Etching Transfer. With the increase of applications demanding large-scale TMD films for devices such as integrated circuits, the development of scalable, non-destructive transfer techniques became necessary. Consequently, many methods initially devised for transferring graphene were adapted for TMD films. One of the most widely employed techniques is the polymer-assisted chemical etching method (Figure 26a).⁴⁹⁶ This transfer process involves several steps: (i) Polymer is initially uniformly spin-coated onto the TMD/growth substrate, serving as a supporting layer. (ii) The polymer/TMD/growth substrate assembly is then carefully floated on the surface of an etching solution, facilitating complete and clean chemical etching of the growth substrate. (iii) After thorough cleaning with deionized water, the polymer/TMD structure is transferred onto the target substrate. The polymer supporting layer is subsequently removed, either by dissolution in acetone or through annealing, ultimately yielding the TMD/target substrate configuration.

Scaling this process up to larger dimensions without compromising the TMD film’s structural integrity is crucial. The suitability of the support layer plays a crucial role in the transfer process. The PMMA with suitable flexibility, robustness, and compatible thermal expansion coefficient makes it a preferred choice for a supporting layer.^{900,901} However, its tendency to crack, wrinkle, or leave residues has driven researchers to explore alternatives.⁹⁰² In a recent development, Mondal et al. successfully demonstrated a residue-free transfer technique for CVD-grown TMD samples employing polypropylene carbonate (PPC) as the supporting layer instead of PMMA.⁹⁰³ The experimental results indicate that PPC leaves significantly less (almost negligible) chemical residue compared to PMMA and exhibits better adhesion to TMD. More polymers, such as PC,^{904,905} PVA,⁹⁰⁶ PLA,⁹⁰⁵ and others,^{902,907} are utilized to support the layers, effectively addressing the issues of chemical residue and folding during the transfer process.

The conventional method of chemical etching substrate transfer typically necessitates the use of harsh chemical corrosion agents, such as KOH, which inevitably leads to damage to the TMD materials. Furthermore, employing aggressive chemical reagents for etching the growth substrate renders it nonreusable, resulting in a relatively costly

production process and hindering its industrial application. Consequently, an alternative transfer technique known as bubble transfer has emerged for transferring CVD-grown TMD films on metal substrates.⁹⁰⁸ In contrast, the bubble transfer method employs an electrical current to generate bubbles between the substrate and TMD, weakening their adhesion and enabling separation without substrate etching. For instance, Yun et al. utilized the bubble method to successfully transfer cm-scale, CVD-grown WS₂ films from gold foil onto SiO₂/Si substrates for electrical studies.⁴⁹⁶ Gao et al. extended the bubble method to incorporate a roll-to-roll structure for the production of large-area flexible films (Figure 26b).⁴¹⁷ These films included homogeneous single and double layer WS₂, as well as WS₂/graphene heterostructures. The weak interaction between WS₂ and Au enables the mass production of large-area, flexible monolayer WS₂ thin film transistor arrays using the electrochemical bubble method. Moreover, seeking to avoid introducing unnecessary impurities due to chemical reactions, Ma et al. pioneered an ultrasonic bubbling technique in which microbubbles, are induced by ultrasound instead of electrochemical reaction.⁹⁰⁹ Notably, this method ensures a straightforward transfer process without the need for any detrimental etching agents or chemical reactions, but inevitably some cracks will be introduced.

Chemical etching transfer technologies, including chemical etching and bubble methods, offer easy operation, industrial compatibility, and the ability to transfer large areas, making them cater to the necessity for large-area films in high-end applications. Meanwhile, addressing the challenges of sample degradation and substrate damage remains critical, especially since chemical etching methods often involve potentially damaging chemical reagents and are prone to impurity contamination from polymer residues. Additionally, the use of volatile, toxic solvents like acetone for polymer layer removal requires special handling and disposal procedures. While the bubbling method mitigates the need for substrate etching, it introduces risks of rupture and folding in the TMD films during bubble generation. Future developments must focus on optimizing these processes to further minimize defects and impurities. Finding solutions that can achieve the balance of material quality, size, cost, and efficiency is vital and urgent, ensuring the broad scalability and integration of TMDs into next-generation electronic devices. At the same time, people are pursuing a complete dry transfer without chemical reagents to deal with these issues and realize this vision.

6.2.2. Direct Pick-up Transfer. To address the limitations associated with chemical etching, such as potential sample degradation and polymer contamination, the surface energy assisted direct pick-up transfer method has been adopted, offering a nondestructive alternative. In this transfer process, a supporting layer initially adheres to the TMD films, forming a stack of supporting layer/TMD/growth substrate. The transfer occurs when the adhesive force between the supportive layer and the TMD supersedes that between the TMD and its growth substrate, allowing the composite to be picked up and placed onto the target substrate. By contrast, if the TMD adheres more strongly to the target substrate, the supporting layer can be removed separately, leaving the TMD on the target substrate. Surface energy assisted direct pick-up methods facilitate ultraclean transfer without the need for chemical etching, dissolution reactions, and sometimes even liquid involvement in order to achieve complete dry transfer.

Initially, laboratories utilize polymers like PDMS to create stamps for supporting layers.^{894,895,910,911} By adjusting the polymer's surface energy through temperature manipulation, they could modulate the energy relationships among the stamps, TMDs, and substrate for successful TMD transfer. However, stamp-based transfer methods, similar to mechanical exfoliation, are limited by the size of the material being transferred. Therefore, researchers have developed various methods for surface energy adjustment via water, metal, and vdW forces to enable direct pick-up transfers.

Water serves as an efficient medium to control surface energy dynamics, simplifying the lifting of TMD films from substrates by modifying the surface energy balance.^{912–914} Introducing a water layer between a hydrophilic substrate and a hydrophobic supportive layer allows the transfer of the TMD/supportive layer stack.⁹¹⁵ Upon water evaporation, the TMD adheres to the target substrate, facilitating the supportive layer's removal through thermal adjustment. For instance, Xu et al. demonstrated a polystyrene (PS) supporting layer-based transfer process using water-assisted transfer. They leveraged capillary forces in water to alter the surface energy relationship between TMDs and the growth substrate, facilitating their transfer to the target substrate (Figure 26c).⁹¹⁶ Using water, inch-scale TMD films can be transferred losslessly to flexible substrates,⁴⁷⁷ even abandoning the supporting layer to complete the transfer. Hong et al. demonstrated the transfer of a single layer of MoS₂ from glass to a graphite substrate using solely ultrapure water, completely eliminating the need for polymer support.⁹¹⁷ In addition, ice has also been used as a supporting layer for ultraclean transfers.⁹¹⁸

Metal-assisted transfer techniques have exhibited efficacy in facilitating clean transfers of TMD films.⁹¹⁹ The interaction between metals and TMDs is marked by a high surface energy, which simplifies the pick-up process. As a result, metal-assisted transfer methods have shown feasibility in achieving clean TMD transfers. The greater mechanical stiffness of metal films also enhances stability during the transfer process, preserving the structural integrity of the transferred film. For example, Jaewoo et al. used a 600-nanometer-thick Ni film as an atomic-scale adhesive supporting layer, enabling high-throughput production of multiple single-layer wafer-scale 2D materials, with a notable achievement of 5 cm diameter films (Figure 26d).⁹²⁰ Huang et al. demonstrated a gold-assisted mechanical stripping method for the separation of 40 types of single-crystal monolayers.⁹²¹ Liu et al. evaporated a thin gold film onto the meticulously polished surface of a silicon wafer, then stripped the gold film from the substrate using a heat release band and a polyvinylpyrrolidone (PVP) interface layer.⁹²² The ultraflat gold strip enables a tight and uniform vdW contact between gold and the two-dimensional vdW crystal surface, aiding material transfer. Similarly, bismuth has been identified as a viable support for transferring TMDs, underscoring the diversity of metals applicable in this context.

The vdW force assisted direct pick-up transfer offers a chemical-free and solvent-free approach to efficiently strip TMD layers from their growth substrate, eliminating the need for etchants or solvents.^{923,924} Materials with intrinsic vdW forces and surface energies compatible with TMDs act as natural support layers, permitting unblemished transfers. This method allows for precise layer stacking, aiding in the construction of heterostructures and devices, making it invaluable for controlled material integration. Its versatility spans large-area material transfer, from micrometers to

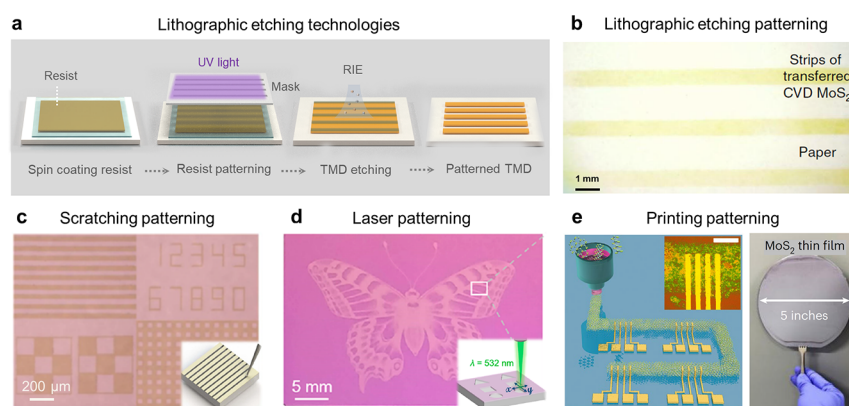


Figure 27. Patterning techniques for large-area TMDs. (a) Schematic illustration of lithographic etching technologies for TMDs. (b) Optical micrograph showing the patterned MoS₂ strips on paper by lithographic etching technologies. Reprinted with permission from ref 931. Copyright 2020 Springer Nature. (c) Optical images of patterned MoS₂ films by scratching patterning. Inset: illustration of the scratching-lithography process. Reprinted with permission from ref 939. Copyright 2020 IOP Publishing Ltd. (d) Photograph of patterned MoS₂ films by laser patterning. Inset: illustration of the laser patterning. Reprinted with permission from ref 944. Copyright 2022 American Chemical Society. (e) Schematic illustration (inset: optical microscopic image) of an inkjet-printed large-area superconducting NbSe₂ wire (left panel) and image of slot-die-coated SEA and MoS₂ on a 5-in. silicon wafer (right panel). Reprinted with permission from ref 950. Copyright 2021 Springer Nature (left panel). Reprinted with permission from ref 951. Copyright 2023 Springer Nature (right panel).

centimeters, applicable in research and industrial settings. Kang et al. successfully employed the vdW force assisted direct pick-up transfer to transfer and stack TMD layers in a vacuum environment, facilitating the creation of CVD-grown TMD heterostructures with pristine interfaces (Figure 26e).⁹²⁵ Kim et al. reported the development of an extremely anisotropic thermal conductor based on large-area vdW films with random interlayer rotation, achieved through the vdW force assisted direct pick-up transfer. This innovation yielded a room-temperature thermal anisotropy ratio of nearly 900 in MoS₂, one of the highest thermal anisotropy ratios ever recorded (Figure 26f).⁹²⁶ Furthermore, the vdW force assisted direct pick-up transfer can be seamlessly integrated into automated transfer instrument for TMDs, leveraging van der Waals forces between the materials. Mannix et al. introduced a robotic four-dimensional pixel assembly method that utilizes the vdW force assisted direct pick-up transfer to fabricate vdW solids with unprecedented speed, meticulous design, large surface areas, and precise angle control (Figure 26g).⁹²⁷

With the rapid advancement of the electronics industry, TMDs are emerging as a critical element in the next generation of semiconductor materials. Serving as the bridge in the application of TMD materials, transfer technology offers a clean, nondestructive, smooth, straightforward, and environmentally friendly method. This opens up limitless possibilities for the potential applications of 2D materials. To align with the demands of the electronics industry, there is a more pressing need to develop TMD transfer technology that can accommodate large areas and achieve mechanical automation.

6.3. Patterning Techniques

Patterning techniques possessing TMDs as specific morphology at the nanoscale represent an enabling technology for further boosting the pristine material properties. Nanopatterning plays a crucial role in shaping TMDs into arbitrarily complex geometries in order to meet the specific requirements of the desired target application. For instance, the realization of TMD-based optical metasurfaces needs morphology control on the subwavelength scale thus producing spatially varying optical constants which are able to induce nonconventional light-matter interaction.^{928,929} In the field of electronics,

pattern engineering is an effective route toward the fabrication and miniaturization of integrated circuits. In addition to traditional lithography, some approaches designed specifically for TMDs, such as utilizing specialized probes, have dramatically shrunk feature sizes from microns to nanometers, achieving resolutions below 20 nm and enabling wafer-scale production capabilities.⁹³⁰ In this section, we mainly focus on the patterning techniques of the as-grown TMDs: lithographic etching technology, direct writing technology, and inkjet printing technology.

As an important part of the traditional semiconductor micromachining process, well-established lithographic etching technologies, including UV lithography, electron beam lithography (EBL), reactive ion etching (RIE), etc., are widely used for patterning TMD devices. Figure 27a illustrates the typical process flow for the lithography and etching processes. A resist layer is first spin-coated onto a target TMD film, followed by the baking process to remove the solution and eliminate the strain built-in after spin-coating. The mask featuring the desired nanopattern is then aligned and exposed to ultraviolet light to pattern the photoresist (or scanning to expose the preset pattern by high energy electron beam). Following this, the development process removes the photoresist from the exposed area and leaves the specific patterned photoresist covering the TMD target pattern, which serves as a mask for the TMD during the subsequent etching process. Followed by the etching process, the patterned TMD film was successfully fabricated.

According to the etching mediums, the etching process can be categorized into dry etching and wet etching, with typical dry etching involving a chemical reaction activated by plasma or high-energy beam bombardment, without the use of a solution. In addition to oxygen plasma, reactive ion etching (RIE), a mature commercial dry etching method, is commonly used for fabricating specific TMD structures in integrated circuit manufacturing. In RIE chambers, high-pressure ionization of plasma generated by corrosive gases (e.g., CHF₃, CF₄, and SF₆) that exhibit strong chemical reactivity. These gases react with the atoms of the etched sample, producing volatile substances that corrode the sample's surface.

Precise control over etching parameters allows the fabrication of two-dimensional nanopatterns of varying thickness. In 2013, Chen et al. reported the etching of bulk MoS₂ by SF₆ to achieve the controlled fabrication of large-area patterned arrays.⁷¹⁶ Following this, Conti et al. achieved specific MoS₂ patterns by etching MoS₂ on sapphire with SF₆ and transferred the patterns to paper, resulting in MoS₂ array devices with impressive on/off ratios and mobility (Figure 27b).⁹³¹ Furthermore, Meng et al. utilized CF₄ RIE etching to fabricate MoS₂ TFTs based on 2-in.-MoS₂ on sapphire with Au Film laminated on the fresh as-grown MoS₂.⁹³² The Au Film acted as protection layer from ambient absorption, dry etching mask and electrical contacts, achieving transistors with median mobility of 54 cm² V⁻¹ s⁻¹, drive current of 210 μA μm⁻¹, and excellent uniformity, leading to the realization of high-resolution displays.

Although wet etching is another universal nanopatterning method, its development has been slow due to the limitations of immersion solutions. In 2020, Munkhbat et al. introduced a wet etching approach that achieves anisotropic TMD etching with atomic precision.⁹³³ They formed circular holes on TMD surfaces through EBL and RIE, followed by anisotropic etching in an aqueous solution of H₂O₂ and NH₄OH to create hexagonal hole arrays. They showed that TMDs can be etched along certain crystallographic axes, such that the obtained edges are nearly atomically sharp and exclusively zigzag-terminated. To address the limitations of solution-based wet etching, Liu et al. expanded this method to thermal etching. They annealed TMDs after laser irradiation to enable anisotropic thermal etching.⁹³⁴ This approach allowed for controlled hole sizes and densities in bilayer WS₂ with different arrangements, achieving precise patterning in this two-dimensional material.

In summary, the etching process is particularly suitable for large-area processing, making it of great promise for batch production.⁹³⁵ The minimal feature size is close to sub-10 nm. In addition, etching technologies are compatible with modern semiconductor integration process, which possibly makes TMDs easy to be integrated on silicon-based substrates.⁹³⁶ Etching technologies are suitable for batch production which has been widely employed in the silicon-based industry. Still, the photoresist residues will hinder the application of 2D materials.⁹³⁷ And TMD's atomic thinness makes it susceptible to damage. Ultraviolet exposure and direct metal electrode evaporation potentially cause edge defects and morphological inconsistencies, reducing device performance.

To prevent unintended material modifications and eliminate the impact of residuals and laser exposure, direct writing technology primarily utilizes two key tools: probes and lasers. For instance, scanning probe lithography has been employed to directly fabricate single-layer TMD patterns without relying on sacrificial resist materials.⁹³⁸ In 2020, Wei et al. introduced scratch lithography, where metal tungsten tips mechanically scrape the surface of two-dimensional materials to achieve patterned processing at a wafer scale, with an accuracy of approximately 1 μm, similar to UV lithography (Figure 27c).⁹³⁹ Moreover, Zhao et al. utilized tip-induced oxidation to achieve controlled oxidation at resolutions below 100 nm,⁹⁴⁰ effectively producing controllable-sized two-dimensional graphical materials by manipulating tip bias, amplitude set point, and humidity. Laser processing has emerged as another crucial direct-write technique for patterning 2D nanopatterns.^{941,942} In 2018, Lin et al. presented photothermal

plasma nanolithography,⁹⁴³ an all-optical lithography technique enabling high-throughput, versatile, and mask-free patterning of various atomic layers. More recently, Poddar et al. developed a resistless lithography method based on direct laser patterning (Figure 27d),⁹⁴⁴ successfully fabricating FET arrays using monolayer MoS₂ and WSe₂. However, direct writing technology typically requires more time to achieve high-resolution results at atomic or molecular scales, resulting in higher costs and increased energy consumption compared to lithography. Consequently, it is challenging to apply direct writing technology for wafer-scale imaging tasks.

Inkjet printing technology, developed over a decade, is an efficient patterning method employing solution intercalation.^{945,946} It involves dispersing TMD in solution to create ink^{947,948} and employs controlled programming to quickly and precisely print TMD in situ.^{463,949} This approach is particularly valuable for producing large-area patterns with relatively low resolution, typically exceeding 1 μm. In 2021, Li et al. used an electrochemical stripping method to produce high-yield, large-size single crystal monolayers of up to 300 μm, using NbSe₂ serving as a model system (Figure 27e, left panel).⁹⁵⁰ The resulting twisted NbSe₂ vdW heterojunction exhibited remarkable stability, excellent interface properties, and critical current modulation in response to a magnetic field flux quantum suitable for integer molar lattice. More recently, Kwon et al. employed a commercial slot printing process to manufacture wafer-scale transistor arrays based on MoS₂. At room temperature, the average carrier mobility of the FET reached 80.0 cm² V⁻¹ s⁻¹, with Hall's measurement indicating 132.9 cm² V⁻¹ s⁻¹ (Figure 27e, right panel).⁹⁵¹

Achieving high-quality and controllable two-dimensional material nanopatterns is paramount in transitioning from laboratory-scale research to practical applications. Traditional lithography technology remains widely used in TMD patterning due to its maturity, compatibility with modern industry, and mass manufacturing capabilities. However, its complex steps introduce unknown modulations, hindering the assurance of controlled TMD device performance. Consequently, there is a pressing need to explore novel patterning methods for 2D TMDs, aiming to fabricate devices while minimizing thermal, mechanical, and chemical damage, as well as avoiding unnecessary modulations.

7. APPLICATIONS OF LARGE-AREA TMDs

In the past decade, the unique properties of 2D TMDs have sparked numerous application-driven explorations in fields such as electronics, optoelectronics, and photonics. Proof-of-concept devices such as ultrascaled transistors, flexible displays, and wearable electronics have appeared as promising "killer applications" for large-area TMD materials. The device performance, integration density and reliability are steadily advanced as the evolution of synthesis methodology of TMDs. These rapid developments significantly fueled the efforts for pushing the lab-to-fab transition of TMDs by worldwide scientists and companies like TSMC, Samsung, and Intel.⁹⁵² In this section, we mainly focus on the diverse application scenarios of large-area synthesized TMDs, including electronics, photonics, sensors, catalysis and other potential fields.

7.1. Electronics

In response to the increasing demand for high integration density of transistors guided by Moore's law, CMOS device sizes have been steadily decreasing in recent decades. However,

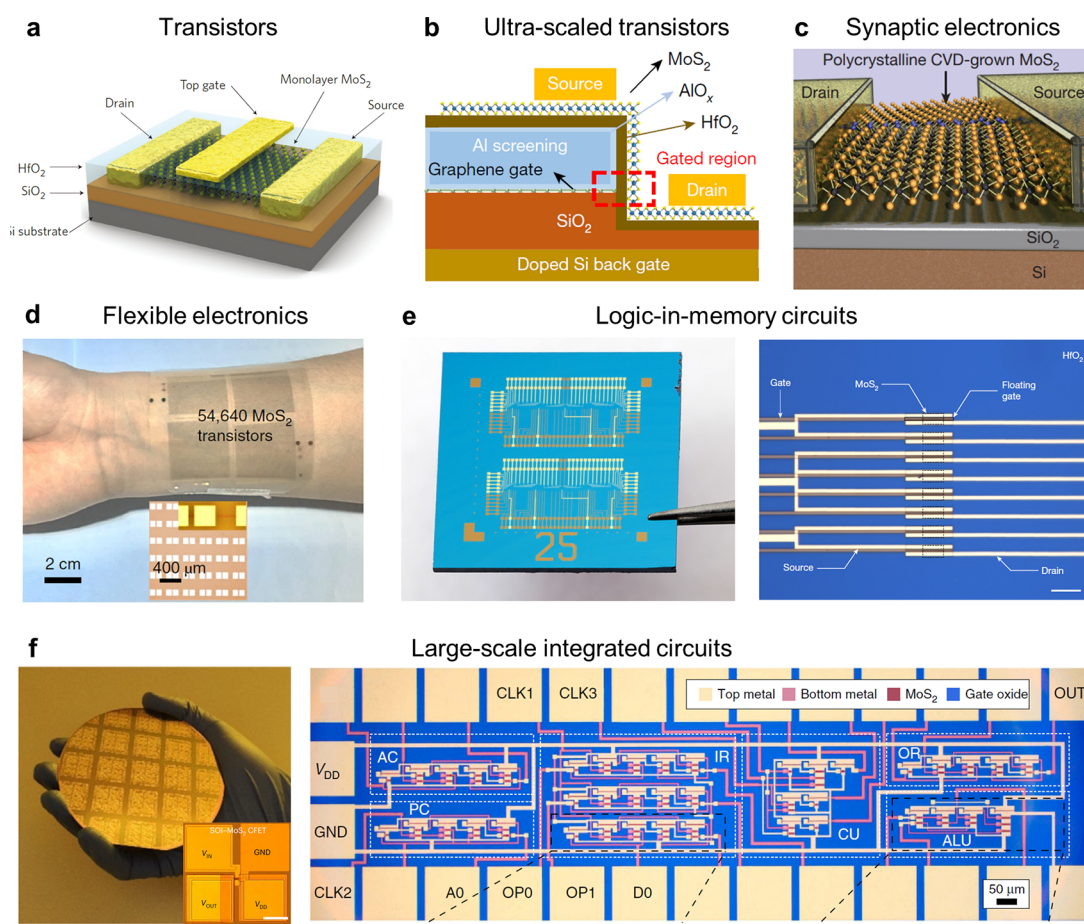


Figure 28. Applications of TMDs for electronics. (a) Schematic illustration of transistors based on TMDs. Reprinted with permission from ref 49. Copyright 2011 Springer Nature. (b) Schematic of ultrathin edge gate monolayer MoS₂ side-wall transistor. Reprinted with permission from ref 955. Copyright 2022 Springer Nature. (c) Schematic of a MoS₂ memtransistor device for synaptic electronics. Reprinted with permission from ref 980. Copyright 2018 Springer Nature. (d) Photograph of very large-scale flexible MoS₂ transistor arrays. Inset: magnified image of FET arrays. Reprinted with permission from ref 984. Copyright 2020 Springer Nature. (e) The logic-in-memory circuits based on TMDs. Left, photograph of a fabricated 12 mm × 12 mm die with logic-in-memory cell arrays. Right, optical image of the fabricated floating-gate memory array. Reprinted with permission from ref 992. Copyright 2020 Springer Nature. (f) Large-scale integrated circuits based on TMDs. Optical image of the 3D-stacked CFET wafer after MoS₂ transfer (left panel). Inset: the zoom-in image of the CFET device. Reprinted with permission from ref 935. Copyright 2023 Springer Nature. Microscope image of the microprocessor (right panel). Reprinted with permission from ref 999. Copyright 2017 Springer Nature.

as the transistor channel length and thickness reduce and approach the physical limits, the influence of scattering mechanism, dangling bond, and short-channel effects will inevitably be introduced, which will cause a decrease in device mobility and drift in threshold voltage, leading to Moore's Law failure. Sustaining Moore's Law and unlocking the potential of the next generation of computers will necessitate entirely new materials and devices.⁹⁵³ Monolayer TMDs, with subnanometer (<1 nm) thickness, emerge as prime candidates for pushing the boundaries beyond the ultimate scaling limits of conventional silicon (<5 nm). Atomic layer thickness and no dangling bonds position TMDs as a potentially superior supplement for advanced silicon-based processes. Consequently, extensive research has been conducted on TMD-based FETs. A critical moment occurred in 2011 when Radisavljevic et al. unveiled a monolayer MoS₂-based FET that operated at room temperature with a remarkable current on/off ratio of 10⁸ and exhibited ultralow standby power dissipation—powered by a single-layer MoS₂ with a mobility of at least 200 cm² V⁻¹ s⁻¹ (Figure. 28a).⁴⁹ Subsequently,

TMD-based transistors have been the subject of extensive research and have seen periods of sustainable development.

On account of their intrinsic immunity to short-channel effects and advancements in structure fabrication have unlocked even more promising avenues for short-channel transistors. Xie et al. developed a grain boundary widening technique with graphene electrodes for contacting monolayer MoS₂ and fabricated FETs with channel lengths scaling down to ≈4 nm.⁹⁵⁴ The practicality of MoS₂ transistors with a 1 nm physical gate length using a single-walled carbon nanotube as the gate electrode has also been validated.³ Further pioneering in 2022, Wu et al. demonstrated side-wall MoS₂ transistors with an atomically thin channel and a physical gate length of sub-1 nm using the edge of monolayer graphene as the gate electrode. (Figure 28b).⁹⁵⁵ Transistor architectures play a role in the performance since structural variations can affect the gate's ability to modify the electric field applied to the channel. Thanks to their layered nature, 2D semiconductors are also adapted to various transistor architectures, from planar to three-dimensional (3D), illustrating compatibility with advanced Si technology. The 3D structure allows for better gate

control and higher current for a given footprint of the transistor. Recently, fin field-effect-transistors (FinFETs),⁹⁵⁶ multibrIDGE-channel field effect transistors (MBCFETs),⁹⁵⁷ and CFETs^{958,959} based on TMDs have been developed. Gate-all-around (GAA) devices are considered to be promising devices because of their excellent electrostatic control properties and area efficiency.⁹⁶⁰ Additionally, low-temperature monolithic three-dimensional integration (M3D) of TMDs has been realized by vdW lamination of entire prefabricated circuit tiers. By further repeating the vdW lamination process tier by tier, an M3D integrated system is achieved with 10 circuit tiers in the vertical direction, where the processing temperature is controlled to 120 °C. Furthermore, by vertically connecting devices within different tiers through vdW intertier vias, various logic, and heterogeneous structures are realized with desired system functions.⁹⁶¹ The ability to shrink transistors to such diminutive sizes reveals electrical performance possibilities that surpass those of silicon-based technologies, signaling a new era where the physical constraints of silicon are no longer a boundary to the progress of ultrascaled electronics.

As the device size continues to miniaturize, the metal and dielectric layers deposited on the TMDs are a major limitation to increasing the performance of transistors. During deposition of metal and dielectric layers, the evaporated atoms destroy the TMDs atomic lattice generating defects that result in the Fermi level being pinned by the interfacial state, and the potential barrier height is independent of Schottky-Mott limit.⁹⁶² For TMDs-based FET applications, the core of tuning the FETs transport characteristics is to modulate the 2D semiconductor-metal contact barrier by the gate voltage. Addressing this, a series of inventive strategies have been designed to decrease the contact resistance, including improvement of metal-TMD contact, vdW contact, and adding an extra tunneling layer. Shen et al. reported ohmic contact with zero Schottky barrier height between semimetallic bismuth and semiconducting monolayer TMDs.⁹⁶³ Recently, Jiang et al. reported a yttrium-doping approach to convert semiconducting MoS₂ into metallic MoS₂, which improves the band alignment and provides ohmic device contacts. The yttrium-doped MoS₂ acts as a metallic buffer that improves charge carrier transfer from the metal electrode to semiconducting MoS₂.⁹⁶⁴ Analogously, Pt,⁹⁶⁵ Au,⁹⁶⁶ In,^{967,968} and Sb⁹⁶⁹ have also been demonstrated a substantial reduction in contact resistance when interfaced with TMDs. In contrast to contacts formed by deposited metals, vdW contacts via transfer not only prevent damage to the TMD but also reduce contact resistance, making them a proven and effective contact method.^{970–973} Liu et al. defined a highly efficient and damage-free strategy for metal integration by transferring metal films (silver or platinum) with a work function that matches the conduction band or valence band edges of molybdenum sulfide.⁹⁷⁴ Another important aspect is the deposition of superior gate dielectrics atop TMD films. These dielectrics not only regulate the current via gate capacitance but also insulate the gate from the channel, mitigating leakage currents. Advanced deposition techniques have been showcased, including the introduction of a seeding layer, remote plasma treatments, and ultraviolet-ozone exposure to attain homogeneous high-*k* dielectrics. Xu et al. reported a high-quality dielectric film Sb₂O₃ with sub-1 nm equivalent oxide thickness and fabricated monolayer MoS₂-based FETs with the thinnest equivalent oxide thickness (0.67 nm).⁹⁷⁵ The transistors exhibited an on/off ratio of over 10⁶ using an ultralow operating voltage of 0.4 V, achieving

unprecedentedly high gating efficiency. Other than conventional high-*k* dielectrics such as Al₂O₃ or HfO₂,⁹⁷⁶ electrolytes such as ionic liquid,⁹⁷⁷ ion gel⁹⁷⁸ or polymer electrolyte,⁹⁷⁹ are emerging as alternative dielectrics for gating TMD FETs.

With continuous advances in transistor processing technology, the electrical performance of TMDs materials at the ultimate size based on atomic layer thickness has been proved, and device processes compatible with 2D materials such as contact and dielectric layers are being optimized, propelling their adoption across the electronics field. Their expanding importance in synaptic electronics, flexible electronics, logic-in-memory circuits, and integrated circuits is unmistakable. As one of the pivotal elements in extending Moore's Law, TMD-based transistors are progressively cementing their role as a cornerstone technology for future electronics.

The integration of TMDs into the domain of synaptic electronics is attracting substantial attention due to their biocompatibility, enhanced carrier dynamics, and adaptability for implementation in both two and three-terminal device architectures. TMDs-based memristors are suitable for emulating the biological synapses of the human brain's neural network, which possess the capability to regulate resistance across multiple states by recording the history of electrical stimulation. A landmark study by Sangwan et al. in 2018 introduced a memtransistor employing polycrystalline monolayer MoS₂ as the channel. This memtransistor combines the functionalities of a memristor and a transistor, exhibiting reversible stepwise resistance changes as well as long-term potentiation (LTP) and long-term depression (LTD) behaviors in response to sequential voltage pulses (Figure 28c).⁹⁸⁰ The 2D planar geometry of this device enables the integration of multiple terminals, enriching channel connectivity. This design not only improves heterosynaptic plasticity but also reflects the complex synaptic connections found in biological neural networks. These artificial synapses are instrumental in simulating neural transmission and the physical sensing of information, potentially constructing computing systems that rival the robustness and efficiency of the human brain. Furthermore, the synergy of artificial synapses with various nanomaterial-based active channels opens doors to applications such as visual recognition,^{981,982} and hardware neural networks,⁹⁸³ underscoring their practicality.

The application of TMDs in the realm of flexible electronics, sensors, and display technologies is rapidly expanding, fueled by their outstanding properties such as flexibility, transparency, and biocompatibility.^{984–987} These characteristics render TMDs particularly suitable for cutting-edge applications in the ever-evolving field of flexible technology. A notable advancement in this area was reported by Li et al., who successfully fabricated transparent MoS₂-based transistors and logic circuits on flexible substrates. Utilizing 4-in. wafer-scale MoS₂ monolayers (Figure 28d),⁹⁸⁴ these FETs achieved impressive device density (1518 transistors per cm²), high yield (97%), and exhibited remarkable performance metrics including on/off ratios of 10¹⁰, current densities of about 35 μA μm⁻¹, and mobilities of approximately 55 cm² V⁻¹ s⁻¹. Further enhancing the MoS₂ monolayers, encapsulation with hydrophobic fluoropolymer combined with chemical treatment using TSFI not only augmented their environmental stability but also remarkably improved the quantum yield, approaching unity in monolayer MoS₂.⁹⁸⁸ This breakthrough has paved the way for the development of flexible high-speed organic light emitting diode (OLED) displays from atomic layers of

MoS₂.⁹⁸⁹ The resulting flexible and bendable active-matrix OLED displays, incorporating MoS₂ transistors, are particularly promising for wearable display technologies. Moreover, flexible MoS₂ phototransistors have shown remarkable durability, maintaining their mobility even after 1,000 bending cycles, indicative of their excellent mechanical stability. Additionally, MoS₂ FET-based strain sensors⁹⁹⁰ capable of detecting human body motions and biosensors⁹⁹¹ for identifying cancer biomarkers have been developed, leveraging the unique properties of MoS₂. These advancements underscore the significant potential of TMDs in creating flexible, high-performance devices that could revolutionize various aspects of technology, from wearable electronics to advanced sensing and diagnostic tools.

In the realm of computing, traditional Von Neumann architectures, characterized by their distinct processing and storage units, face limitations in power and memory, particularly in the context of expanding data-intensive applications. TMDs emerge as a compelling solution possessing the functionalities of both logic and storage, with their significant direct bandgap and high switching ratios. This integration positions TMDs as a promising candidate for pioneering the next generation of logic-in-memory architectures. In 2020, Marega et al. reported a logic-in-memory devices and circuits based on floating-gate field-effect transistors (FGFETs) utilizing large-area MoS₂ as the active channel material (Figure 28e).⁹⁹² These FGFETs exhibit a conductance that can be precisely and continuously adjusted, making them ideal as the foundational elements for reconfigurable logic circuits. In these circuits, logic operations are executed directly using the memory elements, enhancing both efficiency and speed. Moreover, in 2021, Wang et al. developed a TMD-based dynamic random-access memory (DRAM) cell with a 2T1C (two-transistor, one-capacitor) structure.⁹⁹³ This design not only retains data for over 10 s but also supports 3-bit memory storage. Moreover, Ning et al. introduced a novel duplex device structure.⁹⁹⁴ This design combines a ferroelectric field-effect transistor with an atomically thin MoS₂ channel, realizing a universal in-memory computing architecture conducive to in situ learning. Leveraging the tunable ferroelectric energy landscape, the duplex device demonstrates exceptional performance across various parameters, including endurance (over 10¹³ cycles), retention (exceeding 10 years), speed (4.8 ns), and energy efficiency (22.7 fJ bit⁻¹ μm⁻²). Additionally, this technology facilitated the implementation of a hardware neural network, which achieved a remarkable 99.86% accuracy in a nonlinear localization task using in situ trained weights. More recently, Marega et al. reported an integrated 32 × 32 vector-matrix multiplier with 1024 floating-gate field-effect transistors with a high yield and low device-to-device variability, using monolayer MoS₂ as the channel material.⁹⁹⁵ Logic-in-memory architecture, with its capacity to blend storage and processing, stands as a potent alternative to conventional Von Neumann computers.⁴⁸¹ This architecture is particularly well-suited to meet the escalating computational demands in fields like artificial intelligence, where speed and efficiency are paramount. The advancements in TMD-based devices and circuits herald a new era in computing, where the seamless integration of logic and memory functions can significantly enhance computational capabilities and efficiency.

The situation of TMDs-based device research is currently undergoing a critical transformation, as the focus shifts from

laboratory settings to industrial fabrication and applications via developing large-scale integrated functional circuits using 2D TMDs. This shift holds the promise of integrating TMDs into the modern integrated circuit industry, encompassing applications in sensors, optoelectronic units, and basic logic modules.^{896,897,951,972,996,997} For example, Tong et al. demonstrated the potential of TMDs in heterogeneous complementary FETs on a 4-in. wafer. This innovation combined p-type FETs fabricated using silicon-on-insulator technology with n-type FETs made from MoS₂ (Figure 28f, left panel).⁹³⁵ By effectively matching the mobility and employing multiple-gate modulation of the MoS₂, they addressed the mobility mismatch issue prevalent in fully silicon-based systems. Additionally, there has been progress in the integration of 8-in. NMOS using TMDs,²⁷ further underscoring the scalability of these materials in advanced semiconductor applications. Based on existing growth and device integration technologies, scaled manufacturing sizes^{31,32} have been achieved and various logic gate functions have been implemented as analog electronics.^{897,998} To construct digital integrated circuits capable of complex functions, multiple digital circuit modules such as logic gates, registers, and counters are intricately combined. These circuits form the backbone of modern electronics, including central processing units (CPUs). In a groundbreaking development, Wachter et al. integrated 115 CVD-grown MoS₂ FETs to build a microprocessor capable of processing one bit (Figure 28f, right panel).⁹⁹⁹ These pioneering efforts in wafer-level integration highlight the vast potential for very-large-scale integration (VLSI) of 2D materials. Currently, low-integration-density ICs exploiting TMDs' advanced properties have become a reality, with some companies already commercializing them. The demand is particularly high for sensors and high-power transistors made from TMDs. However, utilizing TMDs to construct high-integration-density ICs presents a more complex challenge. Intrinsic defects in these materials can significantly impact the yield, variability, reliability, and stability of devices.

Additionally, emerging TMDs have attracted tremendous research attention for the future application in optoelectronics for the past decade. Most TMDs possess a direct band gap, which shows higher efficiency of charge-to-photon conversion, compared with that of an indirect band gap. In the recent years, LEDs, photodiodes, photodetectors, and solar cells have been intensively investigated based on mechanical exfoliated TMD sheets.^{898,1000,1001} For wafer-scale TMD films, the optoelectronic study mainly focused on photodetectors.^{447,460,1002}

Photodetectors based on 2D TMD operate mostly on the basis of the photovoltaic effect and exhibit lower dark currents and higher responsivity. In 2013, Lopez-Sanchez et al. demonstrated ultrasensitive monolayer MoS₂ phototransistors with improved device mobility and ON current. Phototransistors show a maximum external photoresponsivity of 880 A W⁻¹ at a wavelength of 561 nm and a photo response in the 400–680 nm range.⁸⁹⁸ Subsequently, Chang et al. reported a phototransistor based on MoSe₂, which presents a much faster response time (<25 ms) than the corresponding 30 s for the CVD MoS₂ monolayer at room temperature in ambient conditions.¹⁰⁰² Recently, Huo et al. designed ultrasensitive two-dimensional photodetectors, which use an in-plane phototransistor with an out-of-plane vertical MoS₂ p–n junction as a sensitizing scheme.¹⁰⁰⁰ The vertical built-in field separates the photoexcited carriers efficiently and

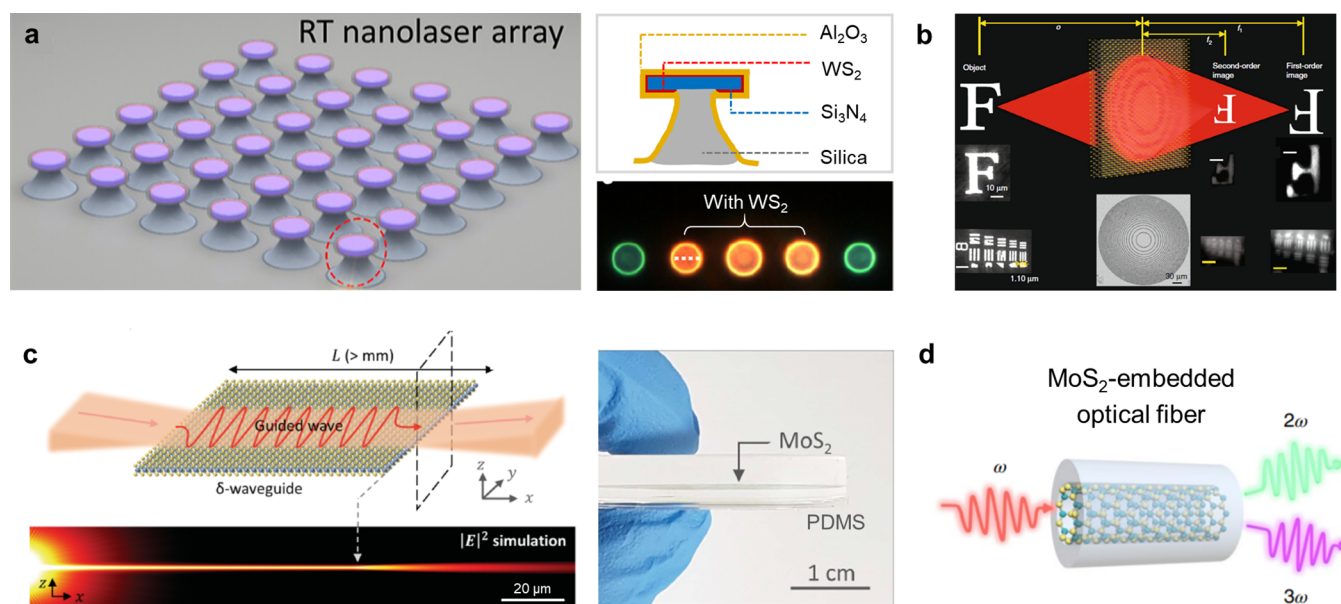


Figure 29. Application in optics and photonics for large-area 2D TMDs. (a) Excitonic laser arrays with directly grown WS₂ between Si₃N₄ microdisks and Al₂O₃ at room temperature. Reprinted with permission from ref 1019. Copyright 2022 American Chemical Society. (b) A large-scale flat lens based on monolayer TMDs with high performance for diffraction-limited wide imaging. Reprinted with permission from ref 942. Copyright 2020 Springer Nature. (c) δ waveguides based on wafer-scale monolayer MoS₂. Reprinted with permission from ref 1025. Copyright 2023 AAAS. (d) Monolayer MoS₂ embedded optical fiber for ultrahigh nonlinearity. Reprinted with permission from ref 199. Copyright 2020 Springer Nature.

produces a photoconductive gain of $>10^5$ electrons per photon, external quantum efficiency greater than 10%, responsivity of $7 \times 10^4 \text{ A W}^{-1}$, and a time response on the order of tens of ms.

As a promising beyond CMOS technology, transitioning from laboratory research to industrial production of 2D TMD-based ICs poses significant challenges. These are not confined to material synthesis, process integration, and device performance evaluation but also extend to circuit design issues. Addressing these challenges will be crucial for realizing the full potential of TMDs in the semiconductor industry, particularly as we approach the physical limits of traditional silicon-based technologies. The successful integration of TMDs into large-scale functional circuits could mark a new era in electronics, offering enhanced performance and new capabilities in a wide range of applications.

7.2. Photonics

2D TMDs have garnered significant attention in the realm of optics and photonics due to their rich optical properties, including strong interaction with light, significant exciton effects, and substantial optical nonlinearity.^{126–128,162,170} TMD monolayers are particularly intriguing with the remarkable optical characteristics and phenomena, which arises from an indirect-to-direct bandgap transition and breaking inversion symmetry when their thickness decreases to the monolayer limit.^{177,221,1003} Compared to 2D TMDs of microscale dimensions obtained by the mechanical exfoliation method, the successful fabrication and transfer of large-area and high-quality TMDs promise superior reproducibility and controllability for scalable manufacturing and integrated photonics.¹⁰⁰⁴

This significant advancement could open up new avenues for advanced optical applications that fully leverage the capabilities of 2D TMDs. In the following, we will explore the various potential optical applications in 2D TMDs and emphasize the unique advantages offered by their large scales.

The unique excitonic effects observed in 2D TMDs have shown tremendous potential for applications in ultracompact coherent light lasers.^{1005–1007} For 2D TMDs, the excitons are tightly bound, due to the enhanced Coulomb interaction between electrons and holes. Monolayer TMDs, with a direct semiconductor bandgap and large exciton binding energy, exhibit strong excitonic emission, making them promising gain media.¹⁰⁰⁵ Their ultrathin nature and interfaces without dangling bonds allow for seamless integration of 2D TMDs onto any cavity, facilitating the achievement of ultralow-threshold nanolasers. In 2015, Wu et al. realized a significant milestone by demonstrating light lasing by integrating monolayer WSe₂ onto a photonic crystal cavity.¹⁰⁰⁸ In the meantime, Ye et al. reported the excitonic lasing using monolayer WS₂ in a microdisk resonator at cryogenic temperatures.¹⁰⁰⁹ Through the optimization of optical microcavities, researchers have achieved 2D TMDs-based light lasing at room temperature. This has been demonstrated not only in monolayer TMDs but also few-layer TMDs and their heterostructures.^{1010–1017} Furthermore, large-area TMDs were in situ grown onto microcavity, which greatly overcame the difficulties and problems during the transfer processes, such as impurity introduction and operation complexity.¹⁰¹⁸ Liu et al. demonstrated the excitonic laser arrays with directly grown WS₂ between Si₃N₄ microdisks and Al₂O₃ at room temperature (Figure 29a).¹⁰¹⁹ The integration of large-area TMDs and innovative microcavity would provide exciting opportunities for TMD-based nanolasers across a spectrum of optical applications.

In addition to their excitonic properties for lasing, the high refractive index for 2D TMDs can significantly enhance light modulation interaction for ultrathin optical applications. In 2016, Yang et al. reported the thinnest optical lens consisting of few-layer MoS₂ (~ 6.3 nm) at the time.¹⁰²⁰ They utilized the high refractive index of 2D MoS₂ to facilitate strong light

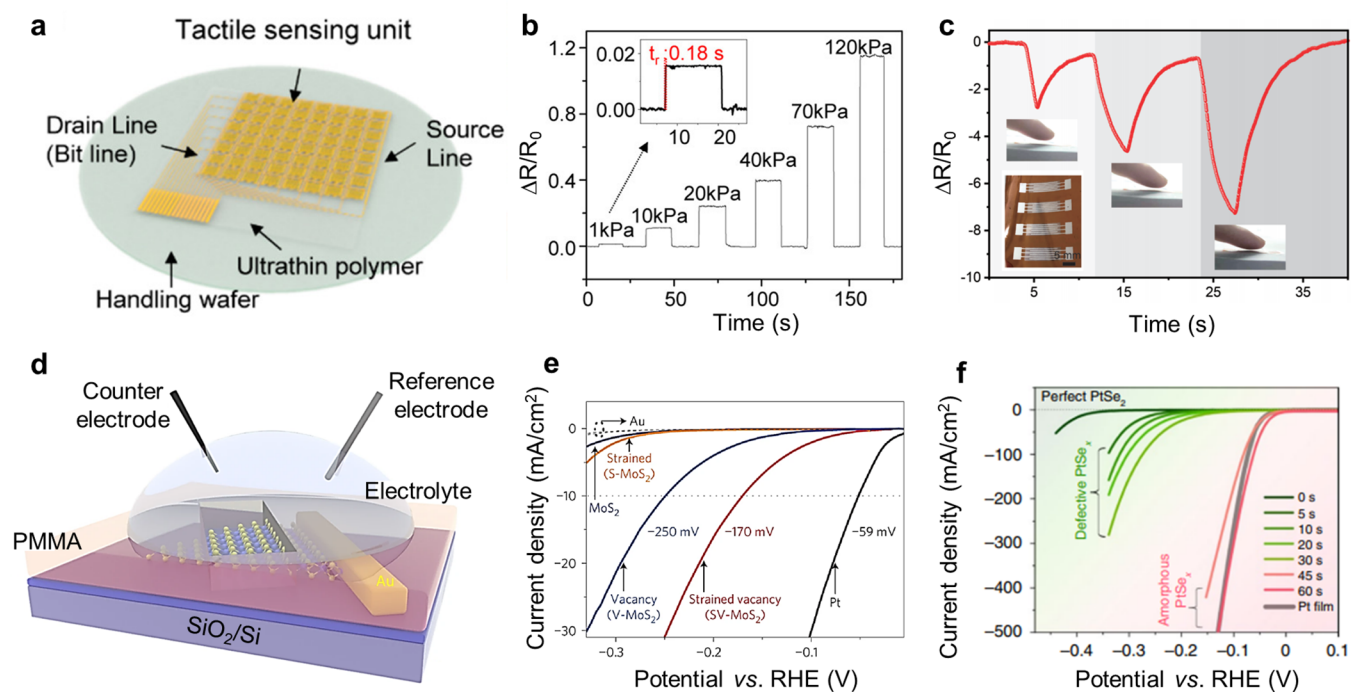


Figure 30. Application in sensors and catalysis for large-area 2D TMDs. (a) Schematic diagram of a large-area active matrix MoS₂ tactile sensor. (b) Relative resistance changes with time of MoS₂ film transistors under different pressures (1 to 120 kPa). The inset illustration shows the response characteristics at 1 kPa, and the response time is 0.18 s. (a,b) Reprinted with permission from ref 1032. Copyright 2019 American Chemical Society. (c) Electrical response of temperature sensor when a finger approaches the sensor. Reprinted with permission from ref 461. Copyright 2022 Wiley-VCH Verlag GmbH & Co. KGaA, Weinheim. (d) Typical schematic diagram of a three-electrode catalytic device. Reprinted with permission from ref 1050. Copyright 2023 Springer Nature. (e) Linear scan voltammograms of monolayer MoS₂ for different tensile strains and S-vacancies. Reprinted with permission from ref 835. Copyright 2015 Springer Nature. (f) Polarization curve of PtSe_x material with a treatment duration of 0–60 s. Reprinted with permission from ref 838. Copyright 2022 Springer Nature.

modulation, thereby enabling a giant optical path difference across different layers of MoS₂ for precise light beam focusing. In 2020, Lin et al. achieved even thinner flat lenses by using monolayer TMDs.⁹⁴² They employed a femtosecond laser direct writing system to create local scattering media within the monolayer TMDs, overcoming the challenge of insufficient light modulation of atomically thin 2D materials. Leveraging large-area monolayer TMDs, they demonstrated a large-scale flat lens with high performance for diffraction-limited wide imaging (Figure 29b).⁹⁴² Subsequently, Teng and Li's two groups employed the supercritical principle to design ultrathin lenses to achieve subdiffraction limited focusing and imaging.^{1021,1022} Furthermore, Van de Groep et al. demonstrated the electrical tunability of a millimeter-scale zone plate lens to improve focusing properties based on large-area monolayer WS₂ in the visible range.¹⁰²³ While the focusing efficiency of ultrathin TMD lenses is far below that of conventional bulky optical lenses, their compact-volume, high-tunability, and easy-integration create new novel possibilities for miniaturized and integrated optical systems.¹⁰²⁴

The availability of large-area and high-quality TMDs has also paved the way for the development of innovative optical waveguides.^{199,1025–1027} Lee et al. recently introduced the concept of δ waveguides based on wafer-scale monolayer MoS₂, where the ultrathin waveguide thickness t and refractive index n at the working wavelength λ satisfy $nt/\lambda \ll 1$ (Figure 29c).¹⁰²⁵ These δ waveguides are capable of operating in the visible and near-infrared ranges, efficiently coupling and guiding light over millimeter-scale distances with minimal loss. Furthermore, they expanded the capabilities of δ

waveguides to encompass functions such as refraction, focusing, grating, and interconnection. Beyond applications in the linear optical regime, large-area 2D TMDs also play a crucial role in nonlinear optics.^{199,1026,1027} For example, Zuo et al. demonstrated that the direct growth of MoS₂ onto the fiber internal walls promised the optical fibers with ultrahigh nonlinearity (Figure 29d).¹⁹⁹ Compared to monolayer MoS₂/silica, a 25 cm-long fiber completely embedded monolayer MoS₂ showed a 300-fold enhancement in both SHG and THG. They also showed that the MoS₂-embedded PCF can serve as a saturable absorber for the all-fiber mode-locked laser. So far, large-area TMDs have provided a valuable material platform for creating ultrathin, compact, and miniaturized optical components and devices,^{31,32} which is expected to drive the development of on-chip photonic circuitry and quantum photonics.

7.3. Sensors

Due to their atomically-thin layered structures, unique electrical properties, and large specific surface areas, 2D TMD materials offer unparalleled advantages in the realm of sensors. Over the past decade, sensors based on TMDs have found widespread applications in various fields, including gas detection, biosensing, environmental monitoring, electronic skin, and electronic devices. The TMD-based sensors can be categorized into three main types: physical sensors (e.g., mechanics, environmental factors), chemical sensors (e.g., gases, organic compounds, inorganic ions), and biosensors (e.g., biomolecules, antibiotics).¹⁰²⁸

Physical sensors rely on physical reactions, including pressure sensors, strain sensors and temperature sensors.^{1029–1031} Among them, pressure sensors primarily operated based on the piezoelectric and piezoresistive effects. The potential for piezoelectricity in TMDs was initially predicted in the theoretical calculation,²⁹⁵ and in 2014, Wu et al. demonstrated a pressure sensor based on monolayer MoS₂.³⁰¹ However, the piezoelectric effect imposes strict requirements on materials, necessitating an inversion symmetry-breaking structure. In the case of common 2H-phase TMDs, only odd-numbered layers meet this requirement, posing challenges for implementing piezoelectric-based sensing devices with multilayer TMDs. In 2022, Hallil et al. reported the strong piezoelectricity of multilayer 3R-MoS₂ flakes, which possess an inversion symmetry-breaking structure.³⁰⁶ Moreover, by introducing defects and altering the distribution of free carriers in MoS₂, additional polarization effects can arise due to the asymmetry of charge distribution, leading to enhanced piezoelectricity. In 2021, Choi et al. used hot solvent etching to fabricate large-scale WS₂ film piezoelectric sensors, demonstrating a 3-fold increase in the piezoelectric response voltage (96.74 mV) under 3 kPa compression compared to the original WS₂.⁸⁴¹ Pressure sensors using piezoresistive effect mechanisms have attracted extensive attention and reports. In 2015, Manzeli et al. conducted a study measuring the bandgap tuning in MoS₂ due to strain with different layer numbers, demonstrating the emergence of piezoresistive effects.³⁰³ Following this, flexible tactile sensors have gained a great deal of attention. Park et al. engineered a MoS₂ haptic sensor array measuring 2.2 cm × 2.2 cm in area.⁹⁹⁰ They integrated the sensor with a graphene electrode to achieve excellent mechanical flexibility, optical transmittance, and a high gauge factor within the visible color range. In 2019, Park et al. developed a large-area active-matrix MoS₂ tactile sensor (Figure 30a).¹⁰³² In experiments, the resistance of sensor linearly increased with applied external pressure, exhibiting a sensitivity of $\Delta R/R_0 \approx 0.011 \text{ kPa}^{-1}$ and a response time of $\sim 180 \text{ ms}$ at high external pressure (Figure 30b). While carbon-based materials like graphene and carbon nanotubes have gained popularity for temperature sensors in recent years, the potential of TMD materials in this field has been relatively unexplored. In 2022, Daus et al. introduced a flexible monolayer MoS₂ temperature sensor array capable of detecting temperature changes in a few microseconds, a significant speed improvement over film metal sensors.¹⁰³³ Additionally, Li et al. recently reported a novel method combining inkjet printing and thermal annealing techniques for synthesizing large-area MoS₂ patterns.⁴⁶¹ In their study, the resistance of the temperature sensor decreased as the distance between the finger and the sensor decreased (Figure 30c).

Chemical sensors play a vital role in converting chemical information into readable signals, usually electrical signals, including gas sensing, organic compound detection, and ion sensing. Gas sensors, for instance, are instrumental in detecting and quantifying specific gas components in the atmosphere, with applications spanning environmental monitoring, industrial safety, and smart cities. The mechanism involves a redox reaction between the target gas and the surface of the TMD material, inducing alterations in the internal charge transfer process. When placed in an inert gas environment, the target gas molecules desorb, restoring the conductivity to its initial value. In 2012, Li et al. developed a NO gas sensor based on few-layer MoS₂.⁶⁵⁰ While 1L MoS₂ exhibited unstable current,

2L, 3L, and 4L MoS₂ FET devices demonstrated stable and sensitive responses (with a minimum response of 0.8 ppm). Likewise, Liu et al. reported that sensors relying on MoS₂ epitaxially grown via CVD technology could effectively detect NO₂ and NH₃, reaching levels as low as 20 ppb and 1 ppm, respectively.¹⁰³⁴ In 2015, Cho et al. introduced a highly sensitive MoS₂ gas sensor and employed *in situ* luminescence characterization to elucidate the interaction between gas molecules and the charge transfer mechanism within MoS₂.¹⁰³⁵ Furthermore, gas sensors using TMD materials for gases such as CO and CO₂ have also been successfully demonstrated.^{1036,1037} In addition, TMDs can also be used as sensitive materials for detecting organic compounds (acetone, ethanol, and methanol) and ion detection sensors.^{1038–1040}

Biosensors that harness the unique properties of TMD materials for the detection of biomolecules have garnered significant interest. The atomic thickness and biocompatibility of TMDs plays a pivotal role in adsorbing biological analytes onto their surfaces, generating a sensing response. Biosensors can be categorized into three main types based on their working mechanisms: electrical, electrochemical, and optical.¹⁰⁴¹ Electrical signal sensors utilizing TMD materials have demonstrated their prowess in detecting various biomolecules, including prostate cancer antigens, miRNA-155, SARS-CoV-2 and DNA.^{991,1042–1044} For instance, Wang et al. pioneered the use of multilayer MoS₂ FET devices for the detection of the cancer marker protein prostate-specific antigen, achieving high sensitivity.¹⁰⁴⁵ Park et al. introduced an ultrasensitive biological FET (with a detection limit of 1 ag/mL) constructed from MoS₂ nanopores stimulated by nuclear pore complexes.¹⁰⁴⁶ This result was achieved by effectively coupling the aptamer to the nanoring at the edge of the MoS₂ nanopore. Moreover, electrochemical and optical signal sensors based on TMD materials also offer valuable avenues for detecting biomolecules.^{1047–1049}

7.4. Catalysis

Clean and sustainable energy conversion technologies are pivotal in reducing reliance on fossil fuels. Catalytic processes play a vital role in the energy conversion journey and constitute a significant component of sustainable energy development. 2D TMD materials have garnered substantial research attention in catalytic reactions, owing to their distinctive electronic structure and surface properties, such as high specific surface area, abundant defect sites, and tunable coordination environment. In recent years, significant strides have been achieved in the field of electrocatalysis utilizing 2D TMDs, including the HER, carbon dioxide reduction reaction (CO₂RR), oxygen reduction reaction (ORR), oxygen evolution reaction (OER), etc.

The HER stands as one of the most prominent catalytic reactions. Extensive research has demonstrated that TMD materials, including MoS₂, MoSe₂, WS₂, WSe₂, NbS₂, exhibit exceptional electrocatalytic performance for HER, and the typical catalytic devices are shown in Figure 30d.^{1050–1054} Enhancing HER involves several key regulatory strategies, including heteroatom doping, active site creation, phase control, and heterostructure construction.^{777,839,1055–1057} Among these strategies, heteroatom doping emerges as a highly effective means of altering the electronic structure of TMD materials and reducing the Gibbs free energy of the electrocatalyst, thus facilitating the HER process.¹⁰⁵⁵ For instance, Xiong et al. employed Co doping to effectively

modulate the electronic structure of MoS₂.¹⁰⁵⁸ As a result, the intrinsic conductivity is increased, the hydrogen adsorption free energy of MoS₂ is decreased under high HER conditions, and the catalytic active site is provided for OER. In 2016, Li et al. reported an effective approach for tuning the HER activity by introducing sulfur vacancies into monolayer 2H-MoS₂, effectively creating catalytic sites (Figure 30e).⁸³⁵ By carefully combining the appropriate S vacancy and strain, they achieved an optimal hydrogen adsorption free energy, resulting in high intrinsic HER activity in the 2H-MoS₂ catalyst. Furthermore, metal-phase TMD materials have demonstrated superior performance in electrocatalysis compared to their semiconductor counterparts. Yu et al. successfully synthesized micron-sized metallic phase 1T'-MoX₂ (X = S, Se) materials at a large scale.⁸¹² Electrochemical experiments revealed that the basal surface of 1T'-MoS₂ exhibited higher activity than that of 2H-MoS₂ in an acidic medium. Recently, Shi et al. demonstrated that 2H-MoS₂ facilitate the epitaxial of Pt nanoparticles, while the 1T' phase supports single-atomically dispersed Pt atoms (s-Pt) with Pt loads up to 10 wt %. The experiment measures for s-Pt/1T'-MoS₂ a mass activity of 85 ± 23 A mg_{pt}⁻¹ at an overpotential of -50 mV.¹⁰⁵⁹ Heterostructure catalysts based on TMD materials have shown great promise for HER.^{1060,1061} In 2015, Gao et al. constructed a heterogeneous MoS₂/CoSe₂ catalyst for highly active HER.¹⁰⁵² In an acidic condition, MoS₂/CoSe₂ heterostructure catalysts exhibited remarkably fast HER rates, approaching those of commercial platinum/carbon catalysts. This performance likely arises from the catalytic synergy between the two materials, both possessing hydrogen evolution activity, and an increase in catalytic sites. Recently, He et al. prepared wafer-scale amorphous PtSe_x (1.2 < x < 1.3) membranes, which acted as catalysts for achieving high-throughput hydrogen production (Figure 30f).⁸³⁸ This innovative approach can be extended to other precious metals, including Pd, Ir, Os, Rh, and Ru elements. In addition, catalytic reactions such as CO₂RR and ORR based on TMD materials have also been confirmed.¹⁰⁶²⁻¹⁰⁶⁶

Based on the rich structural and electrical properties of 2D TMDs and regulatory strategies (heteroatom doping, active site creation, phase control, and heterostructure construction), the improvement of catalytic activity and stability provide opportunities for applications in catalysis. Furthermore, it may be possible to create efficient catalytic properties, promising unique functions, and application-specific customization by designing special materials and building creative structures. However, several key challenges remain for TMD catalysts such as understanding the role of defects and enhancing their stability.

7.5. Other Potential Applications

Beyond the aforementioned contents, diverse TMDs are progressively demonstrating potential applicability in various fields such as energy, mechanics, acoustics, environmental sciences, biology, and corresponding interdisciplinary research. For example, owing to their layered structure, high surface area, and excellent electrochemical performance, 2D TMDs have garnered extensive attention as electrode materials for energy storage devices like supercapacitors and lithium-ion batteries.^{1067,1068} Tunable electronic properties and high thermoelectric figure of merit endow TMDs with substantial potential in the field of thermoelectric materials research, particularly in energy harvesting and thermoelectric heat

energy conversion.^{1069,1070} TMDs possess a unique layered structure, resulting in anisotropic thermal conductivity, with varying heat conduction rates in different directions.⁹²⁶ Coupled with their high thermal stability and a favorable ratio of thermal to electrical conductivity, TMDs present significant potential in the development and application of high-performance thermal conductive materials. This is particularly relevant in areas requiring precise thermal management and stability at high temperatures, such as in cooling electronic devices, energy conversion systems, and aerospace applications.¹⁰⁷¹ In recent years, TMDs have demonstrated considerable potential in biomedical applications. The high surface area and functionalization capabilities enable effective drug loading and targeted release in drug delivery systems. In cancer therapy, TMDs are being explored as potential materials for photothermal and photodynamic treatments.¹⁰⁷² Moreover, the unique optical properties of TMDs render them valuable tools in biological imaging, particularly in fluorescence and photothermal imaging.¹⁰⁷³⁻¹⁰⁷⁵ The excellent tunability of interlayer stacking, high mechanical properties, and atomic-level thickness also indicate TMDs with unique advantages in acoustic devices.¹⁰⁷⁶ Numerous application scenarios gradually emerge along with the in-depth exploration of the properties of TMDs, which also drive the advancement of the "on-demand" synthetic methodology of these materials.

8. SUMMARY AND PERSPECTIVES

After more than a decade of efforts, significant progress has been made in the large-area production of TMD materials. To date, over 40 types of 2D TMDs are accessible in the laboratory,^{368,377} with some achieving standard wafer sizes up to 300 mm.^{31,32,1077,1078} As for the crystallinity, the density of zero-dimensional defects has been successfully suppressed to ~10¹² cm⁻², a level comparable to that of exfoliated samples.^{360,366,437,827} Meanwhile, one-dimensional defects, especially grain boundaries, have been effectively eliminated through the epitaxial growth of single-crystal films. To enrich the application scenarios beyond pristine monolayer TMDs, material modification techniques have been significantly advanced. For example, precise control of thickness, ranging from 1 to 3 layers over wafer scale, has facilitated the improvement of their intrinsic electrical performance.^{626,648} Stable p/n type doping, continuous component alloying and semiconducting/metallic phase transition have offered much freedom in TMD property modification. The roadmap for TMD-based electronics is becoming increasingly clear, leading the way toward standard semiconductor technology.^{208,1079-1083}

Even though significant progress has been made in the wafer-scale production of TMDs, several technique challenges remain to be addressed before the transition from fundamental research to industrial manufacturing. Specifically, numerous parameters within the growth dynamics, surface chemistry, step edges, and atomic symmetry and so on, would synergistically affect the epitaxial behavior and film uniformity. Therefore, these parameters all require in-depth investigation to ensure the reproducibility of TMD products. Besides clarifying the microscopic mechanisms, it is essential to focus on advancing high-throughput, low-cost and environmentally friendly production, as well as keeping a balance between production capacity and material quality. While the TMD wafer sizes have reached 300 mm, aligning with the mainstream of silicon, their

production capacity (dozens of pieces per batch) is still far behind the requirement promised as a mature semiconductor (annual demand for millions of wafers). On the other hand, a more immediate concern is that the excess defect density of as-synthesized TMDs (typically $\sim 10^{12}$ – 10^{14} cm $^{-2}$) is even 2 to 4 orders of magnitude higher than that of the III–V compound semiconductors. In addition, alternative approaches like nonepitaxial patterned growth^{398,1084,1085} or BEOL-compatible (<450 °C) direct growth^{27,1086} should also be developed in parallel to advance industrialization.

Broaden the selection of material species is another key step toward diversifying the functionality of TMD wafers. To date, the majority of reported TMD materials have been primarily centered on MoS₂, owing to its well-balanced performance and synthesis flexibility. In fact, the diverse catalog of TMDs offers a valuable resource for advancing function/device innovation in the long term. For instance, among the tungsten family, monolayer WS₂ is predicted to an outstanding channel material with an ultrahigh phonon-limited mobility (>1100 cm 2 V $^{-1}$ s $^{-1}$) and saturation velocity.^{55,1087} In the context of constructing CMOS circuits, WSe₂ deserves attentions since it appears as a superior member among scarce p-type TMD semiconductors.¹⁰⁸⁸ For TMDs beyond Group VI like metallic NbS₂ and VSe₂ and those beyond thermally stable phases, the basic topics of epitaxial mechanism, wafer-scale synthesis, quality improvement and structure modification are still in a relatively early stage.¹⁰⁸⁹ Further refining of corresponding epitaxial techniques may inspire an in-depth exploration in physics.

As a rapidly rising material, TMDs still lack for unified technological standards concerning detailed quality information, such as defect density, layer number, crystalline orientation, coverage rate and domain size. Establishing these standards is a critical cornerstone for ensuring material quality and reliability when it serves as an option in further semiconductor industry. This is an important issue that should be addressed collaboratively by research and industrial community. Earlier on, 2D graphene took this essential step and established the joint terminology standard, which set a promising precedent for TMDs.¹⁰⁹⁰ Meanwhile, the reported devices based on TMDs should be clearly benchmarked in consideration of performance such as mobilities, saturation current, on/off ratio, subthreshold swing (SS) and drain-induced barrier lowering (DIBL). Such guidelines have been proposed previously to facilitate the effective comparison and evaluation of device performance reported by different institutions.¹⁰⁹¹ Researchers are encouraged to adopt these standards to support long-term innovations in TMD technology.

Considering the current stage of technical route, the present commercialization of TMDs should start from seeking featured applications in some low-integration and cost-insensitive scenarios. As for the adoption of TMDs in electronics, due to the enormous investment of industrial upgrading, a more sensible option at this stage is complementary to the highly developed silicon techniques by hybrid integration. The International Roadmap for Devices and Systems (IRDS) has identified 2D materials as a prospective candidate for new-generation channel material, which is expected to complement mainstream CMOS technology by 2028.¹⁰⁹² In the foreseeable future, we believe atomic TMD layers will break through the bottleneck of scaling down to sub-10 nm physical gate lengths in the post-Moore era. Furthermore, advancing application scenarios of TMDs such as beyond von Neumann computing,

on-chip photonics, flexible optoelectronics, ferroelectrics and spintronics, all hold the potential to fuel revolutionary technologies brought by the 2D era.

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Notes

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ACKNOWLEDGMENTS

This work was supported by the National Natural Science Foundation of China (52025023, 52322205, 51991342, 52250398, 52021006, 92163206, 12274456, 11888101, T2188101, 62305003), National Key R&D Program of China (2022YFA1403500 and 2022YFA1405600), Guangdong Major Project of Basic and Applied Basic Research (2021B0301030002), Beijing Municipal Science and Technology Project (Z221100005822003), and the Strategic Priority Research Program of Chinese Academy of Sciences (XDB33000000). This work has been supported by the New Cornerstone Science Foundation through the XPLORER PRIZE.

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